SAR Test Report

For

Applicant Name:	Bigme Cloud Literacy Technology Co., Ltd.
Address:	01 18F., COFCO PROPERTY TOWER, BAOMIN NO.1RD., BAO AN 3RD DISTRICT, SHENZHEN, CHINA
EUT Name:	Smartphone
Brand Name:	Bigme
Model Number:	HiBreak
Series Model Number:	HiBreak Pro, HiBreak Plus, HiBreak Color, HiBreak Color+, HiBreak2 Pro, HiBreak2 Plus, HiBreak2 Color, HiBreak2 Color+, HiBreak3 Pro, HiBreak3 Plus, HiBreak3 Color, HiBreak3 Color+, B531, B531 Pro,B531 Plus, B531C, B531C Pro, B531C+

Issued By

Company Name:	**BTF Testing Lab (Shenzhen) Co., Ltd.**
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Report Number:	BTF240726R00301
Test Standards:	FCC 47 CFR§2.1093 IEC/IEEE 62209-1528: 2020
FCC ID:	2A8EM-HIBREAK
Test Conclusion:	Pass
Test Date:	2024-08-02 to 2024-08-13
Date of Issue:	2024-08-14
Prepared By:	Zoey Zhang / Test Engineer
Prepared By:	Amenda Zhong / Project Engineer
Date:	2024-08-14
Approved By:	Ryan.CJ / EMC Manager
Date:	2024-08-14

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Revision History		
Version	Issue Date	Revisions Content
R_V0	2024-08-14	Original
Note:	*Once the revision has been made, then previous versions reports are invalid.*	

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BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

1. Introduction

1.1 Identification of Testing Laboratory

Company Name:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Phone Number:	+86-0755-23146130
Fax Number:	+86-0755-23146130

1.2 Identification of the Responsible Testing Location

Test Location:	BTF Testing Lab (Shenzhen) Co., Ltd.
Address:	F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
Description:	All measurement facilities used to collect the measurement data are located at F101,201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China
FCC Registration Number	518915
Designation Number	CN1330

1.3 Laboratory Condition

Ambient Temperature:	21℃ to 25℃
Ambient Relative Humidity:	48% to 59%
Ambient Pressure:	100 kPa to 102 kPa

1.4 Announcement

(1) The test report reference to the report template version v0.

(2) The test report is invalid if not marked with the signatures of the persons responsible for preparing, reviewing and approving the test report.

(3) The test report is invalid if there is any evidence and/or falsification.

(4) This document may not be altered or revised in any way unless done so by BTF and all revisions are duly noted in the revisions section.

(5) Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.

(6) The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

2. Product Information

2.1 Application Information

Company Name:	Bigme Cloud Literacy Technology Co., Ltd.
Address:	01 18F., COFCO PROPERTY TOWER, BAOMIN NO.1RD., BAO AN 3RD DISTRICT, SHENZHEN, CHINA

2.2 Manufacturer Information

Company Name:	Bigme Cloud Literacy Technology Co., Ltd.
Address:	01 18F., COFCO PROPERTY TOWER, BAOMIN NO.1RD.,BAO AN 3RD DISTRICT, SHENZHEN, CHINA

2.3 Factory Information

Company Name:	Bigme Cloud Literacy Technology Co., Ltd.
Address:	01 18F., COFCO PROPERTY TOWER, BAOMIN NO.1RD., BAO AN 3RD DISTRICT, SHENZHEN, CHINA

2.4 General Description of Equipment under Test (EUT)

EUT Name:	Smartphone
Under Test Model Name:	HiBreak
Serial Model and Difference	HiBreak Pro, HiBreak Plus, HiBreak Color, HiBreak Color+, HiBreak2 Pro, HiBreak2 Plus, HiBreak2 Color, HiBreak2 Color+, HiBreak3 Pro, HiBreak3 Plus, HiBreak3 Color, HiBreak3 Color+, B531, B531 Pro, B531 Plus, B531C, B531C Pro, B531C+
Description of Model name differentiation	Only the model name is different, others are the same.

2.5 Equipment under Test Ancillary Equipment

Ancillary Equipment 1	Rechargeable Battery	
	Capacity	3300mAh
	Nominal Voltage	3.85V

2.6 Technical Information

Network and Wireless connectivity	2G Network GSM/GPRS/EGPRS 850/1900 3G Network WCDMA/HSDPA/HSUPA Band 2/5 4G Network FDD LTE Band 2/5/7 TDD LTE Band 38/40/41 2.4G WIFI 802.11b, 802.11g, 802.11n(HT20/40) 5G WIFI 802.11a, 802.11n(HT20/40), 802.11ac(VHT20/40/80) BT (EDR+BLE)

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The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	GSM, WCDMA, LTE, WLAN, Bluetooth		
Frequency Range	GSM 850	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	GSM 1900	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	WCDMA Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 2	TX: 1850 ~ 1910 MHz	RX: 1930 ~ 1990 MHz
	LTE Band 5	TX: 824 ~ 849 MHz	RX: 869 ~ 894 MHz
	LTE Band 7	TX: 2500 ~ 2570 MHz	RX: 2620 ~ 2690 MHz
	LTE Band 38	2570 ~ 2620 MHz	
	LTE Band 40	2305 ~ 2315 MHz	
	LTE Band 41	2555 ~ 2655 MHz	
	802.11b/g/n(HT20)	2412 ~ 2462 MHz	
	802.11n(HT40)	2422 ~ 2452 MHz	
	802.11a /802.11n(HT20/40) /802.11ac(VHT20/40/80)	5150 ~ 5250 MHz 5725 ~ 5850 MHz	
	Bluetooth	2402 ~ 2480 MHz	
Antenna Type	WWAN: PIFA Antenna WLAN: FPIFA Antenna BT: PIFA Antenna		
Hotspot Function	Support		
Power Reduction	Not Support		
Exposure Category	General Population/Uncontrolled exposure		
EUT Stage	Portable Device		
Product	Type		
	☐ Production unit	☒ Identical prototype	

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3. Summary of Test Results

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1093	Radiofrequency radiation exposure evaluation: portable devices
2	IEC/IEEE 62209-1528: 2020	Measurement procedure for the assessment of specific absorption rate of human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices - Part 1528: Human models, instrumentation, and procedures (Frequency range of 4 MHz to 10 GHz)
3	IEEE C95.1-2019	IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz
4	KDB447498 D04	Interim General RF Exposure Guidance v01
5	KDB865664 D01	SAR measurement 100MHz to 6GHz v01r04
6	KDB865664 D02	RF Exposure Reporting v01r02
7	KDB941225 D01	3G SAR Procedures v03r01
8	KDB941225 D05	SAR for LTE Devices v02r05
9	KDB248227 D01	802.11 Wi-Fi SAR v02r02
10	KDB941225 D06	Hotspot Mode v02r01
11	KDB648474 D04	Handset SAR v01r03
12	KDB690783 D01	SAR Listings on Grant v01r03

3.2 Device Category and SAR Limit

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

Body Position	SAR Value (W/Kg)	
	General Population/ Uncontrolled Exposure	Occupational/ Controlled Exposure
Whole-Body SAR (averaged over the entire body)	0.08	0.4
Partial-Body SAR (averaged over any 1 gram of tissue)	1.60	8.0
SAR for hands, wrists, feet and ankles (averaged over any 10 grams of tissue)	4.0	20.0

NOTE:
General Population/Uncontrolled Exposure: Locations where there is the exposure of individuals who have no knowledge or control of their exposure. General population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment- related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Occupational/Controlled Exposure: Locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

3.3 Test Result Summary

The maximum results of Specific Absorption Rate (SAR) found during test as bellows:

<Highest Reported standalone SAR Summary>

Exposure Position	Frequency Band	Reported SAR (W/kg)	Equipment Class	Highest Reported SAR (W/kg)
Head 1-g SAR (0 mm Gap)	GSM 850	0.081	PCE	0.419
	GSM 1900	0.083		
	WCDMA Band II	0.092		
	WCDMA Band V	0.084		
	LTE Band 2	0.159		
	LTE Band 5	0.149		
	LTE Band 7	0.138		
	LTE Band 38	0.122		
	LTE Band 40	0.129		
	LTE Band 41	0.089		
	WLAN 2.4 GHz	0.417	DTS	
	WLAN 5.2 GHz	0.239	NII	
	WLAN 5.8 GHz	0.222		
Exposure Position	**Frequency Band**	**Reported SAR (W/kg)**	**Equipment Class**	**Highest Reported SAR (W/kg)**
Hotspot(Body) 1-g SAR (10 mm Gap)	GSM 850	0.645	PCE	**0.792**
	GSM 1900	0.485		
	WCDMA Band II	0.590		
	WCDMA Band V	0.146		
	LTE Band 2	0.792		
	LTE Band 5	0.128		
	LTE Band 7	0.435		
	LTE Band 38	0.338		
	LTE Band 40	0.237		
	LTE Band 41	0.276		
	WLAN 2.4 GHz	0.150	DTS	
	WLAN 5.2 GHz	0.146	NII	
	WLAN 5.8 GHz	0.310		

This device is in compliance with Specific Absorption Rate(SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC47 CFR part 2(2.1093) and ANSI/IEEE C95.1-2019, and had been tested in accordance with the measurement methods and procedures specified in IEC/IEEE 62209-1528: 2020.

<Highest Reported Simultaneous SAR>

Exposure Position	Simultaneous Configuration	Highest Reported Simultaneous Transmission SAR (W/kg)	Limit (W/kg)	Verdict
Head 1-g SAR (0 mm Gap)	LTE Band 2 + 2.4G WIFI	0.576	1.6	Pass
Hotspot(Body) 1-g SAR (10 mm Gap)	LTE Band 2 + 5G WIFI	1.102	1.6	Pass

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3.4 Test Uncertainty

3.4.1 Measurement uncertainly evaluation for SAR test

Measurement uncertainly evaluation for SAR test (300MHz to 6GHz)

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	√0.5	√0.5	1.43	1.43	∞
Hemispherical Isotropy	5.9	R	√3	√0.5	√0.5	2.41	2.41	∞
Boundary effect	1.0	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1.0	R	√3	1	1	0.58	0.58	∞
Modulation response	3.0	R	√3	1	1	1.73	1.73	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	1	1	0.00	0.00	∞
Integration Time	1.4	R	√3	1	1	0.81	0.81	∞
RF ambient Conditions - Noise	3.0	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3.0	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Test sample Related								
Test sample positioning	2.6	N	1	1	1	2.60	2.60	11
Device Holder Uncertainty	3.0	N	1	1	1	3.00	3.00	7
Output power Variation - SAR drift measurement	5.0	R	√3	1	1	2.89	2.89	∞
SAR scaling	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4.0	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.47	10.34	
Expanded Uncertainty (95% Confidence interval)		k				20.95	20.69	

* This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

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3.4.2 Measurement uncertainly evaluation for system check

Uncertainty Component	Tol (+- %)	Prob. Dist.	Div.	Ci (1g)	Ci (10 g)	1g Ui (+- %)	10 g Ui (+-%)	Vi veff
Measurement System								
Probe calibration	5.8	N	1	1	1	5.80	5.80	∞
Axial Isotropy	3.5	R	√3	1	1	2.02	2.02	∞
Hemispherical Isotropy	5.9	R	√3	0	0	0.00	0.00	∞
Boundary effect	1	R	√3	1	1	0.58	0.58	∞
Linearity	4.7	R	√3	1	1	2.71	2.71	∞
System detection limits	1	R	√3	1	1	0.58	0.58	∞
Modulation response	0	N	√3	0	0	0.00	0.00	∞
Readout Electronics	0.5	N	1	1	1	0.50	0.50	∞
Response Time	0	R	√3	0	0	0.00	0.00	∞
Integration Time	1.4	R	√3	0	0	0.00	0.00	∞
RF ambient Conditions - Noise	3	R	√3	1	1	1.73	1.73	∞
RF ambient Conditions - Reflections	3	R	√3	1	1	1.73	1.73	∞
Probe positioner Mechanical Tolerance	1.4	R	√3	1	1	0.81	0.81	∞
Probe positioning with respect to Phantom Shell	1.4	R	√3	1	1	0.81	0.81	∞
Extrapolation, interpolation and integration Algorithms for Max. SAR Evaluation	2.3	R	√3	1	1	1.33	1.33	∞
Dipole								
Deviation of experimental source from numerical source	5	N	1	1	1	5.00	5.00	∞
Input Power and SAR driftmeasurement	0.5	R	√3	1	1	0.29	0.29	∞
Dipole Axis to Liquid Dist.	2.0	R	√3	1	1	1.15	1.15	∞
Phantom and Tissue Parameters								
Phantom Shell Uncertainty - Shape,Thickness and Permittivity	4	R	√3	1	1	2.31	2.31	∞
Uncertainty in SAR correction for deviation in permittivity and conductivity	2.0	N	1	1	0.84	2.00	1.68	∞
Liquid conductivity measurement	4	N	1	0.78	0.71	3.12	2.84	5
Liquid permittivity measurement	5.0	N	1	0.23	0.26	1.15	1.30	5
Liquid Conductivity - Temperature Uncertainty	2.5	R	√3	0.78	0.71	1.13	1.02	∞
Liquid permittivity - Temperature Uncertainty	2.5	R	√3	0.23	0.26	0.33	0.38	∞
Combined Standard Uncertainty		RSS				10.16	10.03	
Expanded Uncertainty (95% Confidence interval)		k				20.32	20.06	

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4. Measurement System

4.1 Specific Absorption Rate (SAR) Definition

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$\mathbf{SAR} = \frac{d}{dt}\left(\frac{dW}{dm}\right) = \frac{d}{dt}\left(\frac{dW}{\rho dv}\right)$$

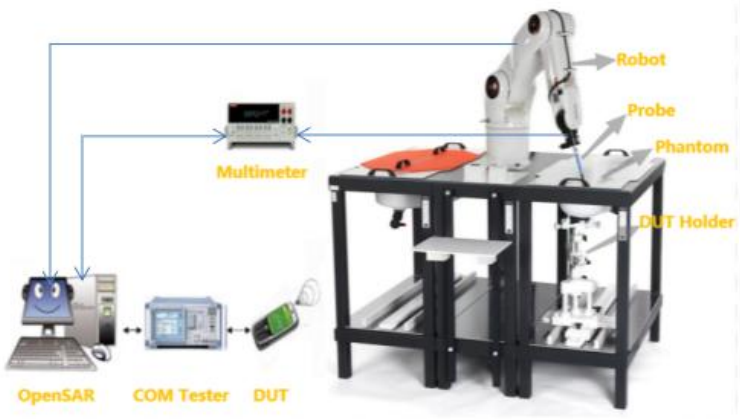
SAR is expressed in units of Watts per kilogram (W/kg) SAR measurement can be related to the electrical field in the tissue by

$$\mathbf{SAR} = \frac{\sigma E^2}{\rho}$$

Where: σ is the conductivity of the tissue,
ρ is the mass density of the tissue and E is the RMS electrical field strength.

4.2 MVG SAR System

4.2.1 SAR system diagram



4.2.2 Robot

A standard high precision 6-axis robot (Denso) with teaches pendant with Scanning System
· It must be able to scan all the volume of the phantom to evaluate the tridimensional distribution of SAR.
· Must be able to set the probe orthogonal of the surface of the phantom (±30°).
· Detects stresses on the probe and stop itself if necessary to keep the integrity of the probe.

4.2.3 E-Field Probe

For the measurements, the Specific Dosimetric SSE2 E-Field Probe with following specifications is used:

- Dynamic range: 0.01-100 W/kg
- Tip diameter: 2mm for SSE2
- Distance between probe tip and sensor centre: 1mm for SSE2
- Distance between sensor centre and the inner phantom surface: 2mm for f>=4GHz.
- Probe linearity: <0.25dB.
- Axial Isotropy: <0.25dB.
- Spherical Isotropy: <0.50dB.
- Calibration range: 150 to 6000 MHz for head & body simulating liquid
- Angle between probe axis (evaluation axis) and surface normal line: less than 20°.

4.2.4 Phantoms

SAM Phantom

For the measurements the Specific Anthropomorphic Mannequin (SAM) defined by the IEEE SCC-34/SC2 group is used. The probe scanning of the E-Field is done in the 2 halves of the normalized head. The normalized shape of the phantom corresponds to the dimensions of 90% of an adult head size. It enables the dosimetric evaluation of left and right-hand phone usage and includes an additional flat phantom part for the simplified body performance check.The phantom set-up includes a cover, which prevents the evaporation of the liquid.

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The thickness of the phantom amounts to 2 mm±0.2 mm. The materials for the phantom do not affect the radiation of the device under test (DUT) : εr' <5
The head is filled with tissue simulating liquid. The hand do not have to be modeled.

SAM Phantom

TWIN SAM phantom			
	Mechanical	Electrical	
Overall thickness	2±0.2 mm(except ear area)	Relative permittivity	3.4
Dimensions	1000 mm(L) x 500 mm(W) x 200 mm(H)	Loss tangent	0.02
Maximum volume	27 L		
Material	Fiberglass based		

ELLIPTICAL Phantom

The phantom is for Body performance check filled with tissue-equivalent liquid to a depth of at least 150 mm, whose shell material is resistant to damage or reaction with tissue-equivalent liquid chemicals.

The shape of the phantom is an ellipse with length 600mm±5mm and width 400mm±5mm.
The phantom shell is made of low-loss and low-permittivity material, having loss tangent tanδ ≤ 0.05 and relative permittivity:
εr' ≤ 5 for f ≤ 3 GHz
3 ≤εr' ≤ 5 for f > 3 GHz
The thickness of the bottom-wall of the flat phantom is 2.0 mm with a tolerance of ± 0.2 mm.

ELLI Phantom

Technical & mechanical characteristics	
Shell thickness	2 mm ± 0.2 mm
Filling volume	25 L
Dimensions	600 mm x 400 mm x 200mm
Permittivity	4.4
Loss tangent	0.017

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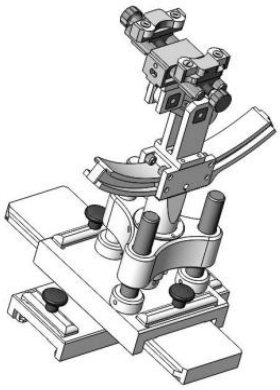
4.2.5 Device Holder



System Material	Permittivity	Loss tangent
Delrin	3.7	0.005

(The positioning system allows obtaining cheek and tilting position with a very good accuracy. In compliance with CENELEC, the tilt angle uncertainty is lower than 1°.)

System Material	Permittivity	Loss tangent
PMMA	2.9	0.028

4.2.6 Simulating Liquid

For SAR measurement of the field distribution inside the phantom, the phantom must be filled with homogeneous tissue simulating liquid to a depth of at least 15 cm. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm. The nominal dielectric values of the tissue simulating liquids in the phantom and the tolerance of 5%.

Head Liquid Depth	Body Liquid Depth
	

The following table gives the recipes for tissue simulating liquid and the theoretical Conductivity/Permittivity.

Head (Reference IEEE1528)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	41.1	57.0	0.2	1.4	0.2	0	0.89	41.9
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1800, 1900, 2000	55.2	0	0	0.3	0	44.5	1.4	40.0
2450	55.0	0	0	0.1	0	44.9	1.80	39.2
2600	54.9	0	0	0.1	0	45.0	1.96	39.0
Frequency (MHz)	Water (%)	Hexyl Carbitol (%)			Triton X-100 (%)		Conductivity σ (S/m)	Permittivity ε
5200	62.52	17.24			17.24		4.66	36.0
5800	62.52	17.24			17.24		5.27	35.3
Body (From instrument manufacturer)								
Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity σ (S/m)	Permittivity ε
750	51.7	47.2	0	0.9	0.1	0	0.96	55.5
835	50.8	48.2	0	0.9	0.1	0	0.97	55.2
900	50.8	48.2	0	0.9	0.1	0	1.05	55.0
1800, 1900, 2000	70.2	0	0	0.4	0	29.4	1.52	53.3
2450	68.6	0	0	0.1	0	31.3	1.95	52.7
2600	68.2	0	0	0.1	0	31.7	2.16	52.5
Frequency(MHz)	Water	DGBE (%)			Salt (%)		Conductivity σ (S/m)	Permittivity ε
5200	78.60	21.40			/		5.30	49.00
5800	78.50	21.40			0.1		6.00	48.20

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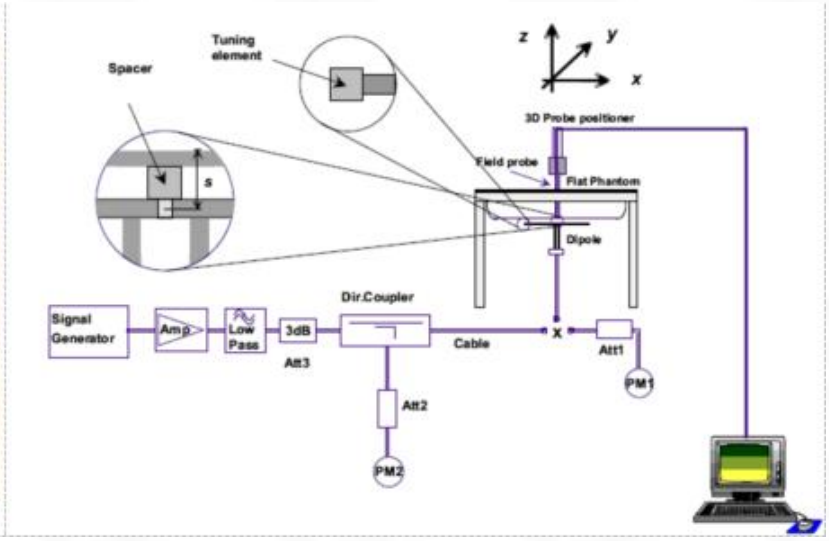
5. System Verification

5.1 Purpose of System Check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. The setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

5.2 System Check Setup



6. TEST POSITION CONFIGURATIONS

According to KDB 648474 D04 Handset, handsets are tested for SAR compliance in head, body-worn accessory and other use configurations described in the following subsections.

6.1 Head Exposure Conditions

Head exposure is limited to next to the ear voice mode operations. Head SAR compliance is tested according to the test positions defined in IEC IEEE 62209-1528:2020 using the SAM phantom illustrated as below.

6.1.1 Definition of the cheek position

The cheek position is established using steps a) to j) as follows.

(a) Configure the DUT for voice operation, if necessary. For example, for a DUT with a flip.a)swivel, or slide cover piece, open the cover if this is consistent with voice operation. If the DUT can also be used with the cover closed, both configurations shall be tested.

(b) Define two imaginary lines on the DUT, the vertical centreline and the horizontal line, relative to the DUT in vertical orientation as shown in Figure 15.

(c) The vertical centreline passes through two points on the front side of the DUT: the midpoint of the width w of the DUT at the level of the acoustic output (Point A in Figure 15), and the midpoint of the width w_t at the bottom of the DUT (Point B). The horizontal line is perpendicular to the vertical centerline, and passes through the centre of the acoustic output (Figure 15). The two lines intersect at Point A. Note that for many DUTs, Point A coincides with the centre of the acoustic output. However, the acoustic output could be located elsewhere on the horizontal line. Also note that the vertical centreline is not necessarily parallel to the front face of the DUT, especially for clamshell DUTs, DUTs with flip cover pieces, and other irregularly shaped DUTs.

(d) Position the DUT close to the surface of the phantom such that Point A is on the (virtual) extension of the line passing through points RE (right-ear ear reference point) and LE left-ear ear reference point) on the phantom (see Figure 16a) and Figure 16b)). The plane determined by the vertical centreline and the horizontal line of the DUT shall be parallel to the sagittal plane of the phantom.

(e) Translate the DUT towards the phantom along the line passing through RE and LE until the DUT touches the ear (see Figure 16c)).

(f) Rotate the DUT around the (virtual) LE-RE Line until the DUT vertical centreline is in the)reference plane(see Figure 16d)).

(g) Rotate the DUT around its vertical centreline until the plane established by the DUT vertical centreline and horizontal line is parallel to the N-F line (see Annex G), and then translate the DUT towards the phantom along the LE-RE line until DUT Point A touches the ear at the ERP (ear reference point) (see Figure 16e))

(h) While keeping Point A on the line passing through RE and LE and maintaining the DUT in contact with the pinna, rotate the DUT about the N-F line until any point on the DUT is in contact with a phantom point below the pinna (cheek) (see Figure 16f)). The physical angles of rotation shall be documented.

(i) While keeping DUT Point A in contact with the ERP rotate the DUT around a line perpendicular to the plane established by the DUT vertical centreline and horizontal line and passing through DUT Point A, until the DUT vertical centreline is in the reference plane(see Figure 16g)).

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(j) Verify that the cheek position is correct as follows:
1) the N-F line is in the plane established by the DUT vertical centreline and horizontal line;
2) DUT Point A touches the pinna at the ERP
3) the DUT vertical centreline is in the reference plane.

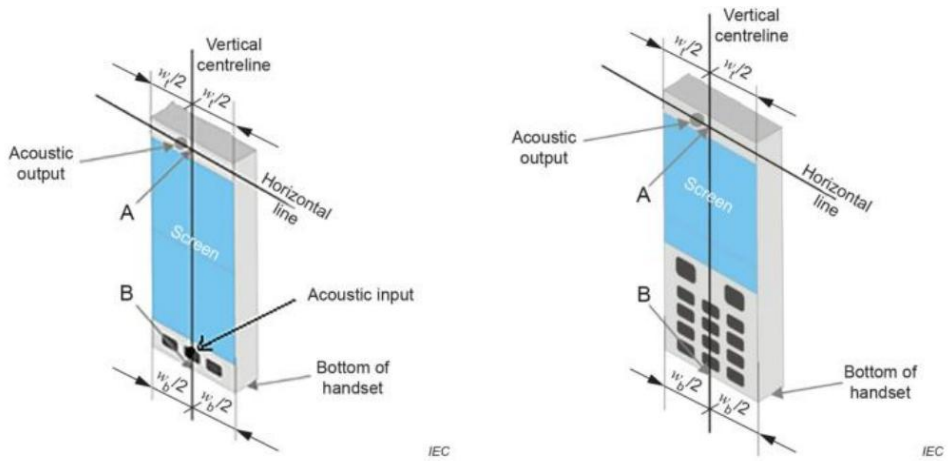
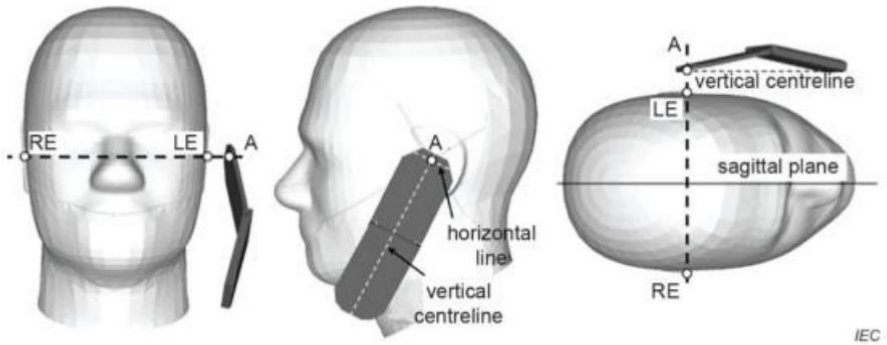


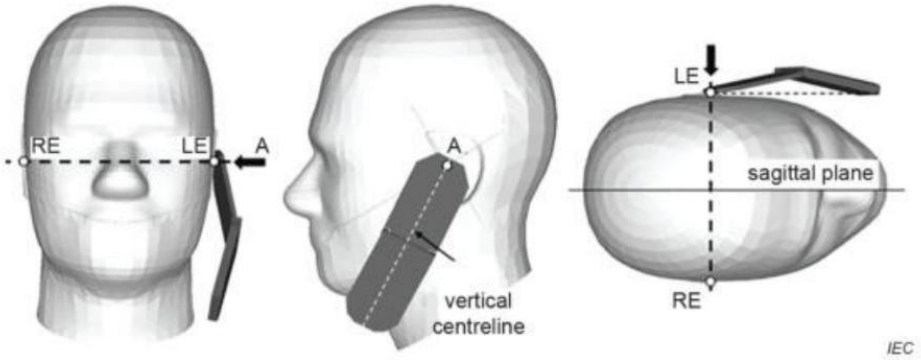
Figure 15 - Vertical and horizontal reference lines and reference points A and B on two example device types: a full touch-screen smart phone (left) and a DUT with a keypad (right)

NOTE The reference points for the right-ear ear reference point (RE), left-ear ear reference point (LE), and mouth (M), which establish the reference plane for DUT positioning, are indicated. This device position shall be maintained for the sagittal phantom test set-up shown in Figure G.4.

a) Phone position 1 – cheek position

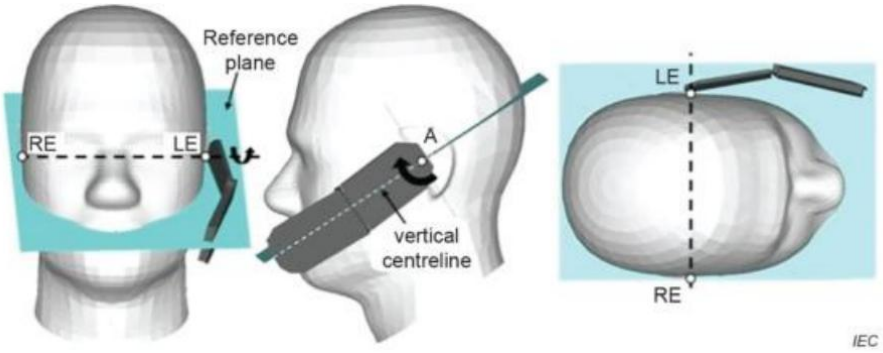


b) One possible DUT position against the head after applying 7.2.4.2.2 c)



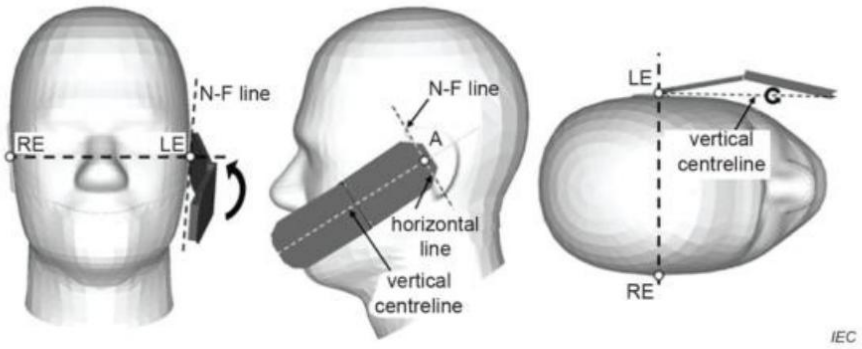
NOTE The black arrows show the direction of translation of the DUT for 7.2.4.2.2 d).

c) DUT position after applying 7.2.4.2.2 d)



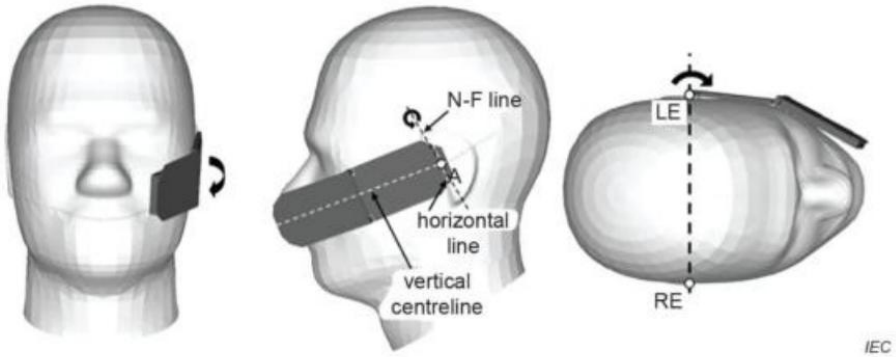
NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 e).

d) DUT position after applying 7.2.4.2.2 e)



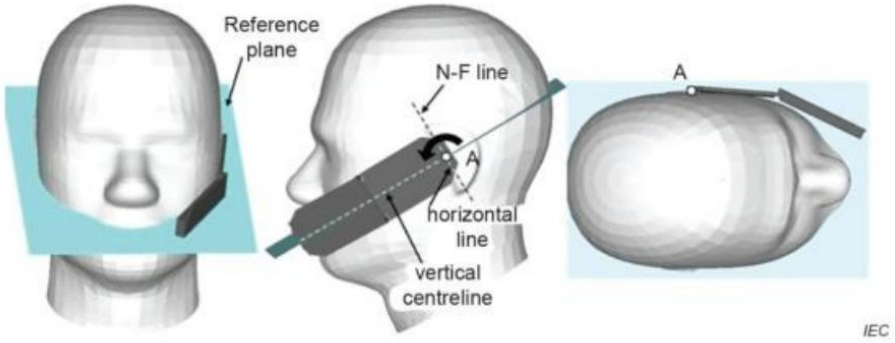
NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 f).

e) DUT position after applying 7.2.4.2.2 f)



NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 g)

f) DUT position after applying 7.2.4.2.2 g)



NOTE The curved black arrows show the direction of rotation of the DUT for 7.2.4.2.2 h).

g) DUT position after applying 7.2.4.2.2 h)

Figure 16 – Cheek position of the DUT on the left side of SAM where the device position shall be maintained for the phantom test set-up

6.1.2 Definition of the tilt position

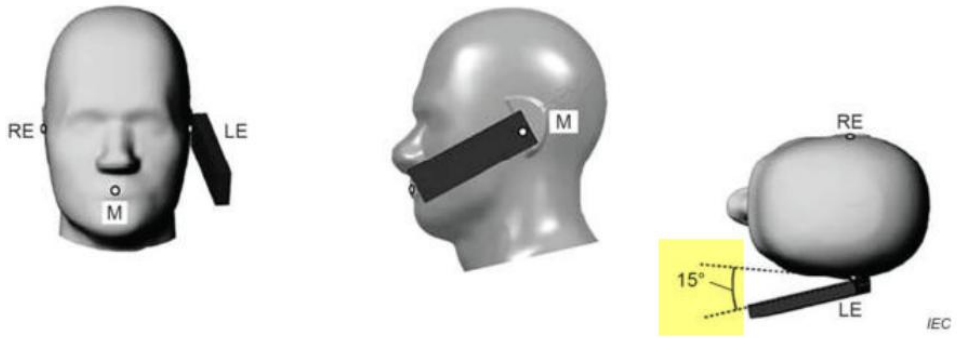
The tilt position is established using steps a) through d) as follows.

(a) Repeat steps a) through j) of 7.2.4.2.2 to place the DUT in the cheek position)(see Figure16).

(b) While maintaining the orientation of the DUT, move the DUT away from the pinna along the line passing through RE and LE far enough to allow a rotation of the DUT away from the cheek by 15°.

(c) Rotate the DUT around the horizontal line by 15°(see Figure 17).

(d) While maintaining the orientation of the DUT. move the DUT towards the phantom on a line passing through RE and LE until any part of the DUT touches the ear. The tilt position is obtained when the contact is on the pinna. If the contact is at any location other than the pinna, e.g. an extended antenna in contact with the back of the head phantom, the angle of the DUT shall be reduced. in this case, the tilt position is obtained if any part of the DUT is in contact with the pinna and a second point on the DUT is in contact with the phantom,e.g.the antenna in contact with the back of the head.



Key

M Mouth reference point

LE Left-ear ear reference point

RE Right-ear ear reference point

This device position shall be maintained for the phantom test set-up.

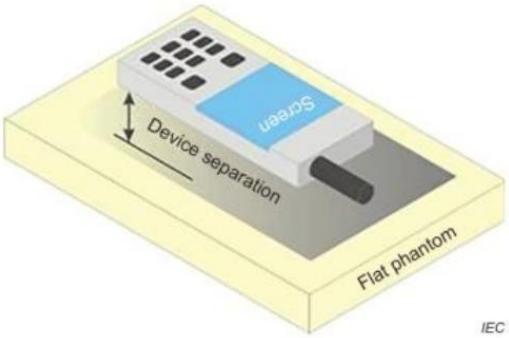
Figure 17 – Tilt position of the DUT on the left side of SAM

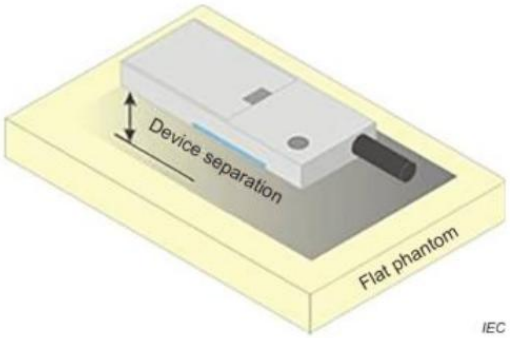
6.2 Body-worn Position Conditions

Body-worn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in KDB 447498 are used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode. When the reported SAR for a body-worn accessory.

Body-worn accessories that do not contain metallic or conductive components may be tested according to worst-case exposure configurations, typically according to the smallest test separation distance required for the group of body-worn accessories with similar operating and exposure characteristics. All body-worn accessories containing metallic components are tested in conjunction with the host device.

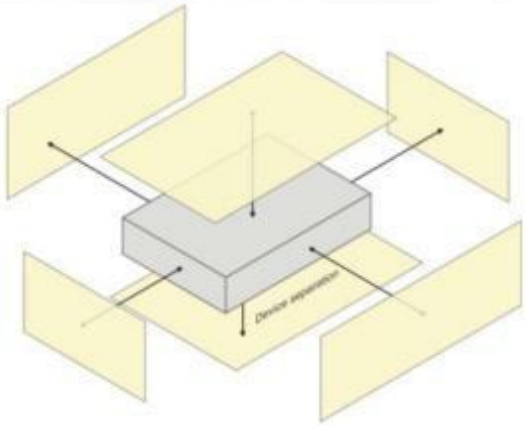
Body-worn accessory SAR compliance is based on a single minimum test separation distance for all wireless and operating modes applicable to each body-worn accessory used by the host, and according to the relevant voice and/or data mode transmissions and operations. If a body-worn accessory supports voice only operations in its normal and expected use conditions, testing of data mode for body-worn compliance is not required. A conservative minimum test separation distance for supporting off-the-shelf body-worn accessories that may be acquired by users of consumer handsets is used to test for body-worn accessory SAR compliance. This distance is determined by the handset manufacturer, according to the requirements of Supplement C 01-01. Devices that are designed to operate on the body of users using lanyards and straps, or without requiring additional body-worn accessories, will be tested using a conservative minimum test separation distance <= 5 mm to support compliance.





6.3 Hotspot Mode Exposure Position Conditions

For handsets that support hotspot mode operations, with wireless router capabilities and various web browsing functions, the relevant hand and body exposure conditions are tested according to the hotspot SAR procedures in KDB 941225. A test separation distance of 10 mm is required between the phantom and all surfaces and edges with a transmitting antenna located within 25 mm from that surface or edge. When the form factor of a handset is smaller than 9 cm x 5 cm, a test separation distance of 5 mm (instead of 10 mm) is required for testing hotspot mode. When the separation distance required for body-worn accessory testing is larger than or equal to that tested for hotspot mode, in the same wireless mode and for the same surface of the phone, the hotspot mode SAR data may be used to support body-worn accessory SAR compliance for that particular configuration (surface).



6.4 Product Specific 10g Exposure Consideration

According with FCC KDB 648474 D04, for smart phones with a display diagonal dimension > 15.0 cm or an overall diagonal dimension > 16.0 cm that provide similar mobile web access and multimedia support found in mini-tablets or UMPC mini-tablets that support voice calls next to the ear, unless it is confirmed otherwise through KDB inquiries, the following phablet procedures should be applied to evaluate SAR compliance for each applicable wireless modes and frequency band. Devices marketed as phablets, regardless of form factors and operating characteristics must be tested as a phablet to determine SAR compliance;

The UMPC mini-tablet procedures must also be applied to test the SAR of all surfaces and edges with an antenna located at ≤ 25 mm from that surface or edge, in direct contact with a flat phantom, for 10-g extremity SAR according to the body-equivalent tissue dielectric parameters in KDB 865664 to address interactive hand use exposure conditions. The UMPC mini-tablet 1-g SAR at 5 mm is not required. When hotspot mode applies, 10-g extremity SAR is required only for the surfaces and edges with hotspot mode 1-g reported SAR > 1.2 W/kg.

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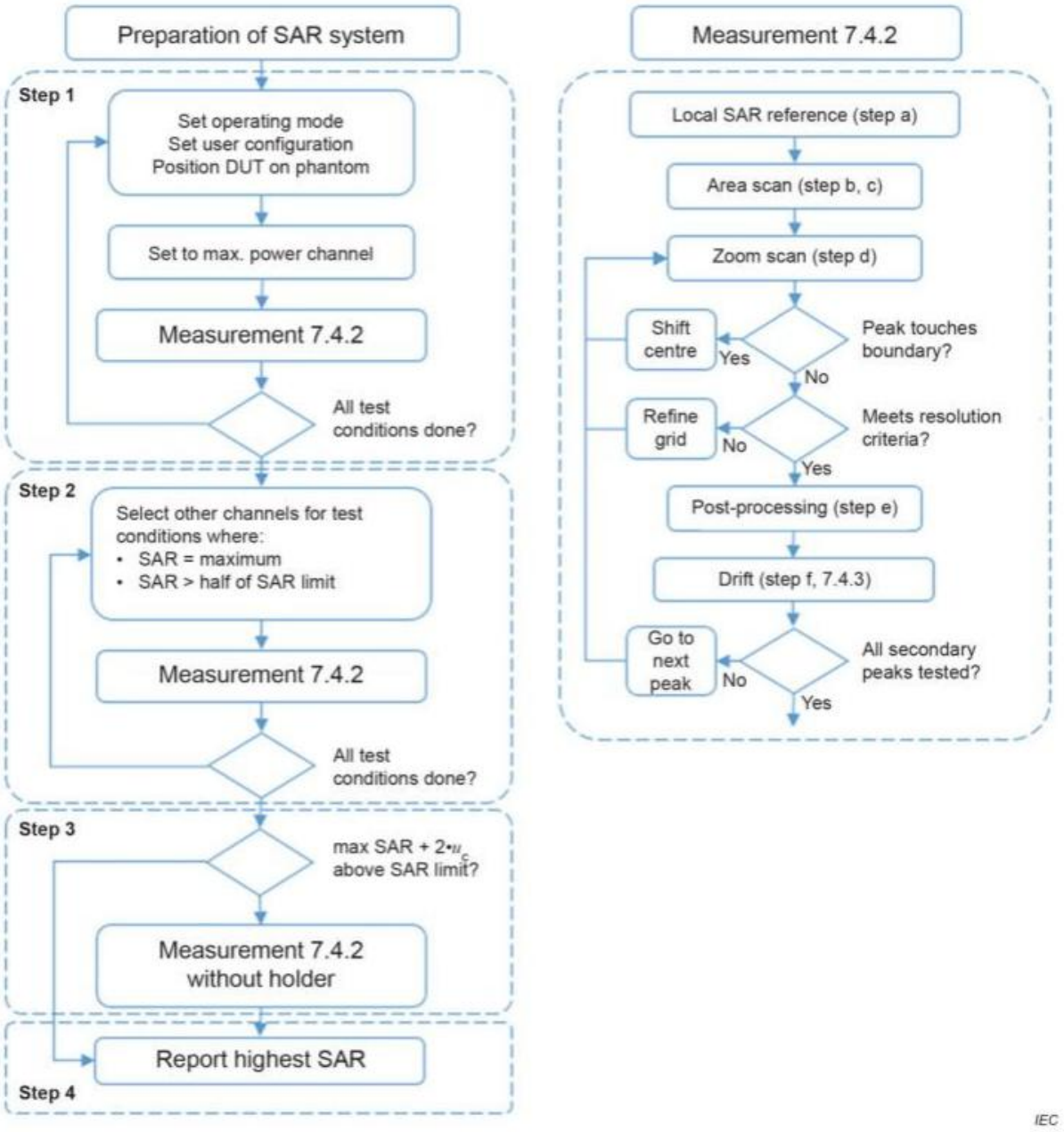
7. Measurement Procedure

7.1 Measurement Process Diagram

Body SAR



7.2 SAR Scan General Requirement

Probe boundary effect error compensation is required for measurements with the probe tip closer than half a probe tip diameter to the phantom surface. Both the probe tip diameter and sensor offset distance must satisfy measurement protocols; to ensure probe boundary effect errors are minimized and the higher fields closest to the phantom surface can be correctly measured and extrapolated to the phantom surface for computing 1 g SAR. Tolerances of the post-processing algorithms must be verified by the test laboratory for the scan resolutions used in the SAR measurements, according to the reference distribution functions specified in IEC/IEEE 62209-1528: 2020.

Table 3 – Area scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the measured points (geometric centre of the sensors) and the inner phantom surface (z_{M1} in Figure 20 in mm)	5 ± 1	$\delta \ln(2)/2 \pm 0,5$ [a]
Maximum spacing between adjacent measured points in mm (see O.8.3.1)[b]	20, or half of the corresponding zoom scan length, whichever is smaller	$60/f$, or half of the corresponding zoom scan length, whichever is smaller
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)[c]	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] See Clause O.8 on how Δx and Δy may be selected for individual area scan requirements.

[c] The probe angle relative to the phantom surface normal is restricted due to the degradation in the measurement accuracy in fields with steep spatial gradients. The measurement accuracy decreases with increasing probe angle and increasing frequency. This is the reason for the tighter probe angle restriction at frequencies above 3 GHz.

Table 4 – Zoom scan parameters

Parameter	DUT transmit frequency being tested	
	$f \leq 3$ GHz	3 GHz < $f \leq 10$ GHz
Maximum distance between the closest measured points and the phantom surface (z_{M1} in Figure 20 and Table 3, in mm)	5	$\delta \ln(2)/2$ [a]
Maximum angle between the probe axis and the phantom surface normal (α in Figure 20)	5° (flat phantom only) 30° (other phantoms)	5° (flat phantom only) 20° (other phantoms)
Maximum spacing between measured points in the x- and y-directions (Δx and Δy, in mm)	8	$24/f$ [b]
For uniform grids: Maximum spacing between measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	5	$10/(f - 1)$
For graded grids: Maximum spacing between the two closest measured points in the direction normal to the phantom shell (Δz_1 in Figure 20, in mm)	4	$12/f$
For graded grids: Maximum incremental increase in the spacing between measured points in the direction normal to the phantom shell ($R_z = \Delta z_2/\Delta z_1$ in Figure 20)	1,5	1,5
Minimum edge length of the zoom scan volume in the x- and y-directions (L_z in O.8.3.2, in mm)	30	22
Minimum edge length of the zoom scan volume in the direction normal to the phantom shell (L_h in O.8.3.2 in mm)	30	22
Tolerance in the probe angle	1°	1°

[a] δ is the penetration depth for a plane-wave incident normally on a planar half-space.

[b] This is the maximum spacing allowed, which might not work for all circumstances.

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7.3 Measurement Procedure

The following steps are used for each test position

a. Establish a call with the maximum output power with a base station simulator. The connection between the mobile and the base station simulator is established via air interface

b. Measurement of the local E-field value at a fixed location. This value serves as a reference value for calculating a possible power drift.

c. Measurement of the SAR distribution with a grid of 8 to 16mm * 8 to16 mm and a constant distance to the inner surface of the phantom. Since the sensors cannot directly measure at the inner phantom surface, the values between the sensors and the inner phantom surface are extrapolated. With these values the area of the maximum SAR is calculated by an interpolation scheme.

d. Around this point, a cube of 30 * 30 * 30 mm or 32 * 32 *32 mm is assessed by measuring 5 or 8 * 5 or 8*4 or 5 mm. With these data, the peak spatial-average SAR value can be calculated.

7.4 Area & Zoom Scan Procedure

First Area Scan is used to locate the approximate location(s) of the local peak SAR value(s). The measurement grid within an Area Scan is defined by the grid extent, grid step size and grid offset. Next, in order to determine the EM field distribution in a three-dimensional spatial extension, Zoom Scan is required. The Zoom Scan is performed around the highest E-field value to determine the averaged SAR-distribution over 10 g. Area scan and zoom scan resolution setting follows KDB 865664 D01v01r04 quoted below.

When the 1 g SAR of the highest peak is within 2 dB of the SAR limit, additional zoom scans are required for other peaks within 2 dB of the highest peak that have not been included in any zoom scan to ensure there is no increase in SAR.

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8. Conducted RF Output Power

8.1 GSM

Mode: GSM850		Maximum Tune-up(dBm)	Burst Average Power (dBm)			Division Factors	Frame-Average Power (dBm)		
			CH128	CH190	CH251		CH128	CH190	CH251
			824.2MHz	836.6MHz	848.8MHz		824.2MHz	836.6MHz	848.8MHz
GSM		**32.00**	31.59	31.61	**31.86**	-9.03	22.56	22.58	**22.83**
GPRS (GMSK)	1Tx slot	32.00	31.58	31.56	31.81	-9.03	22.55	22.53	22.78
	2Tx slots	**31.00**	30.53	30.47	**30.71**	-6.02	24.51	24.45	**24.69**
	3Tx slots	28.50	28.31	28.21	28.41	-4.26	24.05	23.95	24.15
	4Tx slots	27.50	27.18	27.08	27.31	-3.01	24.17	24.07	24.30
EGPRS (8PSK)	1Tx slot	26.00	25.49	25.22	25.57	-9.03	16.46	16.19	16.54
	2Tx slots	24.50	24.25	24.02	24.40	-6.02	18.23	18.00	18.38
	3Tx slots	22.50	22.14	21.88	22.33	-4.26	17.88	17.62	18.07
	4Tx slots	21.50	20.91	20.62	21.00	-3.01	17.90	17.61	17.99
Mode: GSM1900		**Maximum Tune-up(dBm)**	**Burst Average Power (dBm)**			Division Factors	**Frame-Average Power (dBm)**		
			CH512	CH661	CH810		CH512	CH661	CH810
			1850.2MHz	1880.0MHz	1909.8MHz		1850.2MHz	1880.0MHz	1909.8MHz
GSM		**31.50**	31.09	31.20	**31.34**	-9.03	22.06	22.17	**22.31**
GPRS (GMSK)	1Tx slot	31.50	31.07	31.19	31.40	-9.03	22.04	22.16	22.37
	2Tx slots	30.50	29.76	29.97	30.34	-6.02	23.74	23.95	24.32
	3Tx slots	28.50	27.71	27.96	28.44	-4.26	23.45	23.70	24.18
	4Tx slots	**28.00**	26.97	27.23	**27.73**	-3.01	23.96	24.22	**24.72**
EGPRS (8PSK)	1Tx slot	28.00	27.46	27.46	27.62	-9.03	18.43	18.43	18.59
	2Tx slots	27.00	26.41	26.48	26.58	-6.02	20.39	20.46	20.56
	3Tx slots	25.00	24.44	24.48	24.57	-4.26	20.18	20.22	20.31
	4Tx slots	23.50	23.32	23.26	23.40	-3.01	20.31	20.25	20.39

Note:
1) Division Factors
To average the power, the division factor is as follows:
1Tx-slot = 1 transmit time slot out of 8 time slots=> conducted power divided by (8/1) => -9.03dB
2Tx-slots = 2 transmit time slots out of 8 time slots=> conducted power divided by (8/2) => -6.02dB
3Tx-slots = 3 transmit time slots out of 8 time slots=> conducted power divided by (8/3) => -4.26dB
4Tx-slots = 4 transmit time slots out of 8 time slots=> conducted power divided by (8/4) => -3.01dB

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8.2 WCDMA

Mode		Maximum Tune-up(dBm)	WCDMA Band II		
			Conducted Power (dBm)		
			CH9262	CH9400	CH9538
			1852.4	1880.0	1907.6
RMC 12.2K		**24.00**	23.48	23.45	**23.54**
HSDPA	Subtest-1	23.00	22.50	22.47	22.54
	Subtest-2	22.50	22.00	21.92	21.95
	Subtest-3	22.50	22.04	22.00	22.08
	Subtest-4	22.50	22.00	21.93	21.99
HSUPA	Subtest-1	21.00	20.90	20.80	20.51
	Subtest-2	21.00	20.50	20.45	20.48
	Subtest-3	21.50	21.47	21.41	21.44
	Subtest-4	20.00	19.99	19.93	19.96
	Subtest-5	21.50	21.48	21.42	21.48
Mode		Maximum Tune-up(dBm)	WCDMA Band V		
			Conducted Power (dBm)		
			CH4132	CH4183	CH4233
			826.4	836.6	846.6
RMC 12.2K		**23.00**	**22.83**	22.78	22.62
HSDPA	Subtest-1	22.00	21.93	21.67	21.67
	Subtest-2	21.50	21.35	21.15	21.18
	Subtest-3	21.50	21.33	21.23	21.22
	Subtest-4	21.50	21.45	21.30	21.18
HSUPA	Subtest-1	20.50	19.89	19.68	20.09
	Subtest-2	20.00	19.92	19.70	19.73
	Subtest-3	21.00	20.93	20.70	20.75
	Subtest-4	19.50	-0.88	19.24	19.22
	Subtest-5	21.50	21.03	20.72	20.70
Per KDB 941225 D01, when the maximum output power and tune-up tolerance specified for production units in a secondary mode is ≤1/2dB higher than the primary mode (RMC12.2kbps) or when the highest reported SAR of the primary mode is scaled by the ratio of specified maximum output power and tune-up tolerance of secondary to primary mode and the adjusted SAR is ≤ 1.2 W/kg, SAR measurement is not required for the secondary mode.					

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8.3 LTE

Band 2

LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18607	18900	19193
					1850.7MHz	1880.0MHz	1909.3MHz
1.4MHz	QPSK	1	0	24.50	24.17	24.13	24.27
			2	24.50	24.41	24.32	24.42
			5	24.50	24.24	24.16	24.34
		3	0	24.50	24.25	24.17	24.15
			1	24.50	24.24	24.21	24.14
			3	24.50	24.27	24.17	24.15
		6	0	23.50	23.38	23.26	23.28
	16QAM	1	0	23.00	22.96	22.96	22.82
			2	23.50	23.10	23.14	22.99
			5	23.00	22.94	22.92	22.84
		3	0	23.50	23.00	22.95	22.94
			1	23.50	23.01	23.00	22.90
			3	23.50	23.01	22.94	22.94
		6	0	22.50	22.26	22.16	22.01
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18615	18900	19185
					1851.5MHz	1880.0MHz	1908.5MHz
3MHz	QPSK	1	0	24.50	24.35	24.21	24.20
			8	24.50	24.40	24.35	24.21
			14	24.50	24.37	24.36	24.22
		8	0	23.50	23.38	23.19	23.32
			4	23.50	23.40	23.21	23.30
			7	23.50	23.40	23.24	23.27
		15	0	23.50	23.29	23.18	23.15
	16QAM	1	0	23.50	23.23	22.99	22.87
			8	23.50	23.27	22.97	22.90
			14	23.50	23.26	22.92	22.94
		8	0	22.50	22.25	22.15	22.19
			4	22.50	22.30	22.16	22.17
			7	22.50	22.28	22.11	22.14
		15	0	22.50	22.26	22.07	22.03
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18625	18900	19175
					1852.5MHz	1880.0MHz	1907.5MHz
5MHz	QPSK	1	0	24.50	24.31	24.07	24.08
			12	25.00	24.52	24.30	24.37
			24	24.50	24.34	24.19	24.26
		12	0	23.50	23.31	23.17	23.20
			6	23.50	23.34	23.18	23.24
			13	23.50	23.29	23.19	23.13
		25	0	23.50	23.30	23.15	23.13
	16QAM	1	0	23.50	23.14	23.10	23.00
			12	23.50	23.33	23.26	23.08
			24	23.50	23.21	23.11	22.89
		12	0	22.50	22.18	22.23	22.19
			6	22.50	22.21	22.15	22.19
			13	22.50	22.27	22.15	22.04
		25	0	22.50	22.21	22.18	22.18

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LTE-FDD Band 2				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		18650	18900	19150
					1855.0MHz	1880.0MHz	1905.0MHz
10MHz	QPSK	1	0	24.50	24.33	24.15	24.17
			24	24.50	24.44	24.39	24.26
			49	24.50	24.25	24.40	24.23
		25	0	23.50	23.31	23.22	23.29
			12	23.50	23.30	23.18	23.25
			25	23.50	23.34	23.16	23.17
		50	0	23.50	23.35	23.19	23.21
	16QAM	1	0	23.50	23.25	22.94	23.02
			24	23.50	23.32	23.14	23.00
			49	23.50	23.32	22.98	22.89
		25	0	22.50	22.27	22.24	22.33
			12	22.50	22.27	22.25	22.30
			25	22.50	22.29	22.15	22.16
		50	0	22.50	22.32	22.22	22.25
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18675	18900	19125
					1857.5MHz	1880.0MHz	1902.5MHz
15MHz	QPSK	1	0	24.50	24.32	24.00	24.27
			38	24.50	24.38	24.32	24.27
			74	24.50	24.21	24.34	24.22
		36	0	24.00	23.51	23.39	23.42
			18	23.50	23.47	23.38	23.45
			37	23.50	23.47	23.39	23.37
		75	0	24.00	23.53	23.36	23.37
	16QAM	1	0	23.50	23.19	23.12	23.00
			38	23.50	23.34	23.23	23.07
			74	23.50	23.24	23.25	22.90
		36	0	23.50	23.48	23.38	23.43
			18	23.50	23.48	23.36	23.40
			37	23.50	23.49	23.38	23.36
		75	0	22.50	22.35	22.30	22.35
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	18700	18900	19100
					1860.0MHz	1880.0MHz	1900.0MHz
20MHz	QPSK	1	0	24.50	24.36	24.03	24.27
			49	**25.00**	**24.50**	24.44	24.43
			99	24.50	24.07	24.37	24.20
		50	0	23.50	23.31	23.18	23.28
			25	23.50	23.32	23.21	23.35
			50	23.50	**23.33**	23.14	23.16
		100	0	23.50	23.35	23.11	23.28
	16QAM	1	0	23.50	23.08	23.20	23.05
			49	23.50	23.36	23.46	23.19
			99	23.50	23.09	23.27	22.92
		50	0	22.50	22.29	22.27	22.37
			25	22.50	22.32	22.29	22.35
			50	22.50	22.39	22.09	22.32
		100	0	22.50	22.32	22.11	22.35

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Band 5

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20407	20525	20643
					824.7MHz	836.5MHz	848.3MHz
1.4MHz	QPSK	1	0	24.00	23.63	23.51	23.57
			2	24.00	23.74	23.66	23.76
			5	24.00	23.59	23.52	23.57
		3	0	24.00	23.69	23.52	23.67
			1	24.00	23.72	23.54	23.66
			3	24.00	23.73	23.55	23.63
		6	0	23.00	22.71	22.59	22.72
	16QAM	1	0	22.50	22.48	22.27	22.31
			2	23.00	22.70	22.44	22.54
			5	22.50	22.48	22.29	22.31
		3	0	23.00	22.52	22.35	22.37
			1	23.00	22.52	22.34	22.38
			3	23.00	22.52	22.40	22.37
		6	0	22.00	21.68	21.32	21.65
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20415	20525	20635
					825.5MHz	836.5MHz	847.5MHz
3MHz	QPSK	1	0	24.00	23.72	23.56	23.63
			8	24.00	23.70	23.55	23.64
			14	24.00	23.64	23.58	23.64
		8	0	23.00	22.72	22.61	22.64
			4	23.00	22.67	22.55	22.67
			7	23.00	22.75	22.52	22.67
		15	0	23.00	22.69	22.52	22.63
	16QAM	1	0	23.00	22.76	22.35	22.41
			8	23.00	22.80	22.33	22.43
			14	23.00	22.73	22.34	22.43
		8	0	22.00	21.74	21.46	21.63
			4	22.00	21.70	21.47	21.66
			7	22.00	21.74	21.45	21.58
		15	0	22.00	21.70	21.45	21.45

LTE-FDD Band 5				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20425	20525	20625
					826.5MHz	836.5MHz	846.5MHz
5MHz	QPSK	1	0	24.00	23.67	23.44	23.52
			12	24.00	23.76	23.55	23.70
			24	24.00	23.55	23.46	23.64
		12	0	23.00	22.64	22.37	22.50
			6	23.00	22.59	22.67	22.48
			13	23.00	22.80	22.45	22.53
		25	0	23.00	22.74	22.59	22.49
	16QAM	1	0	23.00	22.56	22.43	22.47
			12	23.00	22.69	22.61	22.58
			24	23.00	22.53	22.12	22.44
		12	0	22.00	21.55	21.69	21.50
			6	22.00	21.43	21.61	21.51
			13	22.00	21.77	21.47	21.52
		25	0	22.00	21.75	21.51	21.56

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20450	20525	20600
					829.0MHz	836.5MHz	844.0MHz
10MHz	QPSK	1	0	24.00	23.66	23.52	23.57
			24	**24.00**	23.52	**23.69**	23.19
			49	24.00	23.46	23.63	23.50
		25	0	23.00	22.49	22.52	22.44
			12	23.00	22.46	**22.78**	22.34
			25	23.00	22.58	22.53	22.44
		50	0	23.00	22.49	22.75	22.68
	16QAM	1	0	23.00	22.71	22.32	22.01
			24	23.00	22.64	22.44	22.27
			49	22.50	22.48	22.18	22.29
		25	0	22.00	21.45	21.81	21.54
			12	22.00	21.48	21.81	21.20
			25	22.00	21.53	21.53	21.80
		50	0	22.00	21.51	21.72	21.66

Band 7

LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20775	21100	21425
					2502.5MHz	2535.0MHz	2567.5MHz
5MHz	QPSK	1	0	19.00	18.71	18.38	18.73
			12	19.50	18.84	18.54	19.01
			24	19.00	18.72	18.41	18.86
		12	0	18.00	17.66	17.45	17.72
			6	18.00	17.65	17.44	17.73
			13	18.00	17.64	17.48	17.76
		25	0	18.00	17.68	17.47	17.72
	16QAM	1	0	18.00	17.53	17.42	17.49
			12	18.00	17.67	17.54	17.67
			24	18.00	17.57	17.43	17.15
		12	0	17.00	16.54	16.43	16.71
			6	17.00	16.56	16.45	16.69
			13	17.00	16.63	16.46	16.69
		25	0	17.00	16.67	16.42	16.73
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20800	21100	21400
					2505.0MHz	2535.0MHz	2565.0MHz
10MHz	QPSK	1	0	19.00	18.78	18.54	18.56
			24	19.00	18.93	18.56	18.34
			49	19.00	18.74	18.60	18.28
		25	0	18.00	17.40	17.50	17.24
			12	18.00	17.79	17.54	17.29
			25	18.00	17.70	17.54	17.25
		50	0	18.00	17.75	17.52	17.26
	16QAM	1	0	18.00	17.72	17.23	17.35
			24	18.00	17.81	17.32	17.02
			49	17.50	17.44	17.29	17.04
		25	0	17.00	16.61	16.52	16.39
			12	17.00	16.70	16.52	16.38
			25	17.00	16.74	16.55	16.26
		50	0	17.00	16.73	16.56	16.32

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LTE-FDD Band 7				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		20825	21100	21375
					2507.5MHz	2535.0MHz	2562.5MHz
15MHz	QPSK	1	0	18.50	18.25	17.91	18.30
			38	18.50	18.30	18.02	18.19
			74	18.50	18.20	17.94	18.24
		38	0	17.50	17.29	17.13	17.36
			18	17.50	17.25	17.15	17.36
			37	17.50	17.27	17.32	17.37
		75	0	17.50	17.26	17.26	17.36
	16QAM	1	0	17.50	17.24	17.12	16.94
			38	17.50	17.37	17.10	16.98
			74	17.50	17.30	17.08	16.98
		38	0	17.50	17.31	17.19	17.36
			18	17.50	17.32	17.20	17.38
			37	17.50	17.26	17.15	17.36
		75	0	16.50	16.21	16.45	16.33
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	20850	21100	21350
					2510.0MHz	2535.0MHz	2560.0MHz
20MHz	QPSK	1	0	18.50	18.22	17.90	17.91
			49	**18.50**	**18.33**	18.22	18.13
			99	18.50	17.96	18.05	18.19
		50	0	17.50	**17.28**	16.95	17.34
			25	17.50	17.27	16.93	17.35
			50	17.50	17.09	17.03	17.21
		100	0	17.50	17.22	16.99	17.29
	16QAM	1	0	17.50	17.08	17.09	16.89
			49	17.50	17.38	17.26	17.12
			99	17.50	17.01	17.11	17.00
		50	0	17.00	16.28	16.00	16.50
			25	17.00	16.26	16.00	16.54
			50	16.50	16.15	15.93	16.29
		100	0	16.50	16.24	15.90	16.35

Band 38

LTE-TDD Band 38				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		37775	38000	38225
					2572.5MHz	2595.0MHz	2617.5MHz
5MHz	QPSK	1	0	19.00	18.18	18.72	18.74
			12	19.00	18.35	18.96	18.85
			24	19.00	18.27	18.82	18.65
		12	0	18.00	17.45	17.79	17.93
			6	18.00	17.40	17.79	17.95
			13	18.00	17.45	17.90	17.85
		25	0	18.00	17.51	17.87	17.95
	16QAM	1	0	18.50	17.66	17.95	18.17
			12	18.50	17.87	18.17	18.32
			24	18.50	17.78	18.07	18.18
		12	0	17.00	16.55	16.79	16.98
			6	17.00	16.56	16.79	16.99
			13	17.00	16.56	16.87	16.90
		25	0	17.50	16.65	16.90	17.04

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	37800	38000	38200
					2575.00MHz	2595.00MHz	2615.00MHz
10MHz	QPSK	1	0	19.50	18.36	18.75	19.00
			24	19.50	18.57	19.15	19.11
			49	19.50	18.44	19.02	18.81
		25	0	18.50	17.54	17.84	18.03
			12	18.50	17.55	17.82	18.03
			25	18.00	17.62	17.93	17.92
		50	0	18.00	17.64	17.87	17.95
	16QAM	1	0	18.00	17.72	17.88	17.64
			24	18.50	17.96	18.22	17.81
			49	18.50	17.77	18.06	17.54
		25	0	17.50	16.77	16.94	17.03
			12	17.50	16.77	16.92	17.06
			25	17.50	16.86	17.00	16.95
		50	0	17.50	16.76	16.93	17.05

LTE-TDD Band 38				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		37825	38000	38175
					2577.5MHz	2595.0MHz	2612.5MHz
15MHz	QPSK	1	0	19.50	18.24	18.56	19.04
			38	19.50	18.38	18.93	19.09
			74	19.00	18.44	18.96	18.81
		38	0	18.00	17.51	17.90	17.95
			18	18.00	17.48	17.87	17.94
			37	18.00	17.50	17.89	17.95
		75	0	18.00	17.51	17.89	17.95
	16QAM	1	0	18.00	17.60	17.75	17.71
			38	18.50	17.73	18.00	17.82
			74	18.50	17.70	18.01	17.73
		38	0	18.00	17.51	17.87	17.97
			18	18.00	17.49	17.88	17.94
			37	18.00	17.51	17.88	17.95
		75	0	17.00	16.58	16.88	16.97
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	37850	38000	38150
					2580.0MHz	2595.0MHz	2610.0MHz
20MHz	QPSK	1	0	19.00	18.24	18.53	18.79
			49	**19.50**	18.61	19.08	**19.12**
			99	19.00	18.61	18.96	18.69
		50	0	18.00	17.43	17.67	**17.91**
			25	18.00	17.43	17.65	17.88
			50	18.00	17.68	17.87	17.83
		100	0	18.00	17.57	17.72	17.87
	16QAM	1	0	18.00	17.39	17.58	17.37
			49	18.50	17.69	18.00	17.67
			99	18.00	17.58	17.89	17.34
		50	0	17.00	16.62	16.75	16.93
			25	17.00	16.63	16.75	16.95
			50	17.00	16.83	16.87	16.98
		100	0	17.00	16.71	16.75	16.93

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Band 40

LTE-TDD Band 40				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		38725	38750	38775
					2307.5MHz	2310.0MHz	2312.5MHz
5MHz	QPSK	1	0	20.50	20.16	20.06	20.00
			12	20.50	20.25	20.20	20.16
			24	20.50	20.09	20.08	20.00
		12	0	19.50	19.25	19.23	19.15
			6	19.50	19.26	19.22	19.13
			13	19.50	19.26	19.12	19.22
		25	0	19.50	19.27	19.17	19.18
	16QAM	1	0	20.00	19.26	19.50	19.28
			12	20.00	19.37	19.54	19.38
			24	19.50	19.17	19.42	19.18
		12	0	18.50	18.25	18.25	18.21
			6	18.50	18.25	18.26	18.23
			13	18.50	18.28	18.20	18.24
		25	0	18.50	18.32	18.33	18.23

Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	38750
					2310.0MHz
10MHz	QPSK	1	0	20.50	20.08
			24	**20.50**	**20.18**
			49	20.50	20.02
		25	0	19.50	**19.12**
			12	19.50	19.11
			25	19.50	19.12
		50	0	19.50	19.13
	16QAM	1	0	19.50	19.06
			24	19.50	19.18
			49	19.00	18.98
		25	0	18.50	18.20
			12	18.50	18.20
			25	18.50	18.18
		50	0	18.50	18.18

Band 41

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		40265	40690	41215
					2557.5MHz	2600.0MHz	2652.5MHz
5MHz	QPSK	1	0	19.00	18.01	18.56	18.44
			12	19.00	18.20	18.75	18.52
			24	19.00	18.13	18.65	18.32
		12	0	18.00	17.11	17.60	17.43
			6	18.00	17.16	17.64	17.48
			13	18.00	17.14	17.71	17.41
		25	0	18.00	17.14	17.67	17.44
	16QAM	1	0	18.00	17.30	17.77	17.60
			12	18.00	17.50	17.93	17.67
			24	18.00	17.44	17.86	17.59
		12	0	17.00	16.11	16.54	16.37
			6	17.00	16.09	16.59	16.40
			13	17.00	16.14	16.58	16.27
		25	0	17.00	16.21	16.68	16.36

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Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	40290	40690	41190
					2560.0MHz	2600.0MHz	2650.0MHz
10MHz	QPSK	1	0	19.00	18.10	18.59	18.54
			24	19.00	18.47	18.97	18.74
			49	19.00	18.30	18.84	18.43
		25	0	18.00	17.26	17.64	17.49
			12	18.00	17.25	17.62	17.47
			25	18.00	17.28	17.77	17.43
		50	0	18.00	17.24	17.66	17.39
	16QAM	1	0	18.00	16.79	17.66	17.51
			24	18.00	17.09	18.00	17.72
			49	18.00	16.91	17.93	17.47
		25	0	17.00	16.30	16.65	16.53
			12	17.00	16.31	16.69	16.52
			25	17.00	16.30	16.79	16.42
		50	0	17.00	16.35	16.63	16.36

LTE-TDD Band 41				Maximum Tune-up(dBm)	Conducted Power(dBm)		
Bandwidth	Modulation	RB allocation	RB offset		40315	40690	41165
					2562.5MHz	2600.0MHz	2647.5MHz
15MHz	QPSK	1	0	18.50	18.12	18.43	18.38
			38	19.00	18.31	18.81	18.59
			74	19.00	18.17	18.78	18.31
		36	0	18.00	17.29	17.74	17.56
			18	18.00	17.25	17.74	17.55
			37	18.00	17.26	17.75	17.57
		75	0	18.00	17.28	17.73	17.56
	16QAM	1	0	18.00	17.20	17.50	17.46
			38	18.00	17.42	17.82	17.56
			74	18.00	17.38	17.85	17.40
		36	0	18.00	17.26	17.74	17.54
			18	18.00	17.26	17.71	17.55
			37	18.00	17.25	17.74	17.55
		75	0	17.00	16.30	16.71	16.49
Bandwidth	Modulation	RB allocation	RB offset	Maximum Tune-up(dBm)	40340	40690	41140
					2565.0MHz	2600.0MHz	2645.0MHz
20MHz	QPSK	1	0	18.50	18.10	18.30	18.19
			49	**19.00**	18.49	**18.92**	18.75
			99	19.00	18.20	18.72	18.29
		50	0	17.50	17.25	17.43	17.42
			25	17.50	17.33	17.48	17.43
			50	18.00	17.27	**17.75**	17.35
		100	0	18.00	17.32	17.58	17.34
	16QAM	1	0	17.50	16.71	17.24	17.27
			49	18.00	17.05	17.83	17.60
			99	18.00	16.85	17.68	17.26
		50	0	17.00	16.36	16.51	16.53
			25	17.00	16.34	16.51	16.50
			50	17.00	16.36	16.67	16.35
		100	0	17.00	16.40	16.55	16.39

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8.4 Wi-Fi

2.4G

Band (GHz)	Mode	Channel	Freq. (MHz)	EIRP(dBm)	Maximum Tune-up(dBm)	SAR Test Require.
2.4g (2.4~2.4835)	802.11b	1	2412	**15.57**	**16.00**	Yes
		7	2442	15.29	15.50	No
		13	2472	15.43	15.50	No
	802.11g	1	2412	13.30	13.50	No
		7	2442	15.19	15.50	No
		13	2472	13.51	14.00	No
	802.11n(HT20)	1	2412	11.86	12.00	No
		7	2442	14.12	14.50	No
		13	2472	12.55	13.00	No
	802.11n(HT40)	3	2422	12.79	13.00	No
		7	2442	14.39	14.50	No
		11	2462	12.09	12.50	No

5G

Band (GHz)	Mode	Channel	Freq. (MHz)	Average power(dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-1 (5.150~5.250)	802.11a	36	5180	11.07	11.50	No
		40	5200	13.93	14.00	No
		48	5240	13.79	14.00	No
	802.11n(HT20)	36	5180	9.46	9.50	No
		40	5200	14.33	14.50	No
		48	5240	13.79	14.00	No
	802.11ac(VHT20)	36	5180	10.34	10.50	No
		40	5200	14.87	15.00	No
		48	5240	14.29	14.50	No
	802.11n(HT40)	38	5190	11.27	11.50	No
		46	5230	**14.94**	**15.00**	Yes
	802.11ac(VHT40)	38	5190	8.62	9.00	No
		46	5230	14.80	15.00	No
	802.11ac(VHT80)	42	5210	7.27	7.50	No
Band (GHz)	Mode	Channel	Freq. (MHz)	Average power(dBm)	Maximum Tune-up(dBm)	SAR Test Require.
U-NII-3 (5.725~5.850)	802.11a	149	5745	14.87	15.00	No
		157	5785	14.23	14.50	No
		165	5825	12.25	12.50	No
	802.11n(HT20)	149	5745	14.51	15.00	No
		157	5785	13.78	14.00	No
		165	5825	12.71	13.00	No
	802.11ac(VHT20)	149	5745	**15.41**	**15.50**	Yes
		157	5785	13.86	14.00	No
		165	5825	12.90	13.00	No
	802.11n(HT40)	151	5755	14.82	15.00	No
		159	5795	14.06	14.50	No
	802.11ac(VHT40)	151	5755	15.29	15.50	No
		159	5795	14.30	14.50	No
	802.11ac(VHT80)	155	5775	13.05	13.50	No

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8.5 Bluetooth

	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
EDR			0	39	78
			2402MHz	2441MHz	2480MHz
	GFSK	-3.50	-5.28	-3.87	-5.05
	π/4QPSK	-4.00	-5.44	-4.06	-5.19
	8DPSK	-3.50	-5.41	-3.97	-5.21
BLE	Mode	Maximum Tune-up(dBm)	Average Conducted Output Power (dBm)		
			0	20	39
			2402MHz	2440MHz	2480MHz
	1Mbps	**-2.50**	-4.28	**-2.87**	-4.21
	2Mbps	-2.50	-4.13	-2.95	-4.09

Channel	Frequency (GHz)	Max. Tune-up Power (dBm)	Max. Power (mW)	Test distance (mm)	Exclusion thresholds for 1-g SAR(mW)	RF exposure evaluation required
20	2.440	-2.50	0.56	0	2.75	No
20	2.440	-2.50	0.56	10	10.28	No

Note

1. Per KDB 447498 D04 Interim General RF Exposure Guidance v01, the 1-g SAR test exclusion thresholds for 300 MHz to 6 GHz at *test separation distances* ≤ 40 cm are determined by:

$$P_{\text{th}}\,(\text{mW}) = \begin{cases} ERP_{20\,\text{cm}}(d/20\,\text{cm})^{x} & d \le 20\,\text{cm} \\ ERP_{20\,\text{cm}} & 20\,\text{cm} < d \le 40\,\text{cm} \end{cases} \quad \text{(B. 2)}$$

where

$$P_{\text{th}}\,(\text{mW}) = ERP_{20\,\text{cm}}\,(\text{mW}) = \begin{cases} 2040f & 0.3\,\text{GHz} \le f < 1.5\,\text{GHz} \\ 3060 & 1.5\,\text{GHz} \le f \le 6\,\text{GHz} \end{cases} \quad \text{(B. 1)}$$

$$x = -\log_{10}\left(\frac{60}{ERP_{20\,\text{cm}}\sqrt{f}}\right)$$

and f is in GHz, d is the separation distance (cm), and $ERP_{20\text{cm}}$ is per Formula (B.1).

*When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine estimated SAR.

2. Per KDB 248227 D01 v02r02, choose the highest output power channel to test SAR and determine further SAR exclusion.
3. The output power of all data rate were prescan, just the worst case (the lowest data rate) of all mode were shown in report.

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9. Test Exclusion Consideration

Antenna information:

WWAN Main Antenna	GSM/WCDMA/LTE TX/RX
WLAN/BT Antenna	WLAN/BT TX/RX

Note:
1. KDB 447498 D04v01, particular DUT edges were not required to be evaluated for SAR if the antenna-to-edge distance is greater than 2.5cm.
2. Per KDB648474 D04,10-g extremity SAR is not required when Body-Worn mode 1-g reported SAR<1.2W/Kg.

Distance of The Antenna to the EUT surface and edge (mm）						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	<25	<25	55	<25	145	<25
BT/Wifi	<25	<25	60	<25	<25	145
Positions for SAR tests: Hotspot mode						
Antenna	Front Side (mm)	Back Side (mm)	Left Edge (mm)	Right Edge (mm)	Top Edge (mm)	Bottom Edge (mm)
WWAN	Yes	Yes	No	No	No	Yes
BT/Wifi	Yes	Yes	No	Yes	Yes	No

9.1 SAR Test Exclusion Consideration Table

Per KDB 447498 requires when the standalone SAR test exclusion of section 4.3.1 is applied to an antenna that transmits simultaneously with other antennas, the standalone SAR must be estimated according to the following format to determine simultaneous transmission SAR test exclusion:

(max.power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] · [√f(GHz) / x] W/kg for test separation distances ≤ 50 mm;
where x = 7.5 for 1-g SAR, and x= 18.75 for 10-g SAR.
0.4 W/Kg for 1-g SAR and 1.0 W/kg for 10-g SAR, when the test separation distances is > 50 mm

Mode	Channel	Frequency (GHz)	Max tune-up power (dBm)	Max. Power (mW)	Exposure Position	Head	Body-worn
					Test Dist.(mm)	0	10
BT	20	2.440	-2.50	0.56	Estimated SAR(W/kg)	0.023	0.012

10. Test Result

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 850 (voice)	Left Cheek	251	848.8	4.090	0.073	100.00	1.000	31.86	32.00	1.033	0.075	/
	Left Tilt	251	848.8	4.180	0.032	100.00	1.000	31.86	32.00	1.033	0.033	/
	Right Cheek	251	848.8	2.790	0.078	100.00	1.000	31.86	32.00	1.033	**0.081**	1#
	Right Tilt	251	848.8	3.170	0.036	100.00	1.000	31.86	32.00	1.033	0.037	/
Body(10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 850 (voice)	Front	251	848.8	1.800	0.540	100.00	1.000	31.86	32.00	1.033	0.558	/
	Back	251	848.8	2.190	0.572	100.00	1.000	31.86	32.00	1.033	0.591	/
	Right	251	848.8	-4.720	0.476	100.00	1.000	31.86	32.00	1.033	0.492	/
	Bottom	251	848.8	0.300	0.503	100.00	1.000	31.86	32.00	1.033	0.520	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GPRS 850+2slots	Front	251	848.8	4.340	0.571	100.00	1.000	30.71	31.00	1.069	0.610	/
	Back	251	848.8	-3.770	0.603	100.00	1.000	30.71	31.00	1.069	**0.645**	2#
	Right	251	848.8	2.750	0.501	100.00	1.000	30.71	31.00	1.069	0.536	/
	Bottom	251	848.8	0.530	0.533	100.00	1.000	30.71	31.00	1.069	0.570	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 1900 (voice)	Left Cheek	810	1909.8	0.140	0.073	100.00	1.000	31.34	31.50	1.038	0.076	/
	Left Tilt	810	1909.8	1.260	0.037	100.00	1.000	31.34	31.50	1.038	0.038	/
	Right Cheek	810	1909.8	1.870	0.080	100.00	1.000	31.34	31.50	1.038	**0.083**	3#
	Right Tilt	810	1909.8	2.070	0.042	100.00	1.000	31.34	31.50	1.038	0.044	/
Body(10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GSM 1900 (voice)	Front	810	1909.8	1.580	0.402	100.00	1.000	31.34	31.50	1.038	0.417	/
	Back	810	1909.8	-0.150	0.435	100.00	1.000	31.34	31.50	1.038	0.452	/
	Right	810	1909.8	-1.290	0.331	100.00	1.000	31.34	31.50	1.038	0.344	/
	Bottom	810	1909.8	-3.650	0.370	100.00	1.000	31.34	31.50	1.038	0.384	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
GPRS 1900+4slots	Front	810	1909.8	2.120	0.421	100.00	1.000	27.73	28.00	1.064	0.448	/
	Back	810	1909.8	2.650	0.456	100.00	1.000	27.73	28.00	1.064	**0.485**	4#
	Right	810	1909.8	-1.590	0.364	100.00	1.000	27.73	28.00	1.064	0.387	/
	Bottom	810	1909.8	-2.800	0.393	100.00	1.000	27.73	28.00	1.064	0.418	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Left Cheek	9538	1907.6	2.160	0.076	100.00	1.000	23.54	24.00	1.112	0.085	/
	Left Tilt	9538	1907.6	-1.830	0.040	100.00	1.000	23.54	24.00	1.112	0.044	/
	Right Cheek	9538	1907.6	-3.610	0.083	100.00	1.000	23.54	24.00	1.112	**0.092**	5#
	Right Tilt	9538	1907.6	2.160	0.044	100.00	1.000	23.54	24.00	1.112	0.049	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas. SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 2 (RMC*)	Front	9538	1907.6	-4.000	0.504	100.00	1.000	23.54	24.00	1.112	0.560	/
	Back	9538	1907.6	-0.500	0.531	100.00	1.000	23.54	24.00	1.112	**0.590**	6#
	Right	9538	1907.6	1.540	0.432	100.00	1.000	23.54	24.00	1.112	0.480	/
	Bottom	9538	1907.6	-4.300	0.467	100.00	1.000	23.54	24.00	1.112	0.519	/

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Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Left Cheek	4132	826.4	2.591	0.076	100.00	1.000	22.83	23.00	1.040	0.079	/
	Left Tilt	4132	826.4	2.147	0.040	100.00	1.000	22.83	23.00	1.040	0.042	/
	Right Cheek	4132	826.4	-1.060	0.081	100.00	1.000	22.83	23.00	1.040	**0.084**	7#
	Right Tilt	4132	826.4	1.710	0.045	100.00	1.000	22.83	23.00	1.040	0.047	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
WCDMA Band 5 (RMC*)	Front	4132	826.4	2.060	0.122	100.00	1.000	22.83	23.00	1.040	0.127	/
	Back	4132	826.4	-3.160	0.140	100.00	1.000	22.83	23.00	1.040	**0.146**	8#
	Right	4132	826.4	-0.470	0.083	100.00	1.000	22.83	23.00	1.040	0.086	/
	Bottom	4132	826.4	1.330	0.100	100.00	1.000	22.83	23.00	1.040	0.104	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Left Cheek	18700	1860.0	-0.490	0.138	100.00	1.000	24.50	25.00	1.122	0.155	/
		Left Tilt	18700	1860.0	2.060	0.067	100.00	1.000	24.50	25.00	1.122	0.075	/
		Right Cheek	18700	1860.0	-4.810	0.142	100.00	1.000	24.50	25.00	1.122	**0.159**	9#
		Right Tilt	18700	1860.0	0.160	0.073	100.00	1.000	24.50	25.00	1.122	0.082	/
	50%RB	Left Cheek	18700	1860.0	2.710	0.117	100.00	1.000	23.33	23.50	1.040	0.122	/
		Left Tilt	18700	1860.0	-0.620	0.060	100.00	1.000	23.33	23.50	1.040	0.062	/
		Right Cheek	18700	1860.0	2.450	0.123	100.00	1.000	23.33	23.50	1.040	0.128	/
		Right Tilt	18700	1860.0	1.660	0.065	100.00	1.000	23.33	23.50	1.040	0.068	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 2 (BW: 20MHz)	1RB	Front	18700	1860.0	-2.870	0.671	100.00	1.000	24.50	25.00	1.122	0.753	/
		Back	18700	1860.0	4.260	0.706	100.00	1.000	24.50	25.00	1.122	**0.792**	10#
		Right	18700	1860.0	1.290	0.598	100.00	1.000	24.50	25.00	1.122	0.671	/
		Bottom	18700	1860.0	-3.220	0.632	100.00	1.000	24.50	25.00	1.122	0.709	/
	50%RB	Front	18700	1860.0	-1.540	0.650	100.00	1.000	23.33	23.50	1.040	0.676	/
		Back	18700	1860.0	0.170	0.683	100.00	1.000	23.33	23.50	1.040	0.710	/
		Right	18700	1860.0	2.390	0.564	100.00	1.000	23.33	23.50	1.040	0.587	/
		Bottom	18700	1860.0	1.130	0.612	100.00	1.000	23.33	23.50	1.040	0.636	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Left Cheek	20525	836.5	2.390	0.133	100.00	1.000	23.69	24.00	1.074	0.143	/
		Left Tilt	20525	836.5	4.400	0.064	100.00	1.000	23.69	24.00	1.074	0.069	/
		Right Cheek	20525	836.5	-4.540	0.139	100.00	1.000	23.69	24.00	1.074	**0.149**	11#
		Right Tilt	20525	836.5	-0.880	0.070	100.00	1.000	23.69	24.00	1.074	0.075	/
	50%RB	Left Cheek	20525	836.5	1.750	0.120	100.00	1.000	22.78	23.00	1.052	0.126	/
		Left Tilt	20525	836.5	-2.980	0.054	100.00	1.000	22.78	23.00	1.052	0.057	/
		Right Cheek	20525	836.5	1.690	0.124	100.00	1.000	22.78	23.00	1.052	0.130	/
		Right Tilt	20525	836.5	0.960	0.061	100.00	1.000	22.78	23.00	1.052	0.064	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 5 (BW: 10MHz)	1RB	Front	20525	836.5	0.010	0.101	100.00	1.000	23.69	24.00	1.074	0.108	/
		Back	20525	836.5	-2.080	0.119	100.00	1.000	23.69	24.00	1.074	**0.128**	12#
		Right	20525	836.5	-1.330	0.064	100.00	1.000	23.69	24.00	1.074	0.069	/
		Bottom	20525	836.5	-0.540	0.081	100.00	1.000	23.69	24.00	1.074	0.087	/
	50%RB	Front	20525	836.5	-2.580	0.082	100.00	1.000	22.78	23.00	1.052	0.086	/
		Back	20525	836.5	-2.530	0.099	100.00	1.000	22.78	23.00	1.052	0.104	/
		Right	20525	836.5	-0.820	0.055	100.00	1.000	22.78	23.00	1.052	0.058	/
		Bottom	20525	836.5	-1.730	0.068	100.00	1.000	22.78	23.00	1.052	0.072	/

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Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 7 (BW: 20MHz)	1RB	Left Cheek	20850	2510.0	3.830	0.127	100.00	1.000	18.33	18.50	1.040	0.132	/
		Left Tilt	20850	2510.0	3.230	0.057	100.00	1.000	18.33	18.50	1.040	0.059	/
		Right Cheek	20850	2510.0	1.530	0.133	100.00	1.000	18.33	18.50	1.040	**0.138**	13#
		Right Tilt	20850	2510.0	-1.400	0.062	100.00	1.000	18.33	18.50	1.040	0.064	/
	50%RB	Left Cheek	20850	2510.0	1.270	0.111	100.00	1.000	17.28	17.50	1.052	0.117	/
		Left Tilt	20850	2510.0	-4.160	0.048	100.00	1.000	17.28	17.50	1.052	0.050	/
		Right Cheek	20850	2510.0	1.310	0.116	100.00	1.000	17.28	17.50	1.052	0.122	/
		Right Tilt	20850	2510.0	0.610	0.053	100.00	1.000	17.28	17.50	1.052	0.056	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 7 (BW: 20MHz)	1RB	Front	20850	2510.0	-0.110	0.382	100.00	1.000	18.33	18.50	1.040	0.397	/
		Back	20850	2510.0	0.730	0.418	100.00	1.000	18.33	18.50	1.040	**0.435**	14#
		Right	20850	2510.0	2.470	0.312	100.00	1.000	18.33	18.50	1.040	0.324	/
		Bottom	20850	2510.0	-1.860	0.357	100.00	1.000	18.33	18.50	1.040	0.371	/
	50%RB	Front	20850	2510.0	0.350	0.350	100.00	1.000	17.28	17.50	1.052	0.368	/
		Back	20850	2510.0	2.320	0.390	100.00	1.000	17.28	17.50	1.052	0.410	/
		Right	20850	2510.0	3.120	0.287	100.00	1.000	17.28	17.50	1.052	0.302	/
		Bottom	20850	2510.0	-0.570	0.322	100.00	1.000	17.28	17.50	1.052	0.339	/

Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 38 (BW: 20MHz)	1RB	Left Cheek	38150	2610.0	-1.770	0.107	100.00	1.000	19.12	19.50	1.091	0.117	/
		Left Tilt	38150	2610.0	-4.250	0.057	100.00	1.000	19.12	19.50	1.091	0.062	/
		Right Cheek	38150	2610.0	0.180	0.112	100.00	1.000	19.12	19.50	1.091	**0.122**	15#
		Right Tilt	38150	2610.0	-2.060	0.061	100.00	1.000	19.12	19.50	1.091	0.067	/
	50%RB	Left Cheek	38150	2610.0	-3.290	0.092	100.00	1.000	17.91	18.00	1.021	0.094	/
		Left Tilt	38150	2610.0	-0.050	0.047	100.00	1.000	17.91	18.00	1.021	0.048	/
		Right Cheek	38150	2610.0	-2.510	0.097	100.00	1.000	17.91	18.00	1.021	0.099	/
		Right Tilt	38150	2610.0	1.070	0.053	100.00	1.000	17.91	18.00	1.021	0.054	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 38 (BW: 20MHz)	1RB	Front	38150	2610.0	-0.330	0.281	100.00	1.000	19.12	19.50	1.091	0.307	/
		Back	38150	2610.0	3.740	0.310	100.00	1.000	19.12	19.50	1.091	**0.338**	16#
		Right	38150	2610.0	4.150	0.220	100.00	1.000	19.12	19.50	1.091	0.240	/
		Bottom	38150	2610.0	0.340	0.254	100.00	1.000	19.12	19.50	1.091	0.277	/
	50%RB	Front	38150	2610.0	-2.580	0.262	100.00	1.000	17.91	18.00	1.021	0.268	/
		Back	38150	2610.0	-3.770	0.285	100.00	1.000	17.91	18.00	1.021	0.291	/
		Right	38150	2610.0	-1.360	0.200	100.00	1.000	17.91	18.00	1.021	0.204	/
		Bottom	38150	2610.0	-1.230	0.227	100.00	1.000	17.91	18.00	1.021	0.232	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 40 (BW: 10MHz)	1RB	Left Cheek	38750	2310.0	4.030	0.114	100.00	1.000	20.18	20.50	1.076	0.123	/
		Left Tilt	38750	2310.0	2.170	0.061	100.00	1.000	20.18	20.50	1.076	0.066	/
		Right Cheek	38750	2310.0	-4.540	0.120	100.00	1.000	20.18	20.50	1.076	**0.129**	17#
		Right Tilt	38750	2310.0	-2.300	0.065	100.00	1.000	20.18	20.50	1.076	0.070	/
	50%RB	Left Cheek	38750	2310.0	-1.130	0.099	100.00	1.000	19.12	19.50	1.091	0.108	/
		Left Tilt	38750	2310.0	-2.060	0.047	100.00	1.000	19.12	19.50	1.091	0.051	/
		Right Cheek	38750	2310.0	0.840	0.105	100.00	1.000	19.12	19.50	1.091	0.115	/
		Right Tilt	38750	2310.0	1.660	0.051	100.00	1.000	19.12	19.50	1.091	0.056	/

Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.

Band 40 (BW: 10MHz)	1RB	Front	38750	2310.0	2.470	0.197	100.00	1.000	20.18	20.50	1.076	0.212	/
		Back	38750	2310.0	-3.100	0.220	100.00	1.000	20.18	20.50	1.076	**0.237**	18#
		Right	38750	2310.0	-2.950	0.150	100.00	1.000	20.18	20.50	1.076	0.161	/
		Bottom	38750	2310.0	-1.340	0.171	100.00	1.000	20.18	20.50	1.076	0.184	/
	50%RB	Front	38750	2310.0	-2.820	0.176	100.00	1.000	19.12	19.50	1.091	0.192	/
		Back	38750	2310.0	0.610	0.201	100.00	1.000	19.12	19.50	1.091	0.219	/
		Right	38750	2310.0	4.110	0.131	100.00	1.000	19.12	19.50	1.091	0.143	/
		Bottom	38750	2310.0	3.240	0.153	100.00	1.000	19.12	19.50	1.091	0.167	/

Head(0mm gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Left Cheek	40690	2600.0	3.660	0.082	100.00	1.000	18.92	19.00	1.019	0.084	/
		Left Tilt	40690	2600.0	-2.060	0.040	100.00	1.000	18.92	19.00	1.019	0.041	/
		Right Cheek	40690	2600.0	-3.640	0.087	100.00	1.000	18.92	19.00	1.019	**0.089**	19#
		Right Tilt	40690	2600.0	-2.710	0.045	100.00	1.000	18.92	19.00	1.019	0.046	/
	50%RB	Left Cheek	40690	2600.0	-1.680	0.070	100.00	1.000	17.75	18.00	1.059	0.074	/
		Left Tilt	40690	2600.0	-3.080	0.031	100.00	1.000	17.75	18.00	1.059	0.033	/
		Right Cheek	40690	2600.0	0.670	0.074	100.00	1.000	17.75	18.00	1.059	0.078	/
		Right Tilt	40690	2600.0	1.230	0.036	100.00	1.000	17.75	18.00	1.059	0.038	/
Body(hotspot open, 10mm Gap)													
Mode	Channel Type	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
Band 41 (BW: 20MHz)	1RB	Front	40690	2600.0	2.100	0.242	100.00	1.000	18.92	19.00	1.019	0.247	/
		Back	40690	2600.0	1.060	0.271	100.00	1.000	18.92	19.00	1.019	**0.276**	20#
		Right	40690	2600.0	-3.530	0.178	100.00	1.000	18.92	19.00	1.019	0.181	/
		Bottom	40690	2600.0	-1.750	0.221	100.00	1.000	18.92	19.00	1.019	0.225	/
	50%RB	Front	40690	2600.0	-3.370	0.220	100.00	1.000	17.75	18.00	1.059	0.233	/
		Back	40690	2600.0	-0.410	0.251	100.00	1.000	17.75	18.00	1.059	0.266	/
		Right	40690	2600.0	3.940	0.154	100.00	1.000	17.75	18.00	1.059	0.163	/
		Bottom	40690	2600.0	2.810	0.198	100.00	1.000	17.75	18.00	1.059	0.210	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11b	Left Cheek	1	2412	2.990	0.371	100.00	1.000	15.57	16.00	1.104	0.410	/
	Left Tilt	1	2412	-0.780	0.168	100.00	1.000	15.57	16.00	1.104	0.185	/
	Right Cheek	1	2412	-2.510	0.378	100.00	1.000	15.57	16.00	1.104	**0.417**	21#
	Right Tilt	1	2412	0.280	0.174	100.00	1.000	15.57	16.00	1.104	0.192	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
2.4g (2.4~2.4835) 802.11b	Front	1	2412	-0.070	0.114	100.00	1.000	15.57	16.00	1.104	0.126	/
	Back	1	2412	-1.600	0.136	100.00	1.000	15.57	16.00	1.104	**0.150**	22#
	Right	1	2412	-1.980	0.070	100.00	1.000	15.57	16.00	1.104	0.077	/
	Top	1	2412	0.250	0.092	100.00	1.000	15.57	16.00	1.104	0.102	/

Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11n(HT40)	Left Cheek	46	5230	-1.350	0.231	100.00	1.000	14.94	15.00	1.014	0.234	/
	Left Tilt	46	5230	0.300	0.122	100.00	1.000	14.94	15.00	1.014	0.124	/
	Right Cheek	46	5230	-2.140	0.236	100.00	1.000	14.94	15.00	1.014	**0.239**	23#
	Right Tilt	46	5230	1.400	0.130	100.00	1.000	14.94	15.00	1.014	0.132	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-1 (5.150~5.250) 802.11n(HT40)	Front	46	5230	0.430	0.121	100.00	1.000	14.94	15.00	1.014	0.123	/
	Back	46	5230	-3.110	0.144	100.00	1.000	14.94	15.00	1.014	**0.146**	24#
	Right	46	5230	-1.380	0.087	100.00	1.000	14.94	15.00	1.014	0.088	/
	Top	46	5230	2.560	0.101	100.00	1.000	14.94	15.00	1.014	0.102	/

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Head(0mm gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-3 (5.725~5.850) 802.11ac(VHT20)	Left Cheek	149	5745	1.550	0.210	100.00	1.000	15.41	15.50	1.021	0.214	/
	Left Tilt	149	5745	0.390	0.107	100.00	1.000	15.41	15.50	1.021	0.109	/
	Right Cheek	149	5745	3.850	0.217	100.00	1.000	15.41	15.50	1.021	**0.222**	25#
	Right Tilt	149	5745	-1.002	0.121	100.00	1.000	15.41	15.50	1.021	0.124	/
Body(hotspot open, 10mm Gap)												
Mode	Position	Ch.	Freq. (MHz)	Power Drift (%)	1g Meas SAR (W/kg)	Duty cycle (%)	Duty cycle Factor	Meas. Power (dBm)	Max. tune-up power (dBm)	Scaling Factor	1g Scaled SAR (W/kg)	Meas. No.
U-NII-3 (5.725~5.850) 802.11ac(VHT20)	Front	149	5745	2.870	0.261	100.00	1.000	15.41	15.50	1.021	0.266	/
	Back	149	5745	1.500	0.304	100.00	1.000	15.41	15.50	1.021	**0.310**	26#
	Right	149	5745	-2.680	0.185	100.00	1.000	15.41	15.50	1.021	0.189	/
	Top	149	5745	-1.330	0.224	100.00	1.000	15.41	15.50	1.021	0.229	/

Note:
1. The maximum SAR Value of each test band is marked bold.
2. SAR plot is provided only for the highest measured SAR in each exposure configuration, wireless mode and frequency band combination.
3. Per KDB 447498 D04 v01, for each exposure position, if the highest output power channel Reported SAR ≤ 0.8W/kg, other channels SAR testing is not necessary.
4. Per KDB 447498 D04 v01, head/body-worn use is evaluated with the device positioned at 0mm/10 mm from a head/flat phantom respectively filled with head tissue-equivalent medium.
5. Per KDB Publication 941225 D06 where SAR test considerations for handsets (L x W ≥ 9 cm x 5 cm) are based on a composite test separation distance of 10 mm from the front, back and edges of the device with antennas 2.5 cm or closer to the edge of the device, determined from general mixed use conditions for this type of devices. Since the hotspot SAR results may overlap with the body-worn accessory SAR requirements, the more conservative configurations can be considered, thus excluding some body-worn accessory SAR tests.
6. Per KDB 447498 D04 v01, the report SAR is measured SAR value adjusted for maximum tune-up tolerance. Scaling Factor=10^[(tune-up limit power(dBm) - Ave.power power (dBm))/10], where tune-up limit is the maximum rated power among all production units.
   Reported SAR(W/kg)=Measured SAR (W/kg)*Scaling Factor.

11. SAR Measurement Variability

According to KDB 865664 D01, SAR measurement variability was assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. Alternatively, if the highest measured SAR for both head and body tissue-equivalent media are ≤ 1.45 W/kg and the ratio of these highest SAR values, i.e., largest divided by smallest value, is ≤ 1.10, the highest SAR configuration for either head or body tissue-equivalent medium may be used to perform the repeated measurement. These additional measurements are repeated after the completion of all measurements requiring the same head or body tissue-equivalent medium in a frequency band. The test device should be returned to ambient conditions (normal room temperature) with the battery fully charged before it is re-mounted on the device holder for the repeated measurement(s) to minimize any unexpected variations in the repeated results.

SAR repeated measurement procedure:

1. When the highest measured SAR is < 0.80 W/kg, repeated measurement is not required.
2. When the highest measured SAR is >= 0.80 W/kg, repeat that measurement once.
3. If the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20, or when the original or repeated measurement is >= 1.45 W/kg, perform a second repeated measurement.
4. If the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20, and the original, first or second repeated measurement is >= 1.5 W/kg, perform a third repeated measurement.

Note: For 1g SAR, the highest measured 1g SAR is 0.706 > 0.80 W/kg, repeated measurement is not required.

BTF Testing Lab (Shenzhen) Co., Ltd.
F101, 201 and 301, Building 1, Block 2, Tantou Industrial Park, Tantou Community, Songgang Street, Bao'an District, Shenzhen, China

12. Simultaneous Transmission

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. When the sum of SAR 1g of all simultaneously transmitting antennas in an operating mode and exposure condition combination is within the SAR limit (SAR 1g 1.6 W/kg), the simultaneous transmission SAR is not required. When the sum of SAR 1g is greater than the SAR limit (SAR 1g 1.6 W/kg), SAR test exclusion is determined by the SAR to Peak Location Ratio (SPLSR).

12.1 Simultaneous Transmission Mode Considerations

Simultaneous transmission SAR test exclusion is determined for each operating configuration and exposure condition according to the reported standalone SAR of each applicable simultaneous transmitting antenna. The device has 2 Tx antennas, WWAN main antenna supports GSM/WCDMA/LTE, Wifi/BT antenna supports 2.4G/5G Wi-Fi and BT. The 2 antennas can always transmit simultaneously. The work mode combination is showed as below table.

Application Simultaneous Transmission information:

NO.	Configuration	Head	Body-worn
1	WWAN+WIFI(2.4g)	Yes	Yes
2	WWAN+WIFI(5g)	Yes	Yes
3	WWAN+BT	Yes	Yes

12.2 Sum SAR of Simultaneous Transmission

Head

Band	Test Position	RB allocation	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE Band 2 QPSK (20MHz)	Left Cheek	1RB	0.155	0.410	0.234	**0.023**	0.565	0.389	0.178	N/A	N/A
	Left Tilt		0.075	0.185	0.124	0.023	0.260	0.199	0.098	N/A	N/A
	Right Cheek		**0.159**	**0.417**	**0.239**	0.023	**0.576**	0.398	0.182	N/A	N/A
	Right Tilt		0.082	0.192	0.132	0.023	0.274	0.214	0.105	N/A	N/A
	Left Cheek	50%RB	0.122	0.410	0.234	0.023	0.532	0.356	0.145	N/A	N/A
	Left Tilt		0.062	0.185	0.124	0.023	0.247	0.186	0.085	N/A	N/A
	Right Cheek		0.128	0.417	0.239	0.023	0.545	0.367	0.151	N/A	N/A
	Right Tilt		0.068	0.192	0.132	0.023	0.260	0.200	0.091	N/A	N/A

Hotspot(body-worn)

Band	Test Position	RB allocation	Scaled				Σ SAR (W/kg) WWAN + WIFI 2.4G	Σ SAR (W/kg) WWAN + WIFI 5G	Σ SAR (W/kg) WWAN + BT	SPLSR	Remark
			WWAN	WIFI 2.4G	WIFI 5G	Bluetooth					
LTE Band 2 QPSK (20MHz)	Front	1RB	0.753	0.126	0.266	**0.012**	0.879	1.019	0.765	N/A	N/A
	Back		**0.792**	**0.150**	**0.310**	0.012	0.942	**1.102**	0.804	N/A	N/A
	Right		0.671	0.077	0.189	0.012	0.748	0.860	0.683	N/A	N/A
	Top		/	0.102	0.229	0.012	0.102	0.229	0.012	N/A	N/A
	Bottom		0.709	/	/	/	0.709	0.709	0.709	N/A	N/A
	Front	50%RB	0.676	0.126	0.266	0.012	0.802	0.942	0.688	N/A	N/A
	Back		0.710	**0.150**	0.310	0.012	0.860	1.020	0.722	N/A	N/A
	Right		0.587	0.077	0.189	0.012	0.664	0.776	0.599	N/A	N/A
	Top		/	0.102	0.229	0.012	0.102	0.229	0.012	N/A	N/A
	Bottom		0.636	/	/	/	0.636	0.636	0.636	N/A	N/A

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13. Test Equipment List

Description	Manufacturer	Model	Serial No./Version	Cal. Date	Cal. Due
E-Field Probe	MVG	SSE2	04/22 EPGO365	2024/02/06	2025/02/05
6 1/2 Digital Multimeter	Keithley	DMM6500	4527164	2023/11/16	2024/11/15
Wideband Radio Communication Tester	ROHDE & SCHWARZ	CMW500	161997	2023/11/16	2024/11/15
MXG Vector Signal Generator	Agilent	N5182A	MY46240163	2023/11/16	2024/11/15
E-Series Avg. Power Sensor	KEYSIGHT	E9300A	MY55050017	2024/03/20	2025/03/19
EPM Series Power Meter	KEYSIGHT	E4418B	MY41293435	2024/03/20	2025/03/19
10dB Attenuator	MIDWEST MICROWAVE	263-10dB	/	2024/03/20	2025/03/19
Coupler	MERRIMAC	CWM-10R-10.8G	LOT-83391	2024/03/20	2025/03/19
835MHz Validation Dipole	MVG	SID835	07/22 DIP 0G835-656	2023/02/06	2025/02/05
1800MHz Validation Dipole	MVG	SID1800	07/22 DIP 1G800-657	2023/02/06	2025/02/05
1900MHz Validation Dipole	MVG	SID1900	07/22 DIP 1G900-658	2023/02/06	2025/02/05
2300MHz Validation Dipole	MVG	SID2300	07/22 DIP 2G300-661	2023/02/06	2025/02/05
2450MHz Validation Dipole	MVG	SID2450	07/22 DIP 2G450-662	2023/02/06	2025/02/05
2600MHz Validation Dipole	MVG	SID2600	07/22 DIP 2G600-663	2023/02/06	2025/02/05
5200MHz-5800MHz Validation Dipole	MVG	SID5000	07/22 DIP5G000-670	2023/02/06	2025/02/05
LIMESAR Dielectric Probe	MVG	SCLMP	06/22 OCPG88	2024/02/02	2025/02/01
ENA Series Network Analyzer	Agilent	E5071B	MY42301221	2023/11/16	2024/11/15
Thermometer	Riters	DT-232	21A11	2024/03/20	2025/03/19
Antenna network emulator	MVG	ANTA 74	07/22 ANTA 74	/	/
SAM Phantom	MVG	SAM	07/22 SAM149	/	/
Mobile Phone Positioning System	MVG	MSH 118	07/22 MSH 118	/	/
Mechanical Calibration Kit	PNA	/	/	2023/11/16	2024/11/15
Open SAR test software	MVG	/	V5.3.5	/	/

Note: For dipole antennas, BTF has adopted 3 years as calibration intervals, and on annual basis, every measurement dipole has been evaluated and is in compliance with the following criteria:

1. There is no physical damage on the dipole;
2. System validation with specific dipole is within 10% of calibrated value;
3. Return-loss in within 20% of calibrated measurement.
4. Impedance (real or imaginary parts) in within 5 Ohms of calibrated measurement.

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ANNEX A Simulating Liquid Verification Result

The dielectric parameters of the liquids were verified prior to the SAR evaluation using an SCLMP Dielectric Probe Kit.

Dielectric performance of tissue simulating liquid									
Frequency (MHz)	εr		σ(s/m)		Delta (εr)	Delta (σ)	Limit	Temp (℃)	Date
	Target	Measured	Target	Measured					
835	41.50	41.41	0.90	0.87	0.22%	3.33%	±5%	20.5	2/8/2024
1800	40.00	39.91	1.40	1.37	0.23%	2.14%	±5%	20.5	6/8/2024
1900	40.00	39.88	1.40	1.41	0.30%	-0.71%	±5%	20.5	7/8/2024
2300	39.50	39.30	1.67	1.70	-0.51%	1.85%	±5%	20.5	8/8/2024
2450	39.20	39.08	1.80	1.81	-0.31%	0.56%	±5%	20.5	9/8/2024
2600	39.00	38.88	1.96	1.97	-0.31%	0.51%	±5%	20.5	12/8/2024
5200	36.00	35.88	4.66	4.70	-0.33%	0.86%	±5%	20.5	13/8/2024
5800	35.30	35.18	5.27	5.31	-0.34%	0.76%	±5%	20.5	13/8/2024
NOTE: The dielectric parameters of the tissue-equivalent liquid should be measured under similar ambient conditions and within 2 ℃ of the conditions expected during the SAR evaluation to satisfy protocol requirements.									

ANNEX B System Check Result

Comparing to the original SAR value provided by MVG, the validation data should be within its specification of 10 %(for 10 g).

Frequency (MHz)	Input Power (mW)	10g SAR (W/Kg)	1g SAR (W/Kg)	10g SAR 1W input power normalized (W/Kg)	1g SAR 1W input power normalized (W/Kg)	10g SAR Standard target (1W) (W/Kg)	1g SAR Standard target (1W) (W/Kg)	10g SAR Deviation	1g SAR Deviation
835	16	0.106	0.163	6.63	10.19	6.17	9.79	7.37%	4.06%
1800	16	0.312	0.588	19.50	36.75	20.61	39.33	-5.39%	-6.56%
1900	16	0.322	0.630	20.13	39.38	20.70	40.97	-2.78%	-3.89%
2300	16	0.34	0.749	21.25	46.81	22.84	50.35	-6.96%	-7.03%
2450	16	0.352	0.793	22.00	49.56	23.86	54.40	-7.80%	-8.89%
2600	16	0.421	0.866	26.31	54.13	24.48	57.14	7.49%	-5.28%
5200	13	0.288	1.019	22.15	78.38	21.29	73.88	4.06%	6.10%
5800	13	0.277	0.981	21.31	75.46	21.50	74.21	-0.89%	1.69%

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ANNEX C SAR Dipole Calibrations

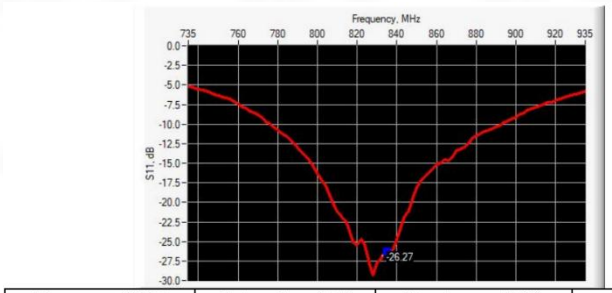
Justification for Extended SAR Dipole Calibrations

Referring to KDB 865664D01V01r04, if dipoles are verified in return loss (<-20dB, within 20% of prior calibration)and in impedance (within 5 ohm of prior calibration). the annual calibration is not necessary and the calibrationinterval can be extended.While calibration intervals not exceed 3 years.

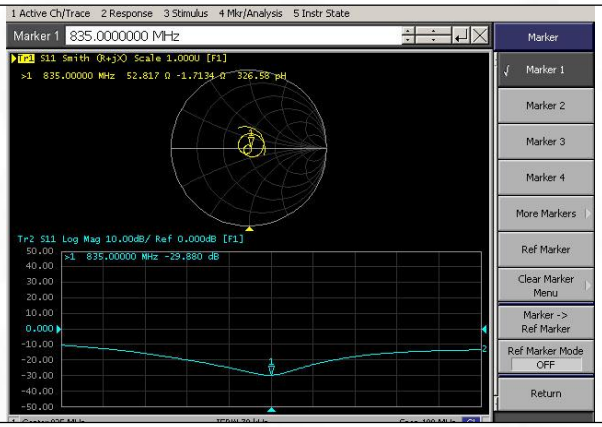
Frequency (MHz)	Return loss(dB)		Impedance(Ω)				error range（%）		Results	Date of Measure ment
	measurement	target	measurement		target		Return loss(±20%)	Impedance(±5 Ω)	(P/F)	
			real part	imaginary part	real part	imaginary part				
CW835	-29.88	-26.27	52.8	-1.7	52.5	-4.2	13.74%	2.8	P	2/5/2024
CW1800	-24.55	-26.54	52.4	-0.2	52.8	+3.8	-7.50%	4.4	P	2/5/2024
CW1900	-25.67	-23.01	51.9	-5.3	51.0	-7.0	11.56%	2.6	P	2/5/2024
CW2300	-32.78	-38.65	49.6	-2.2	50.8	-0.8	-15.19%	2.6	P	2/5/2024
CW2450	-24.37	-21.23	48.3	5.7	49.4	+8.6	14.79%	4.0	P	2/5/2024
CW2600	-20.56	-23.05	57.3	5.7	54.3	+5.5	-10.80%	3.2	P	2/5/2024
CW5200	-21.14	-20.29	58.4	-4.5	58.76	-4.43	4.19%	0.43	P	2/5/2024
CW5800	-28.88	-28.48	50.8	0.1	50.12	-3.76	1.40%	4.34	P	2/5/2024

Dipole calibration report data	Self-examination data

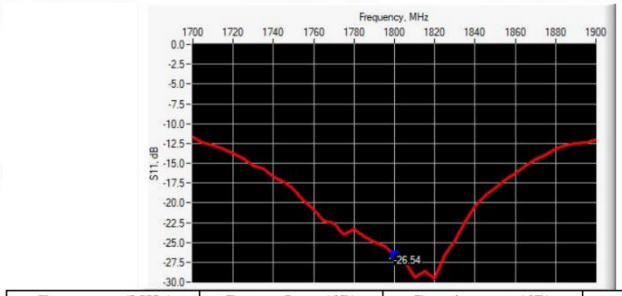
835MHz Dipole



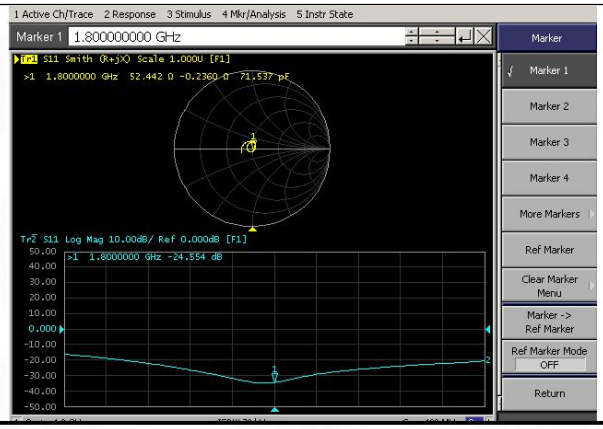
Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
835	-26.27	-20	52.5 Ω - 4.2 jΩ



1800MHz Dipole



Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
1800	-26.54	-20	52.8 Ω + 3.8 jΩ



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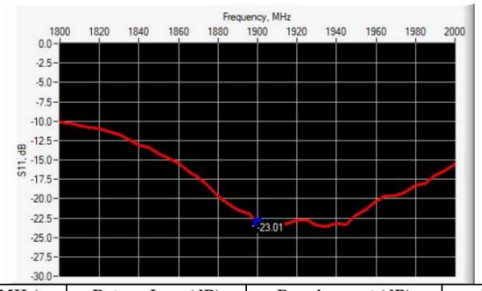
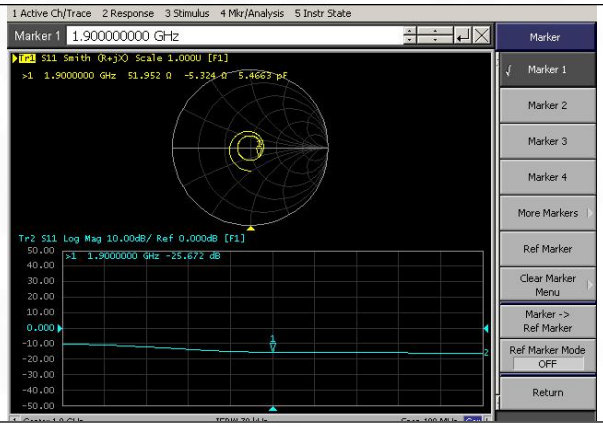
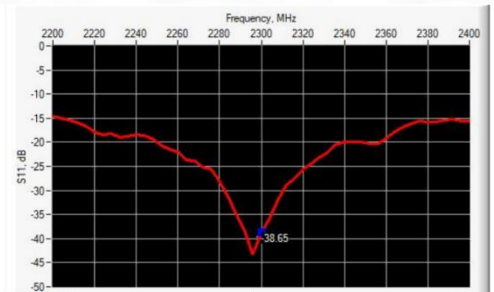
1900MHz Dipole



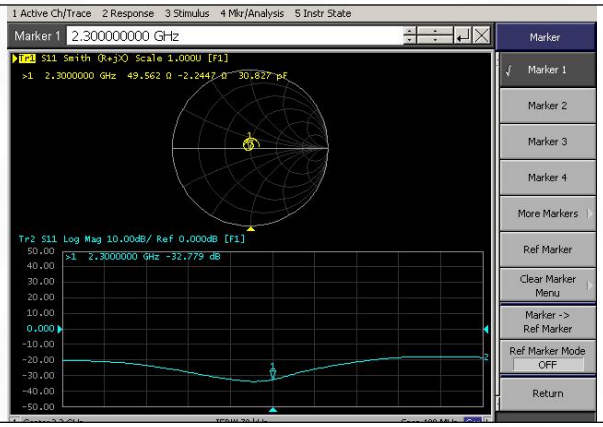
Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
1900	-23.01	-20	51.0 Ω - 7.0 jΩ



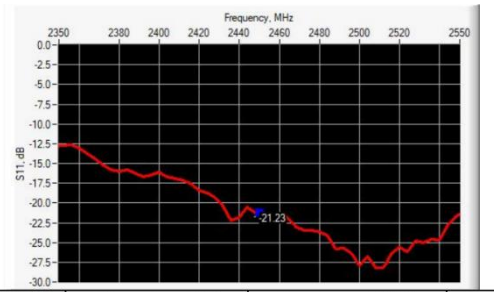
2300MHz Dipole



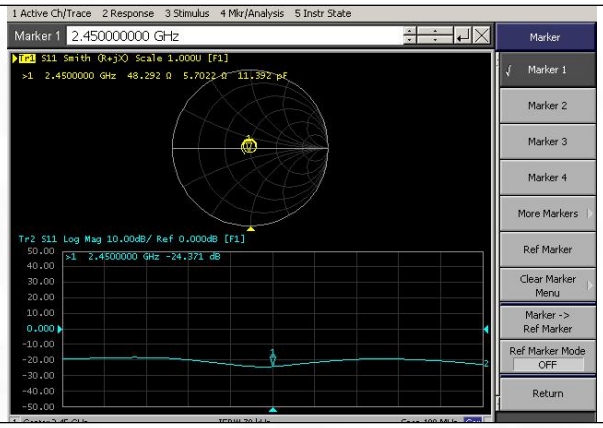
Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2300	-38.65	-20	50.8 Ω - 0.8 jΩ



2450MHz Dipole



Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2450	-21.23	-20	49.4 Ω + 8.6 jΩ



2600MHz Dipole

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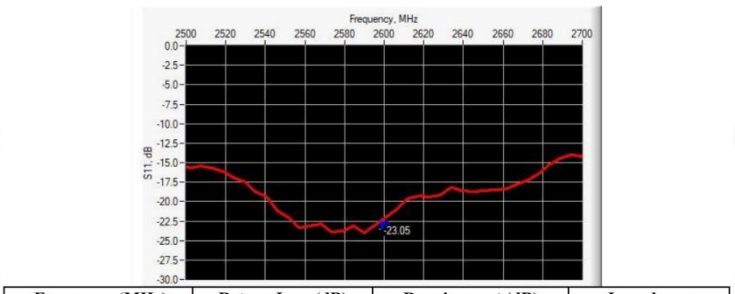
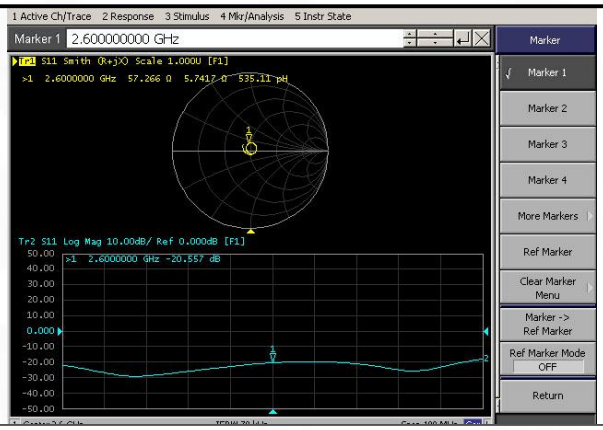
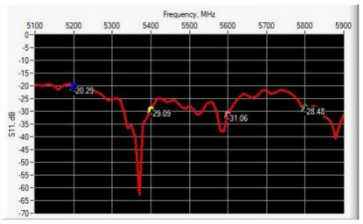


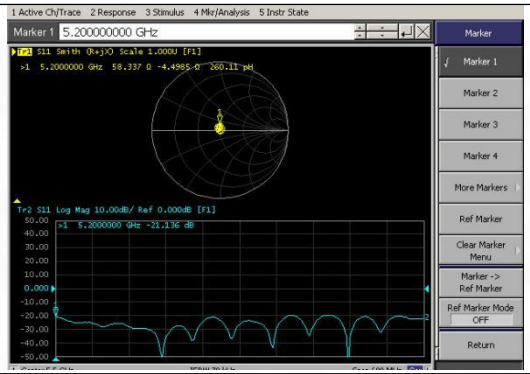
Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
2600	-23.05	-20	54.3 Ω + 5.5 jΩ

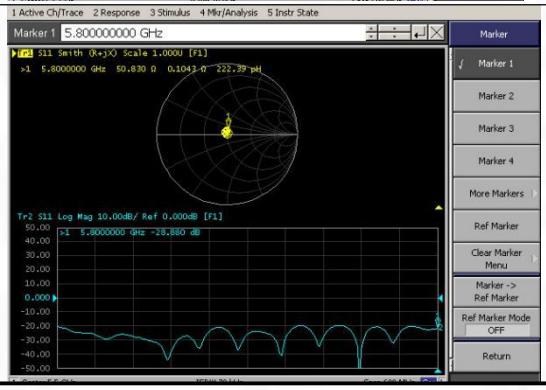


5000MHz Dipole



Frequency (MHz)	Return Loss (dB)	Requirement (dB)	Impedance
5200	-20.29	-20	58.76 Ω - 4.43 jΩ
5400	-29.09	-20	53.46 Ω + 0.61 jΩ
5600	-31.06	-20	52.76 Ω - 0.45 jΩ
5800	-28.48	-20	50.12 Ω - 3.76 jΩ





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System Performance Check Data (835 MHz)

System check at 835 MHz

Date of measurement: 2/8/2024

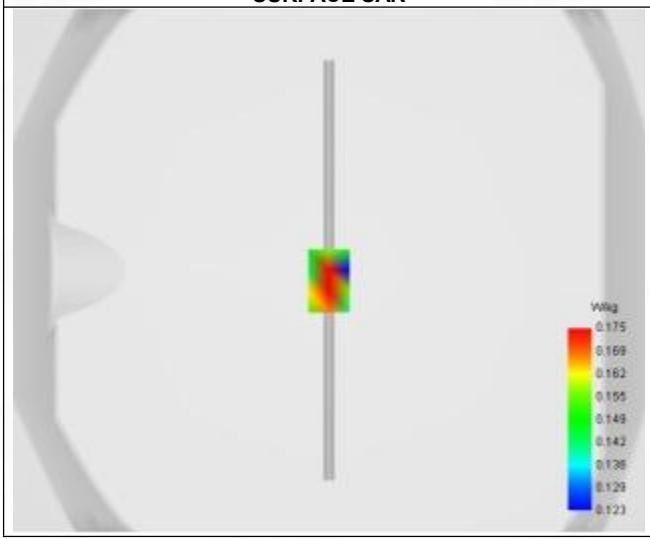
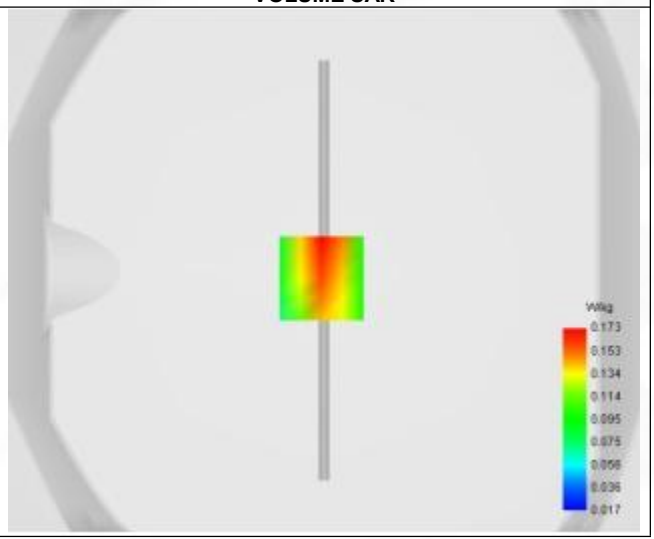
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW835
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	835.000
Relative permitivity (real part)	41.410
Relative permitivity (imaginary part)	19.490
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-3.00 ; SAR Peak: 0.26 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.106
SAR 1g (W/Kg)	0.163
Variation (%)	-3.390
Horizontal validation criteria: minimum distance (mm)	8.487
Vertical validation criteria: SAR ratio M2/M1 (%)	66.47%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.059	0.173	0.115	0.061	0.072

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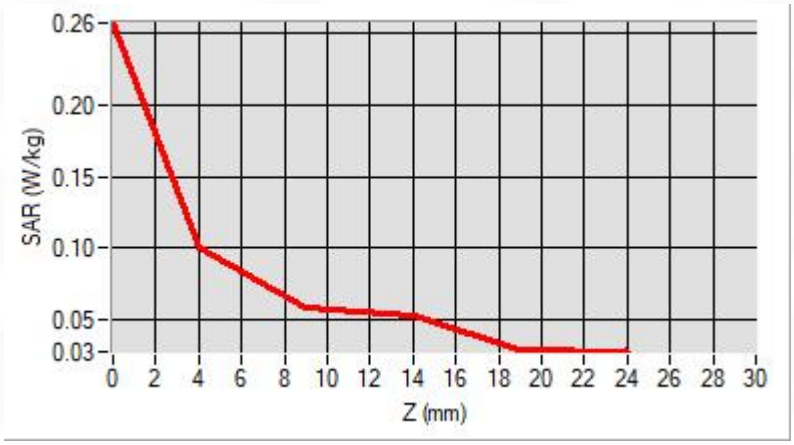
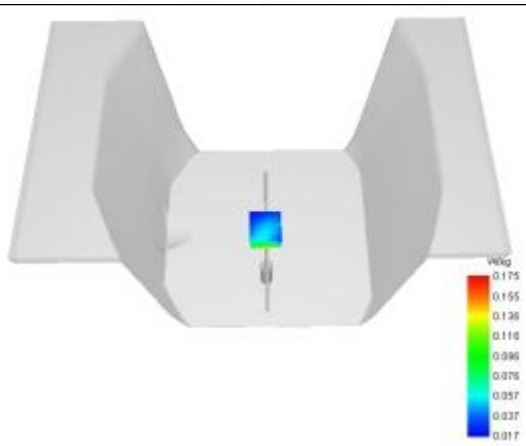
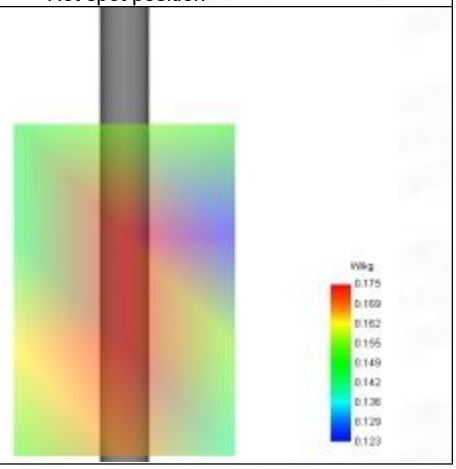


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1800 MHz)

System check at 1800 MHz

Date of measurement: 6/8/2024

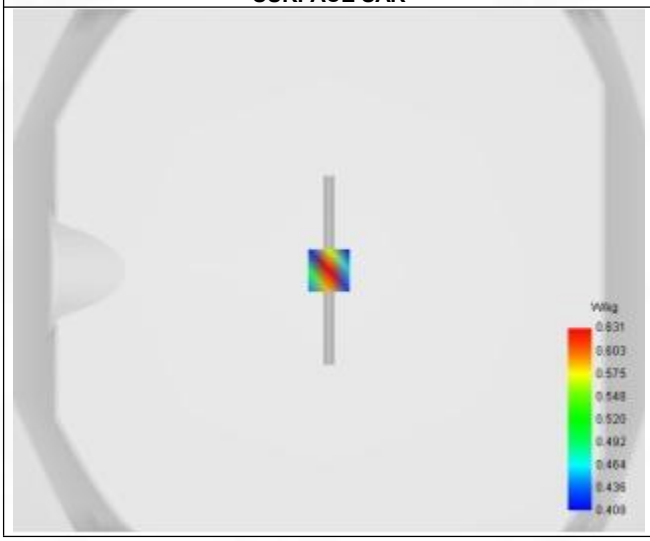
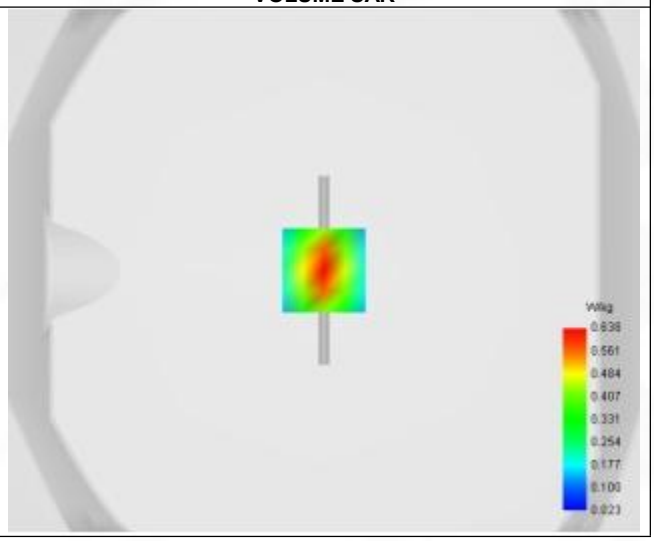
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.96
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1800.000
Relative permitivity (real part)	39.910
Relative permitivity (imaginary part)	14.090
Conductivity (S/m)	1.370

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.00 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.312
SAR 1g (W/Kg)	0.588
Variation (%)	-0.250
Horizontal validation criteria: minimum distance (mm)	8.698
Vertical validation criteria: SAR ratio M2/M1 (%)	55.80%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.003	0.638	0.356	0.204	0.127

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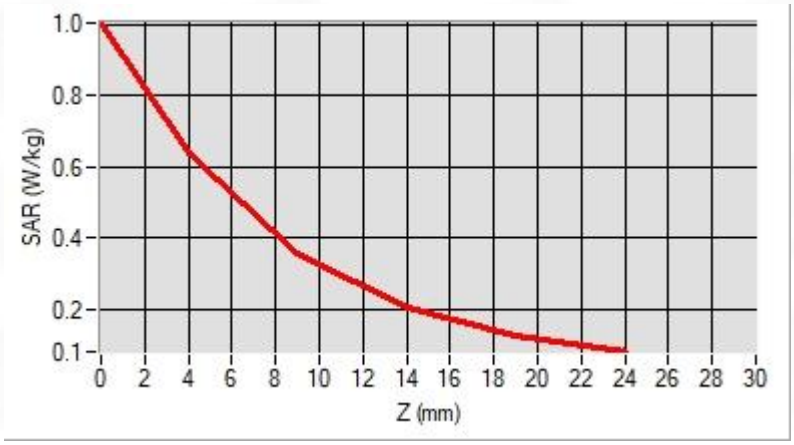
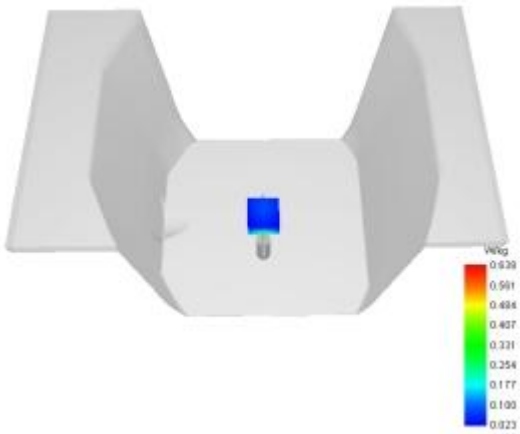
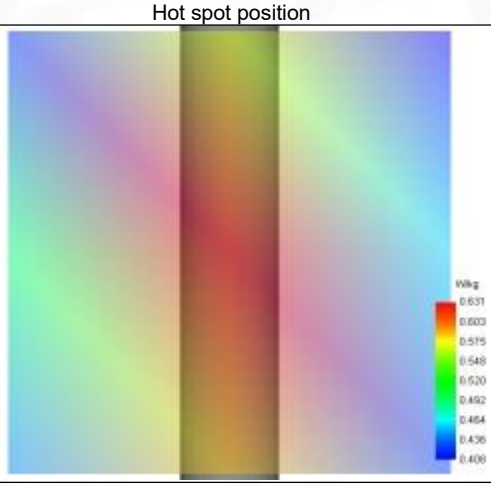


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (1900 MHz)

System check at 1900 MHz

Date of measurement: 7/8/2024

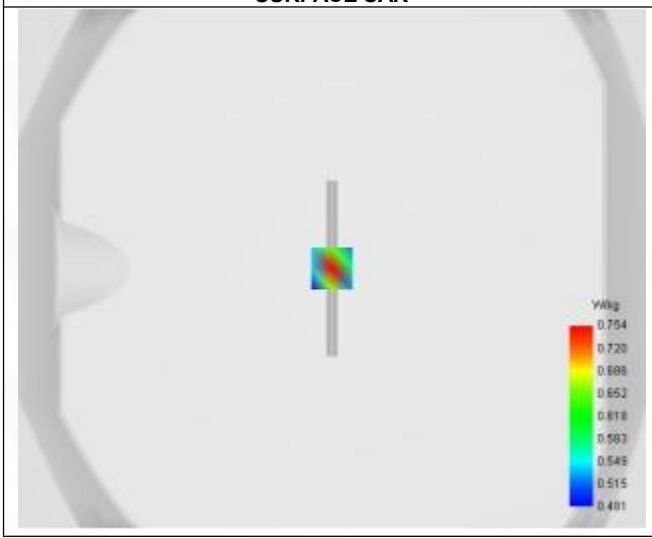
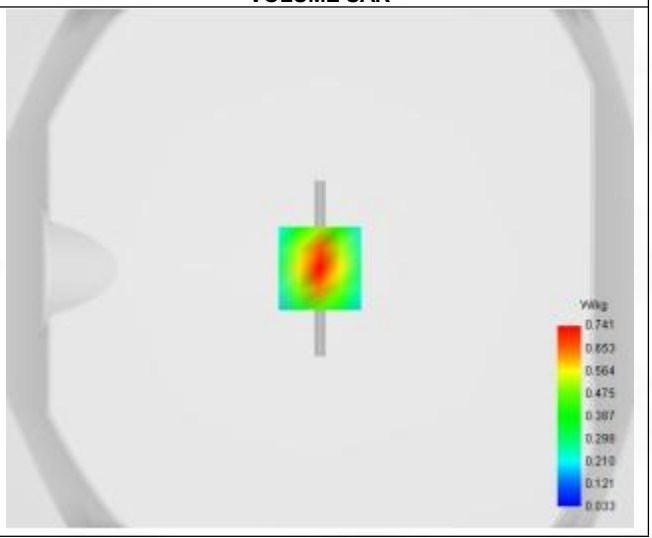
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW1900
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	1900.000
Relative permitivity (real part)	39.880
Relative permitivity (imaginary part)	13.380
Conductivity (S/m)	1.410

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.322
SAR 1g (W/Kg)	0.630
Variation (%)	-2.080
Horizontal validation criteria: minimum distance (mm)	8.699
Vertical validation criteria: SAR ratio M2/M1 (%)	52.96%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.201	0.759	0.402	0.239	0.156

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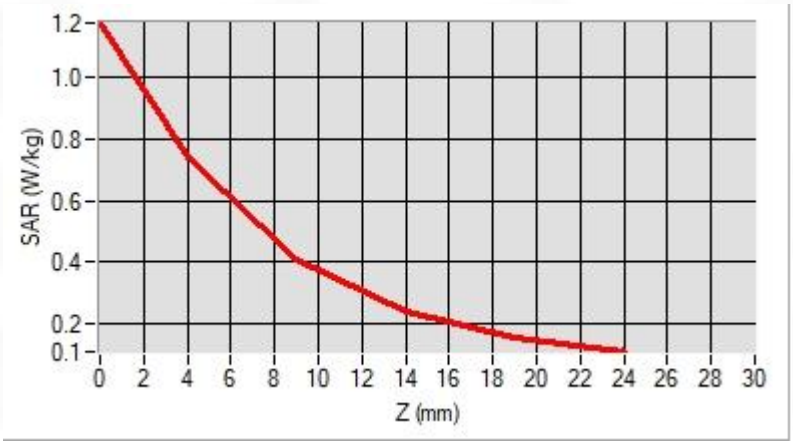
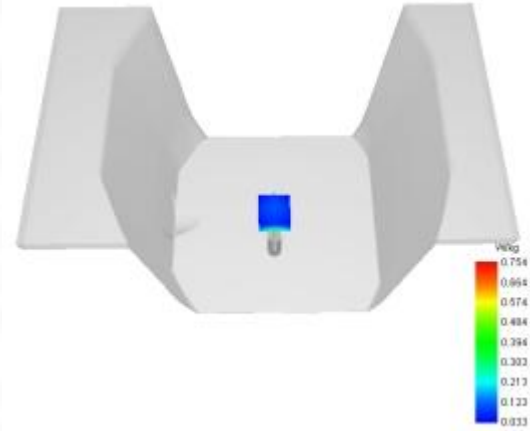
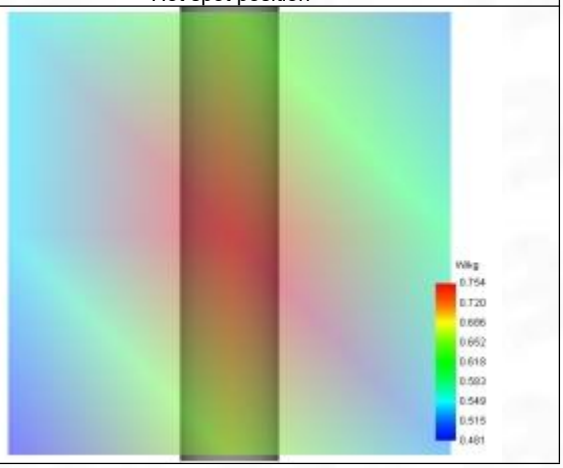


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2300 MHz)

System check at 2300 MHz

Date of measurement: 8/8/2024

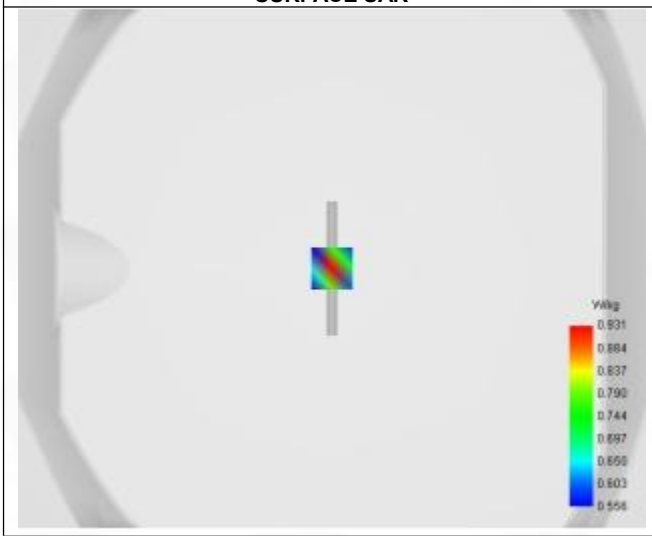
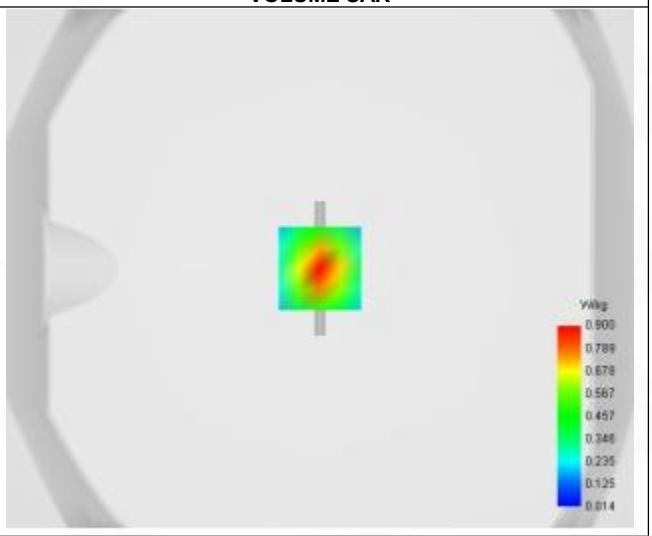
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2300
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2300.000
Relative permitivity (real part)	39.298
Relative permitivity (imaginary part)	13.351
Conductivity (S/m)	1.701

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.40 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.340
SAR 1g (W/Kg)	0.749
Variation (%)	-2.880
Horizontal validation criteria: minimum distance (mm)	8.474
Vertical validation criteria: SAR ratio M2/M1 (%)	53.00%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.400	0.900	0.477	0.261	0.150

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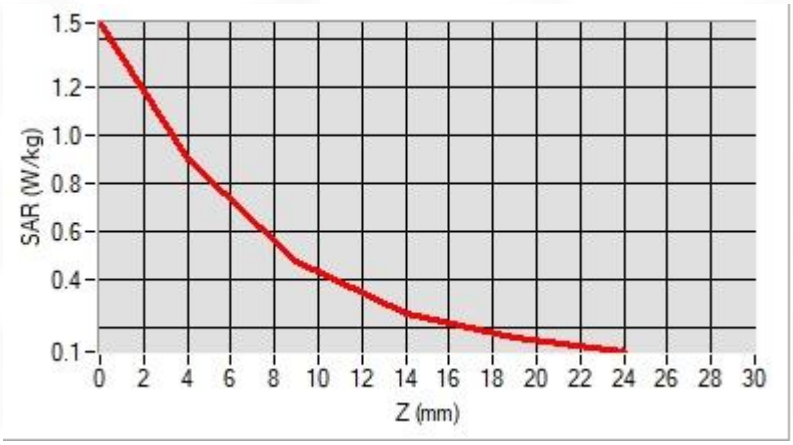
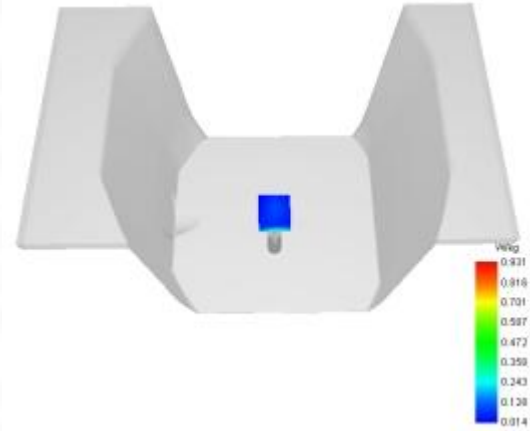
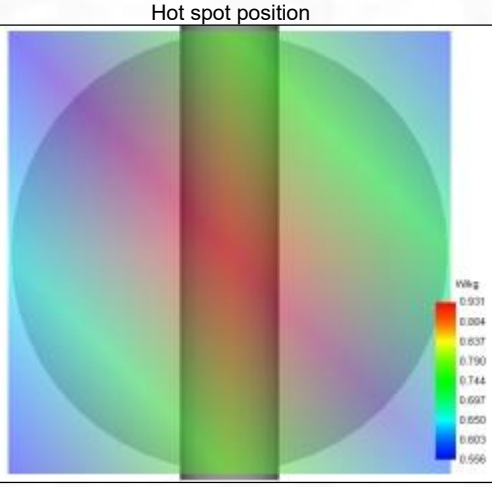


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2450 MHz)

System check at 2450 MHz

Date of measurement: 9/8/2024

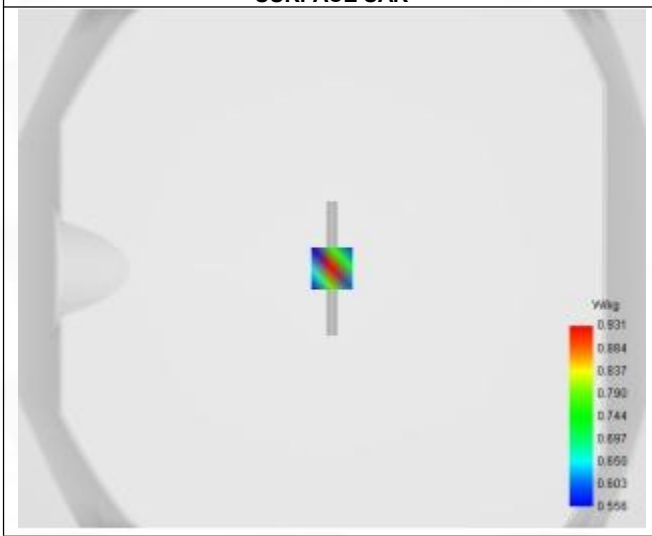
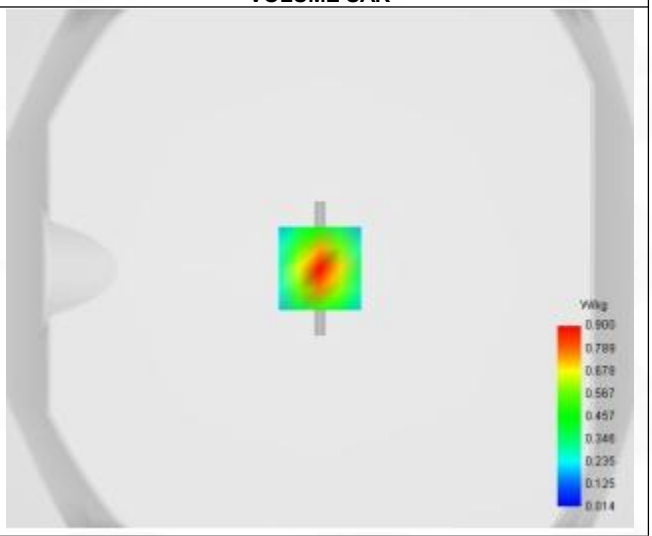
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2450
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2450.000
Relative permitivity (real part)	39.080
Relative permitivity (imaginary part)	13.340
Conductivity (S/m)	1.810

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 1.47 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.352
SAR 1g (W/Kg)	0.793
Variation (%)	-2.570
Horizontal validation criteria: minimum distance (mm)	9.787
Vertical validation criteria: SAR ratio M2/M1 (%)	53.00%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.466	0.900	0.477	0.261	0.158

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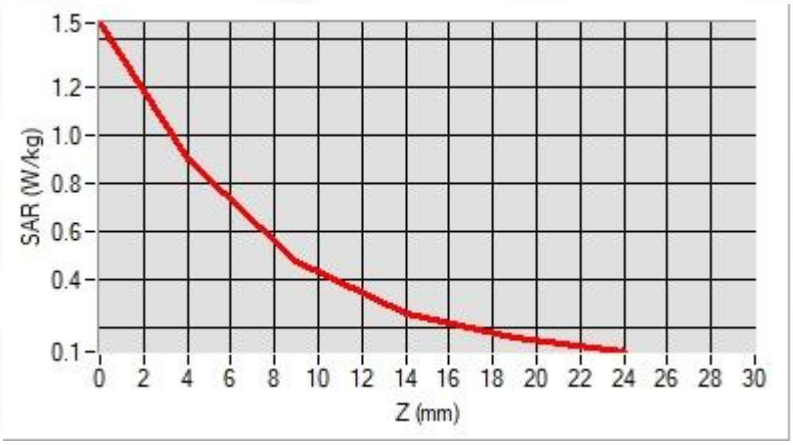
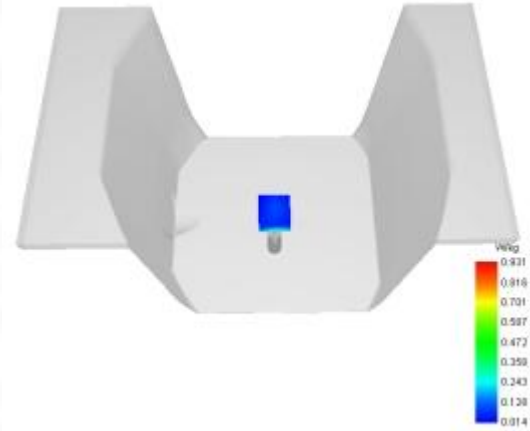
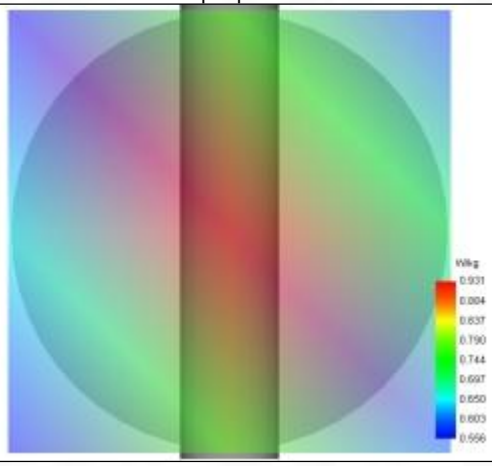


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (2600 MHz)

System check at 2600 MHz

Date of measurement: 12/8/2024

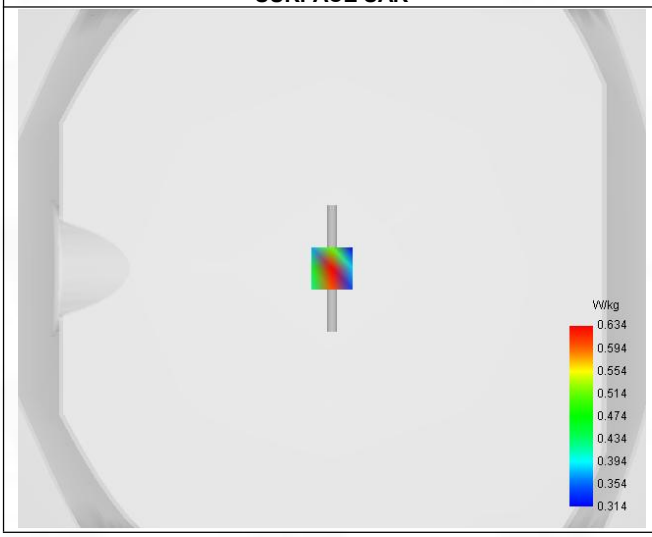
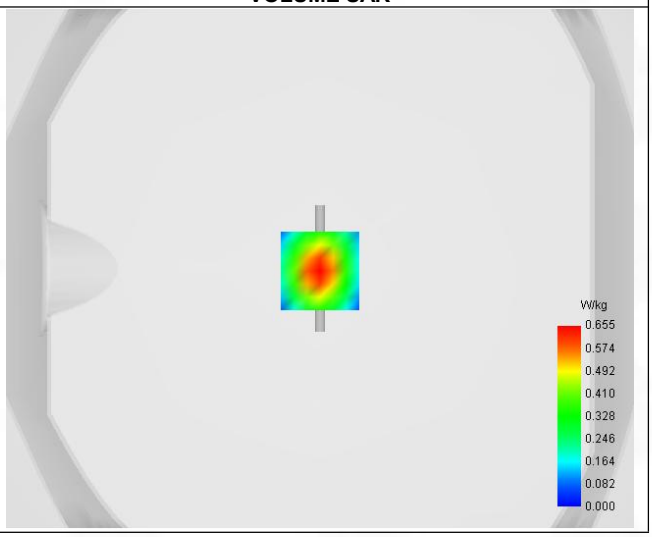
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW2600
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	2600.000
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=-1.00 ; SAR Peak: 1.02 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.421
SAR 1g (W/Kg)	0.866
Variation (%)	2.980
Horizontal validation criteria: minimum distance (mm)	8.298
Vertical validation criteria: SAR ratio M2/M1 (%)	54.81%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.020	0.655	0.359	0.187	0.091

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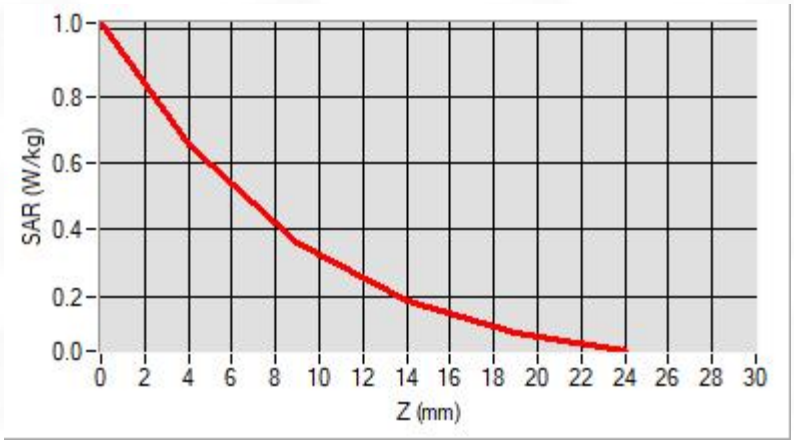
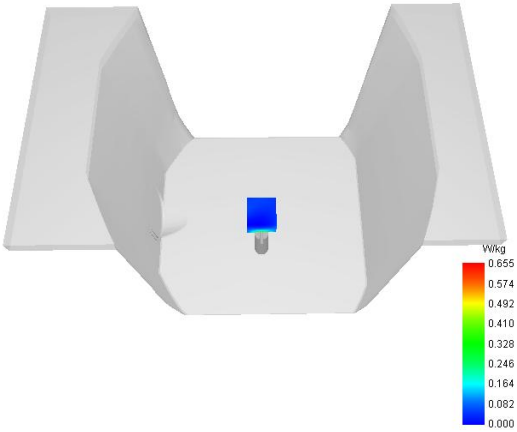
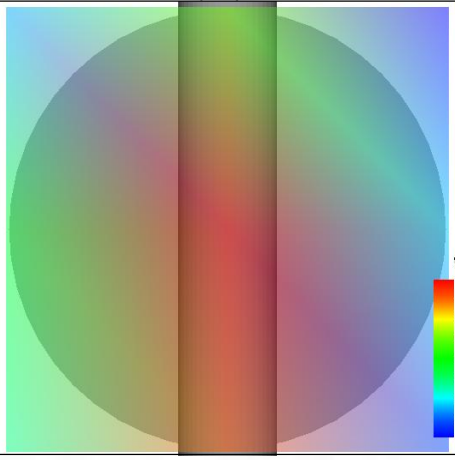


F. 3D Image

3D screen shot	Hot spot position
	

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System Performance Check Data (5200 MHz)

System check at 5200 MHz

Date of measurement: 13/8/2024

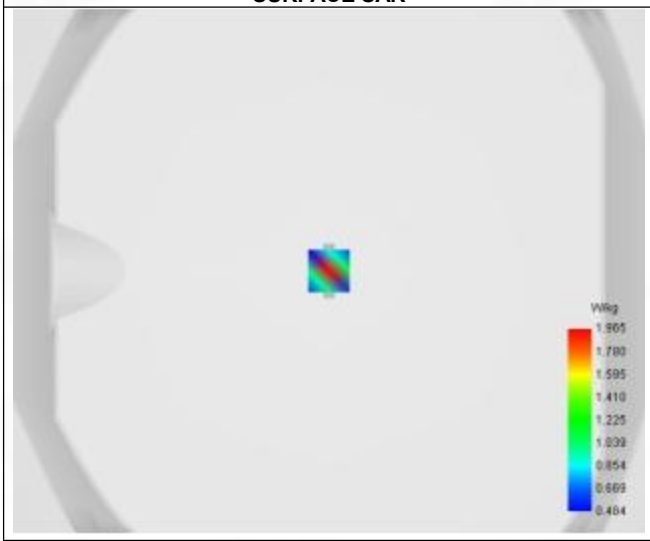
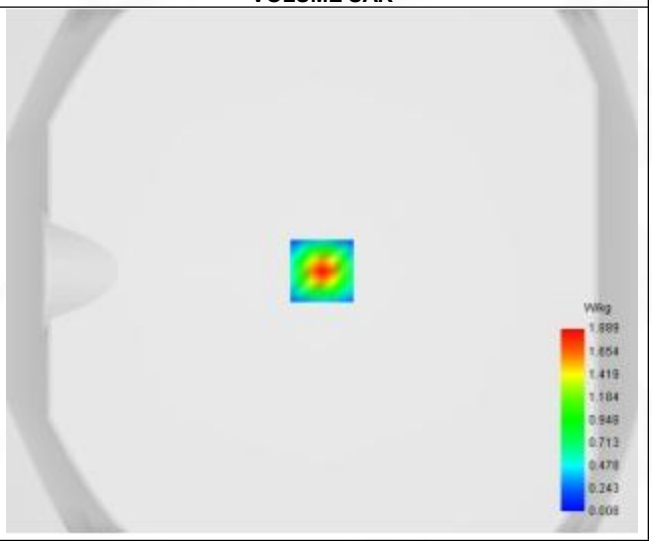
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5200
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5200.000
Relative permitivity (real part)	35.880
Relative permitivity (imaginary part)	16.250
Conductivity (S/m)	4.700

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 3.38 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.288
SAR 1g (W/Kg)	1.019
Variation (%)	-3.400
Horizontal validation criteria: minimum distance (mm)	6.284
Vertical validation criteria: SAR ratio M2/M1 (%)	54.05

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.268	1.889	1.021	0.523	0.266	0.142	0.085	0.060	0.052

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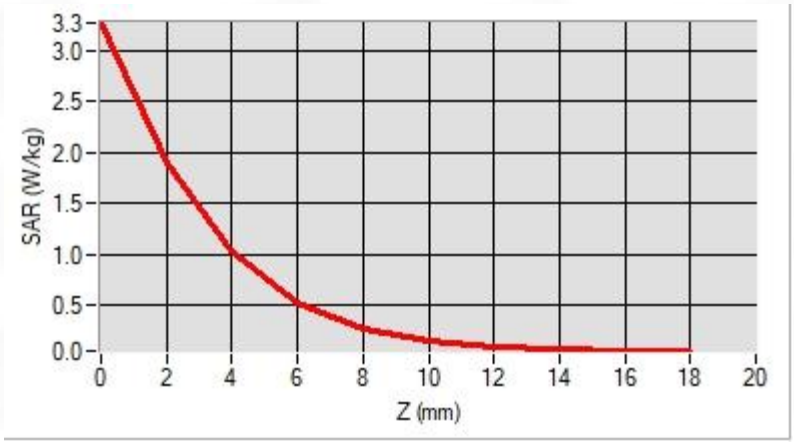
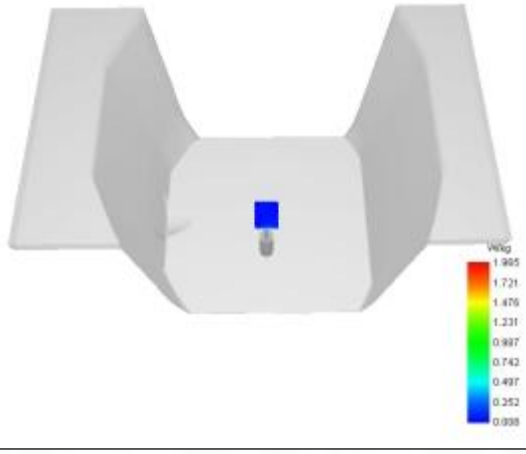
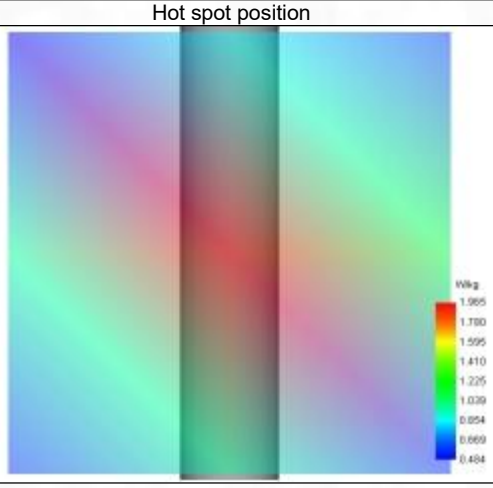


F. 3D Image

3D screen shot	Hot spot position
	

System Performance Check Data (5800 MHz)

System check at 5800 MHz

Date of measurement: 13/8/2024

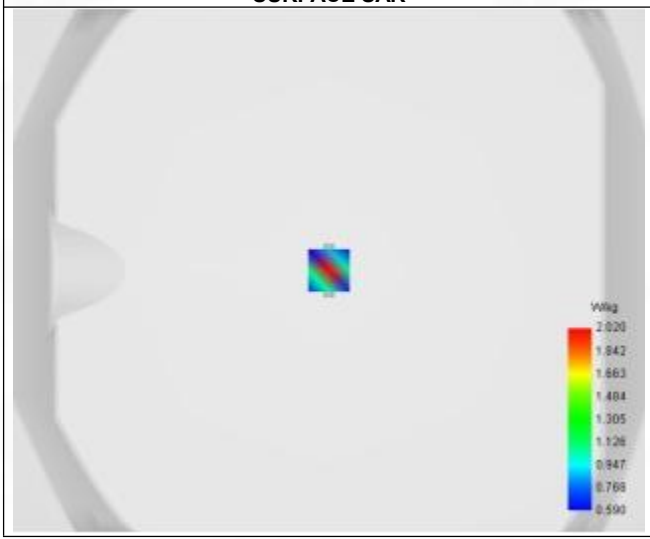
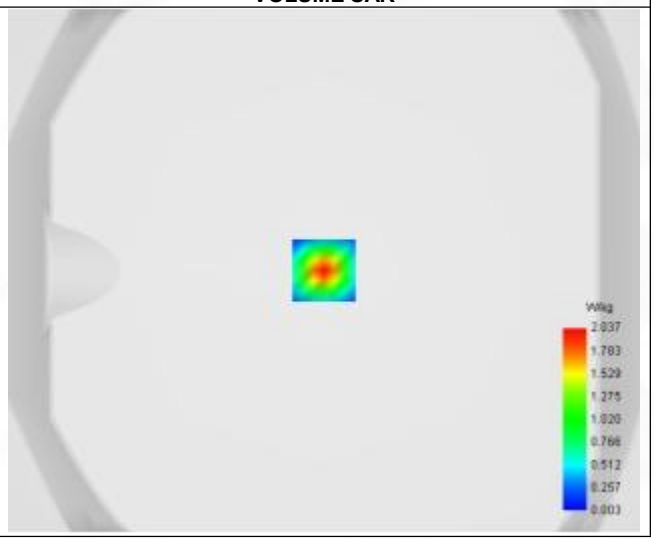
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Dipole
Band	CW5800
Channels	Middle
Signal	CW

B. Permitivity

Frequency (MHz)	5800.000
Relative permitivity (real part)	35.180
Relative permitivity (imaginary part)	16.480
Conductivity (S/m)	5.310

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=0.00 ; SAR Peak: 4.17 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.277
SAR 1g (W/Kg)	0.981
Variation (%)	0.490
Horizontal validation criteria: minimum distance (mm)	7.454
Vertical validation criteria: SAR ratio M2/M1 (%)	44.92%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	3.948	2.037	0.915	0.361	0.135	0.055	0.033	0.037	0.059

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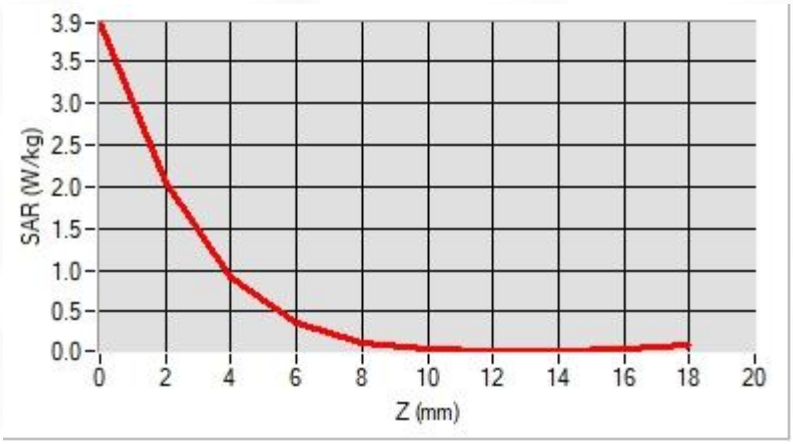
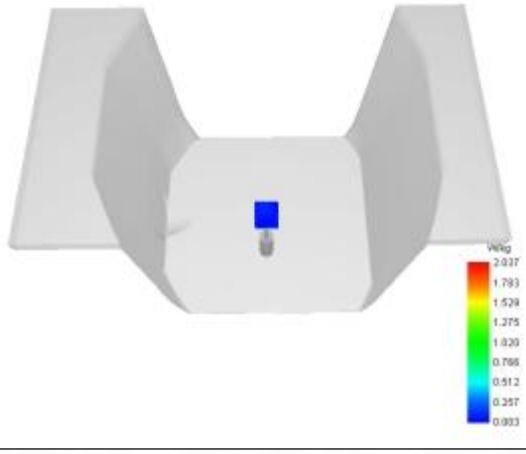
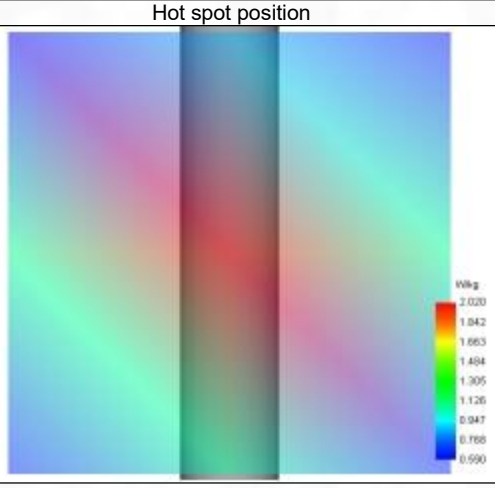


F. 3D Image

3D screen shot	Hot spot position
	

ANNEX D Test Data

1-Head with front position in dist. 0mm on Channel 251 in GSM850 voice

SAR Measurement at GSM850 (Cheek, Right)

Date of measurement: 2/8/2024

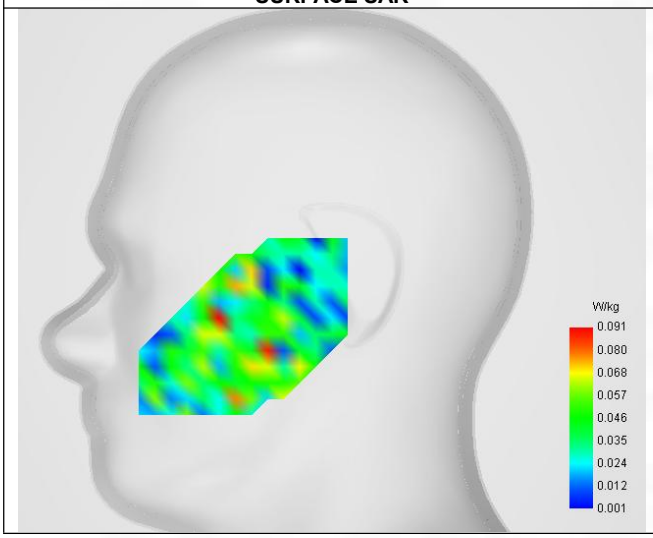
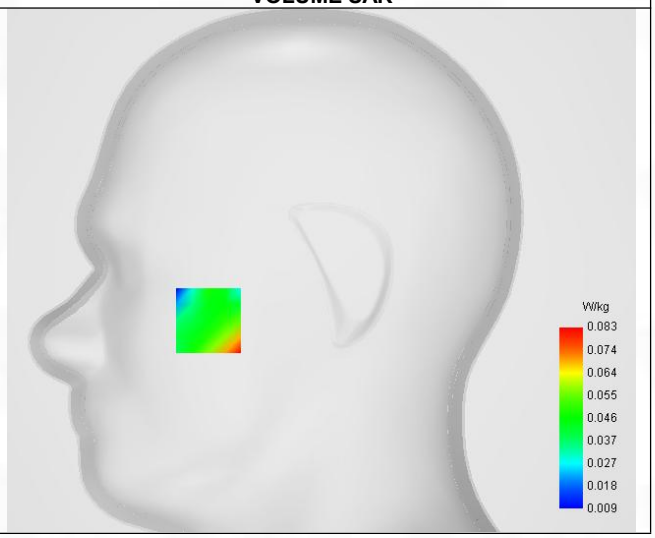
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	GSM850
Channels	Higher (251)
Signal	TDMA (GSM)
Modulation	GMSK

B. Permitivity

Frequency (MHz)	848.800
Relative permitivity (real part)	41.389
Relative permitivity (imaginary part)	19.413
Conductivity (S/m)	0.877

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-56.00, Y=-25.00 ; SAR Peak: 0.16 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.050
SAR 1g (W/Kg)	0.078
Variation (%)	2.790
Horizontal validation criteria: minimum distance (mm)	8.625
Vertical validation criteria: SAR ratio M2/M1 (%)	48.19%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.007	0.083	0.040	0.019	0.054

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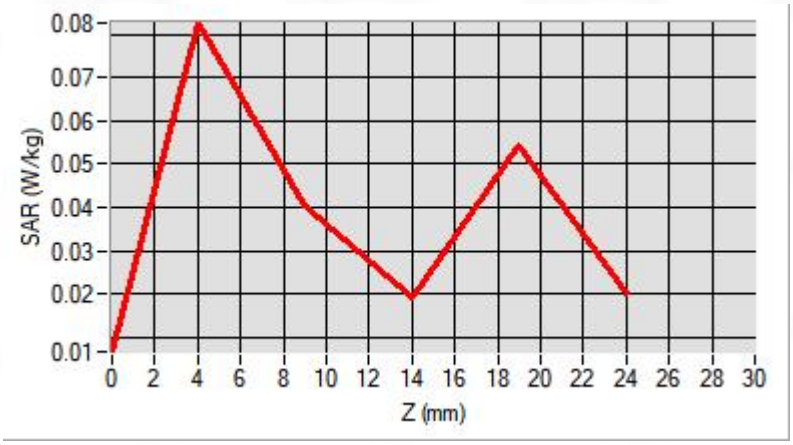
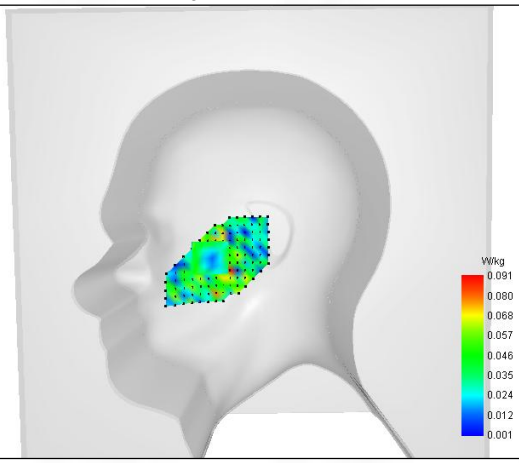
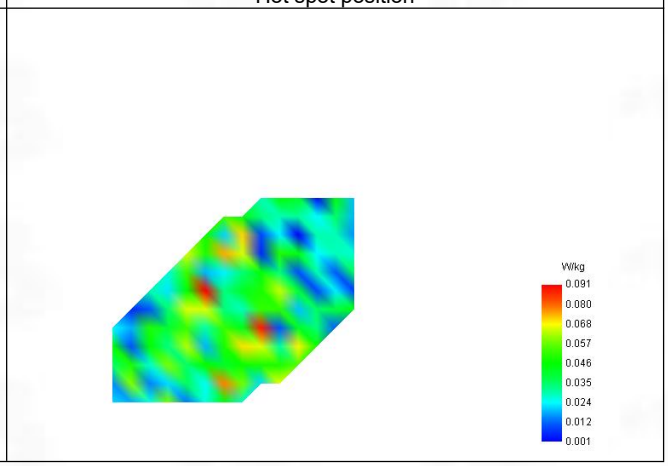


F. 3D Image

3D screen shot	Hot spot position
	

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2-Body with back position in dist. 10mm on Channel 251 in GPRS850+2slots

SAR Measurement at GPRS850 (Body, Validation Plane)

Date of measurement: 2/8/2024

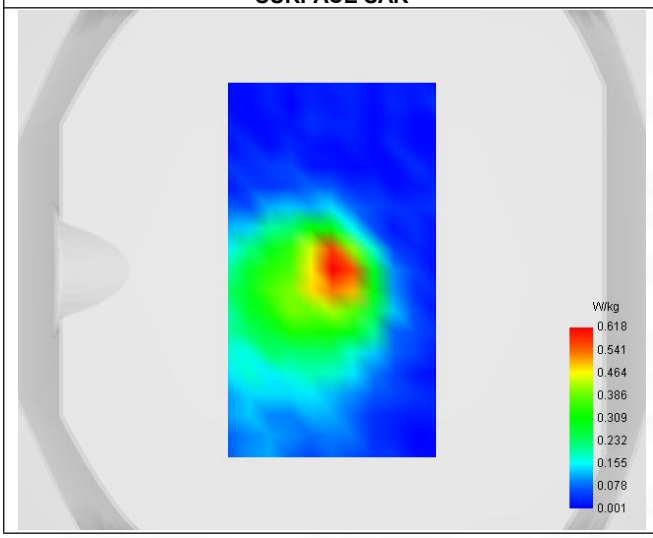
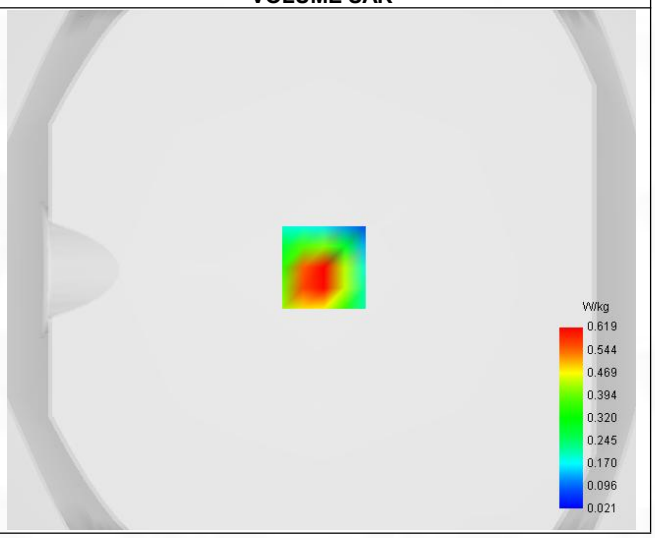
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	GPRS850
Channels	Higher (251)
Signal	TDMA (GPRS)
Modulation	GMSK (CS-1)
TX-slots	2

B. Permitivity

Frequency (MHz)	848.800
Relative permitivity (real part)	41.389
Relative permitivity (imaginary part)	19.413
Conductivity (S/m)	0.877

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=1.00, Y=1.00 ; SAR Peak: 0.98 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.345
SAR 1g (W/Kg)	0.603
Variation (%)	-3.770
Horizontal validation criteria: minimum distance (mm)	9.214
Vertical validation criteria: SAR ratio M2/M1 (%)	58.00%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.947	0.619	0.359	0.216	0.140

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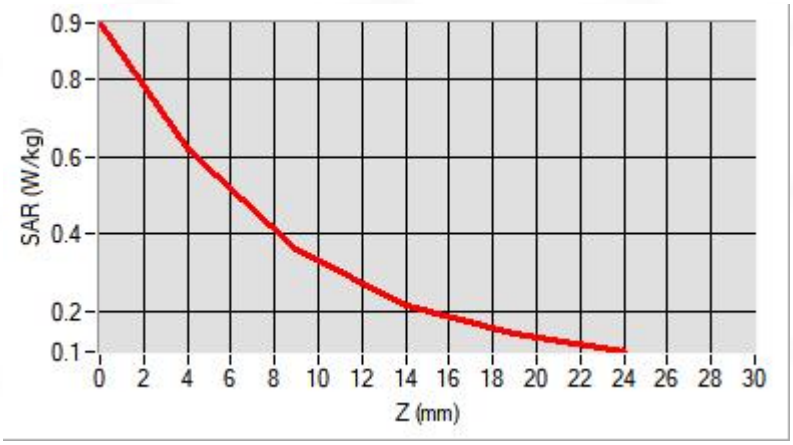
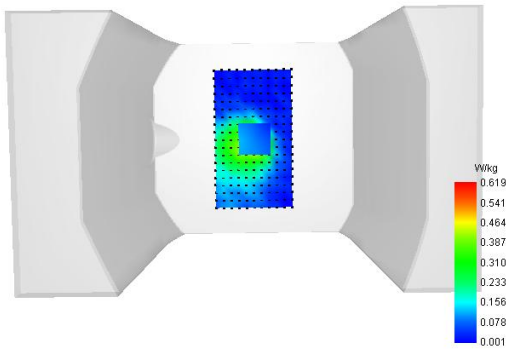
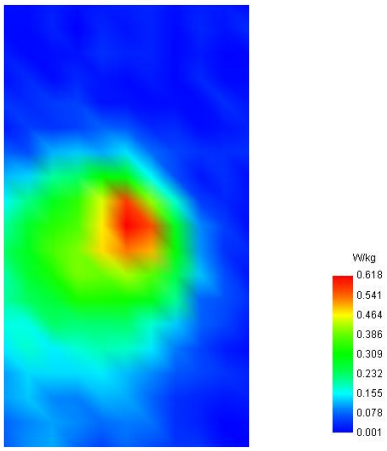


F. 3D Image

3D screen shot	Hot spot position
	

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3-Head with front position in dist. 0mm on Channel 810 in GSM1900 voice

SAR Measurement at GSM1900 (Cheek, Right)

Date of measurement: 7/8/2024

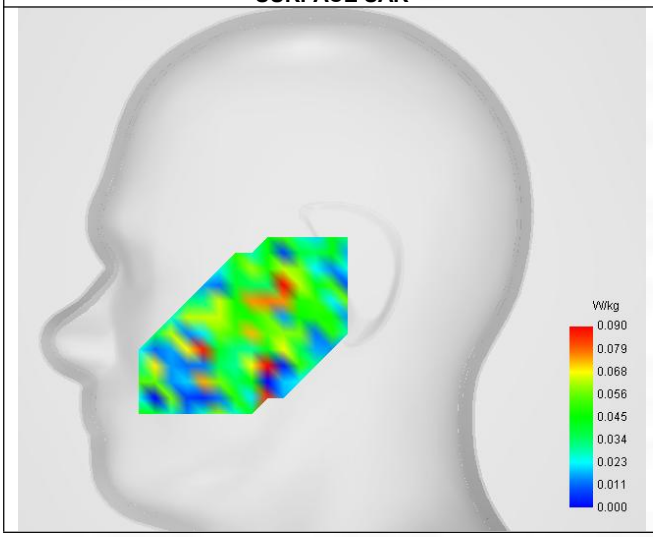
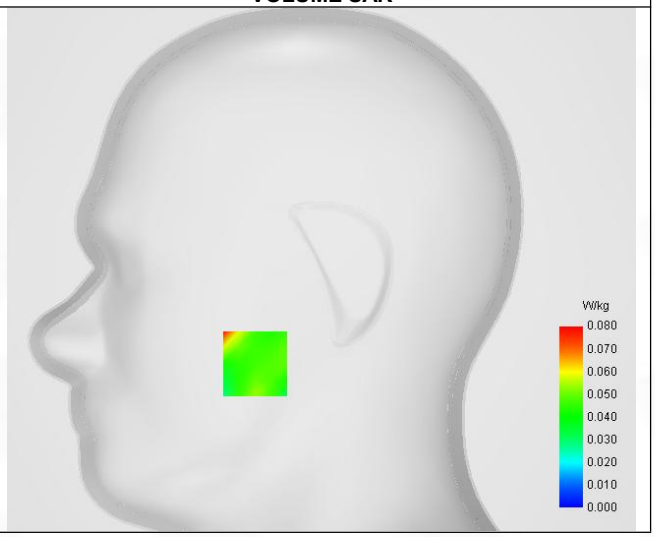
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	GSM1900
Channels	Higher (810)
Signal	TDMA (GSM)
Modulation	GMSK

B. Permitivity

Frequency (MHz)	1909.800
Relative permitivity (real part)	39.866
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.417

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-33.00, Y=-47.00 ; SAR Peak: 0.21 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.046
SAR 1g (W/Kg)	0.080
Variation (%)	1.870
Horizontal validation criteria: minimum distance (mm)	8.322
Vertical validation criteria: SAR ratio M2/M1 (%)	42.50%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.230	0.080	0.034	0.016	0.011

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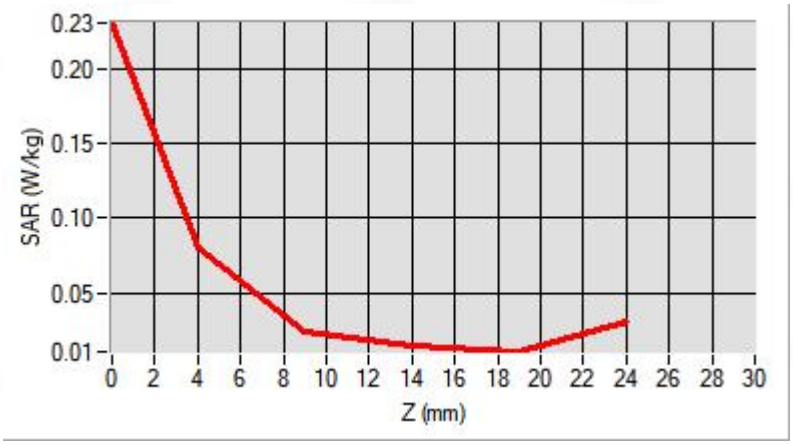
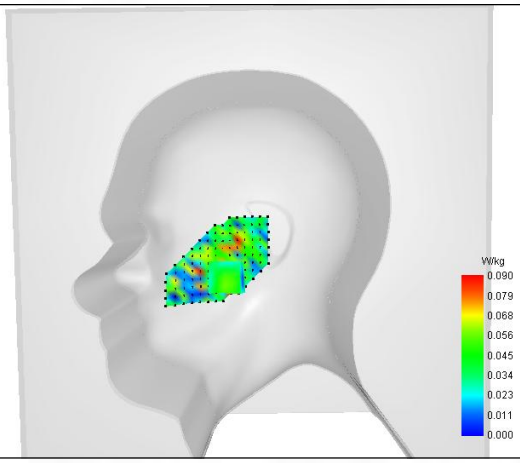
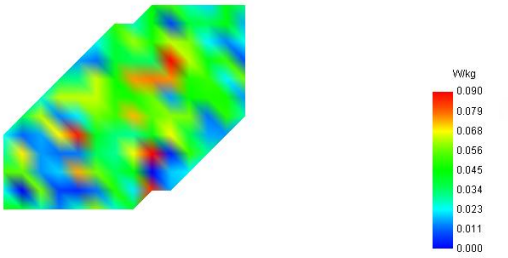


F. 3D Image

3D screen shot	Hot spot position
	

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4-Body with back position in dist. 10mm on Channel 810 in GPRS1900+4slots

SAR Measurement at GPRS1900 (Body, Validation Plane)

Date of measurement: 7/8/2024

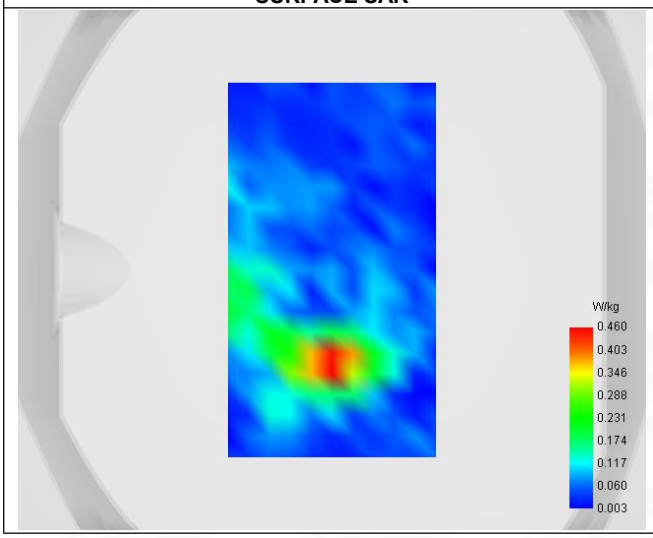
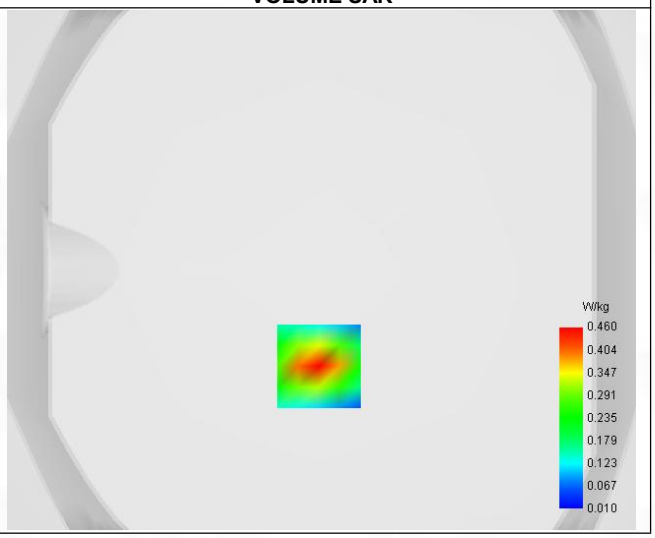
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	GPRS1900
Channels	Higher (810)
Signal	TDMA (GPRS)
Modulation	GMSK (CS-1)
TX-slots	4

B. Permitivity

Frequency (MHz)	1909.800
Relative permitivity (real part)	39.866
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.417

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=-37.00 ; SAR Peak: 0.59 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.254
SAR 1g (W/Kg)	0.456
Variation (%)	2.650
Horizontal validation criteria: minimum distance (mm)	8.565
Vertical validation criteria: SAR ratio M2/M1 (%)	65.43%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.581	0.460	0.301	0.225	0.141

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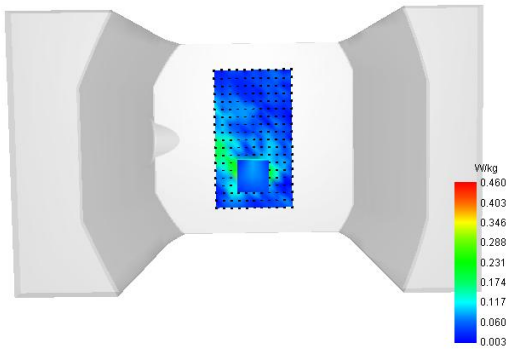
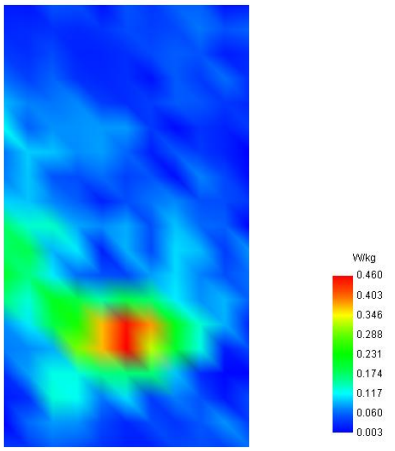
F. 3D Image

3D screen shot	Hot spot position
	

5-Head with front position in dist. 0mm on Channel 9538 in WCDMA Band 2

SAR Measurement at Band 2 (1900) (Cheek, Right)

Date of measurement: 7/8/2024

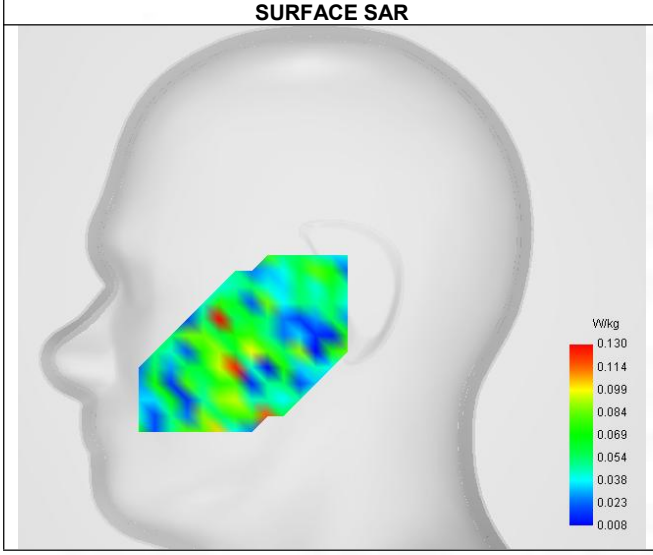
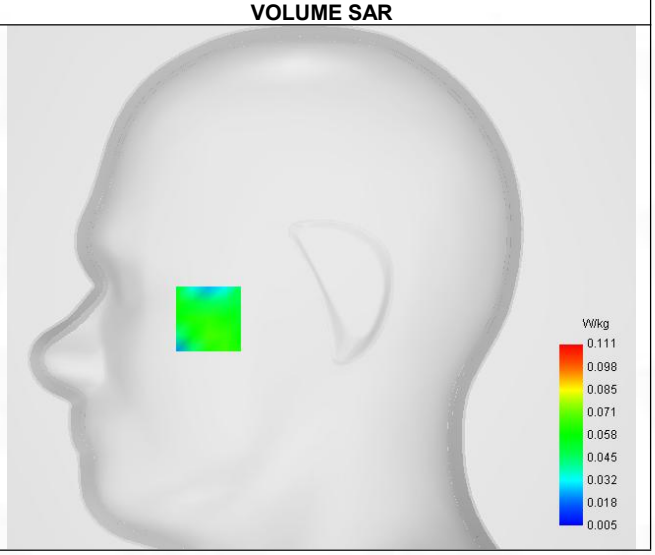
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	Band 2 (1900)
Channels	Higher (9538)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1907.600
Relative permitivity (real part)	39.869
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.416

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-56.00, Y=-16.00 ; SAR Peak: 0.13 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.065
SAR 1g (W/Kg)	0.083
Variation (%)	-3.610
Horizontal validation criteria: minimum distance (mm)	9.288
Vertical validation criteria: SAR ratio M2/M1 (%)	51.35%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.181	0.111	0.057	0.037	0.026

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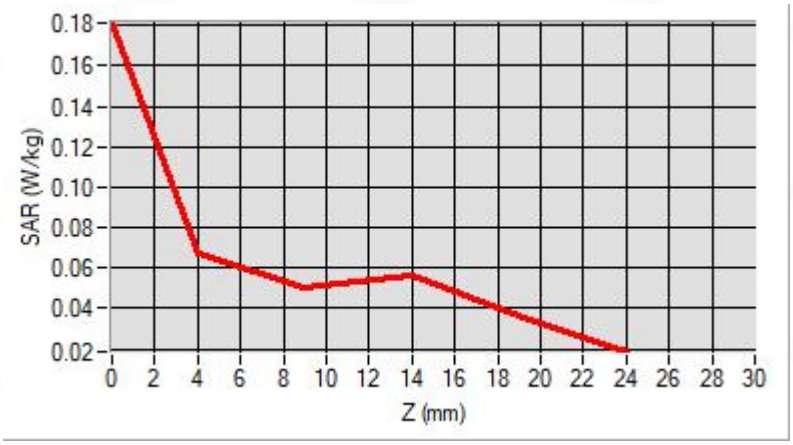
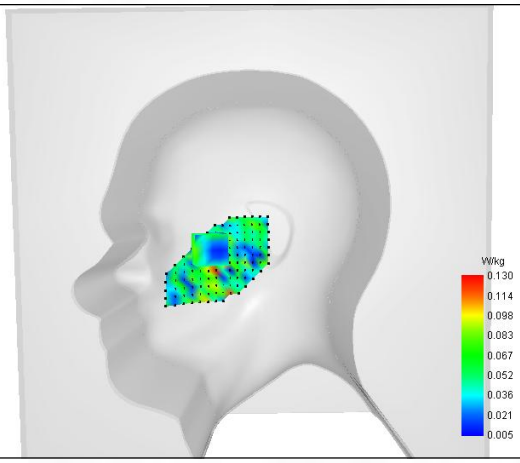
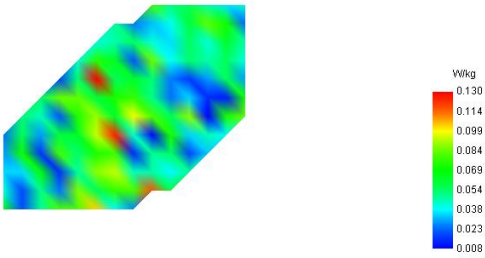


F. 3D Image

3D screen shot	Hot spot position
	

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6-Body with back position in dist. 10mm on Channel 9538 in WCDMA Band 2

SAR Measurement at Band 2 (1900) (Body, Validation Plane)

Date of measurement: 7/8/2024

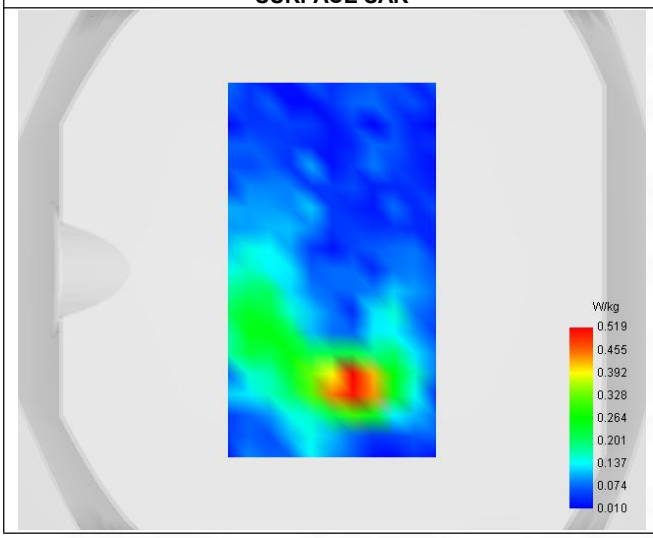
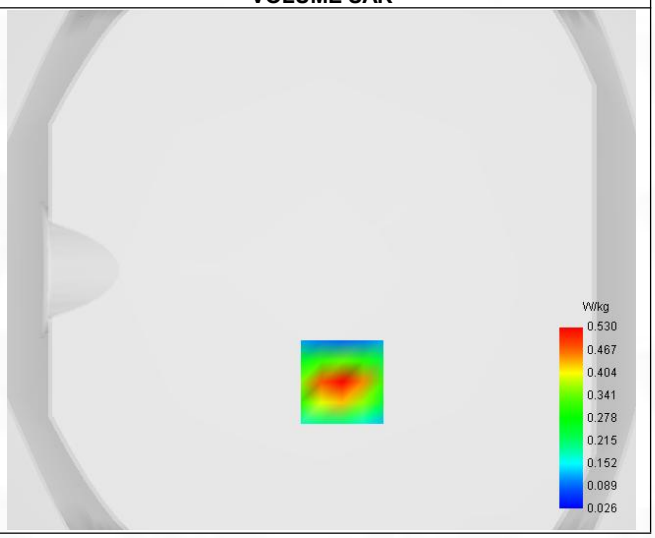
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 2 (1900)
Channels	Higher (9538)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	1907.600
Relative permitivity (real part)	39.869
Relative permitivity (imaginary part)	13.379
Conductivity (S/m)	1.416

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=8.00, Y=-43.00 ; SAR Peak: 0.80 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.286
SAR 1g (W/Kg)	0.531
Variation (%)	-0.500
Horizontal validation criteria: minimum distance (mm)	9.269
Vertical validation criteria: SAR ratio M2/M1 (%)	60.57%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.792	0.530	0.321	0.204	0.142

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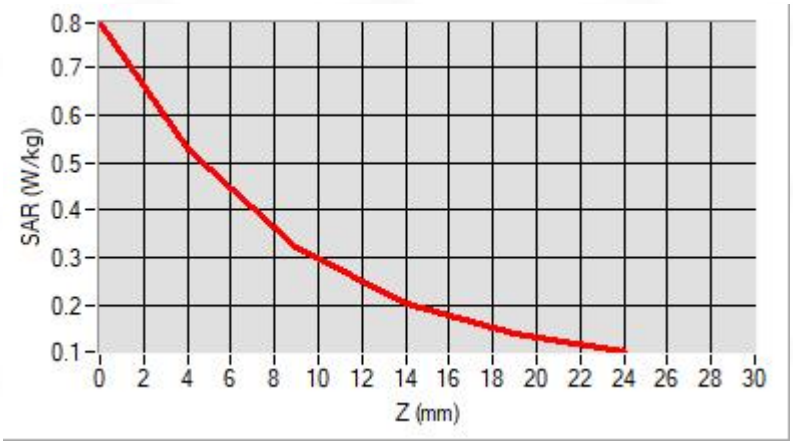
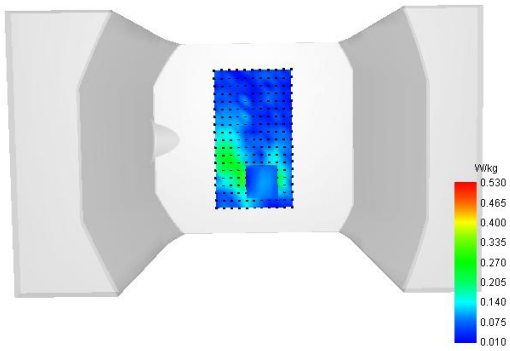
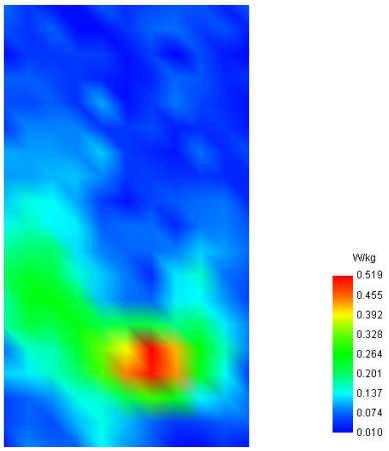


F. 3D Image

3D screen shot	Hot spot position
	

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7-Head with front position in dist. 0mm on Channel 4132 in WCDMA Band 5

SAR Measurement at Band 5 (850) (Cheek, Right)

Date of measurement: 5/8/2024

A. Experimental conditions.

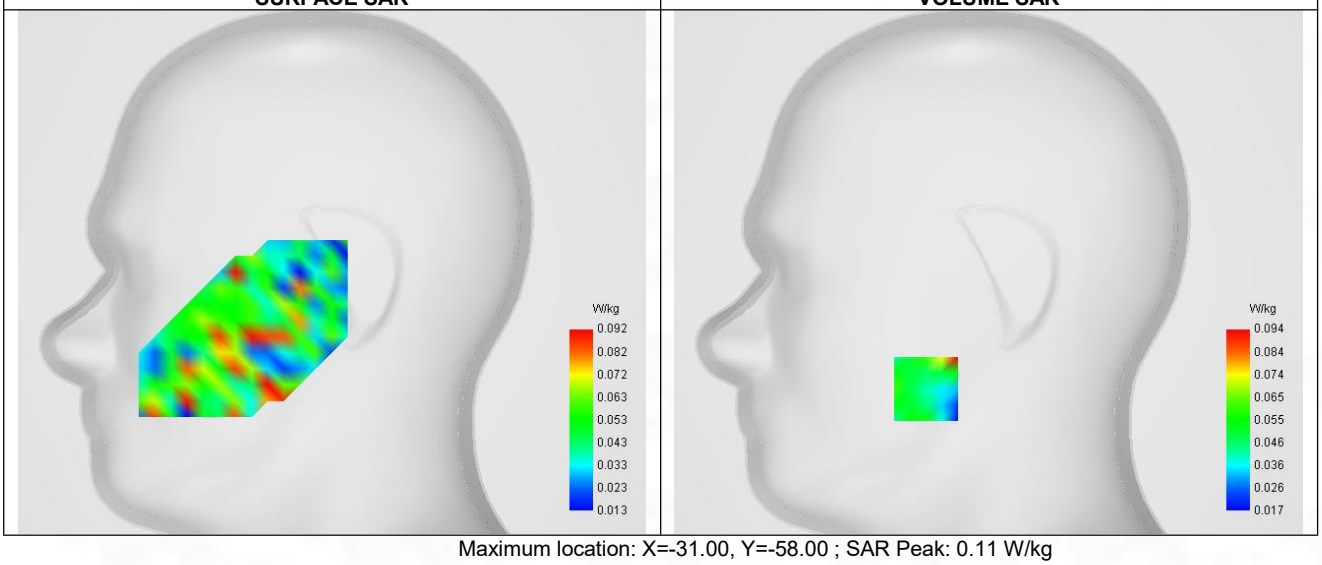
Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	Band 5 (850)
Channels	Lower (4132)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	826.400
Relative permitivity (real part)	41.449
Relative permitivity (imaginary part)	19.689
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR



Maximum location: X=-31.00, Y=-58.00 ; SAR Peak: 0.11 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.061
SAR 1g (W/Kg)	0.081
Variation (%)	-1.060
Horizontal validation criteria: minimum distance (mm)	9.631
Vertical validation criteria: SAR ratio M2/M1 (%)	67.02%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.260	0.094	0.063	0.077	0.069

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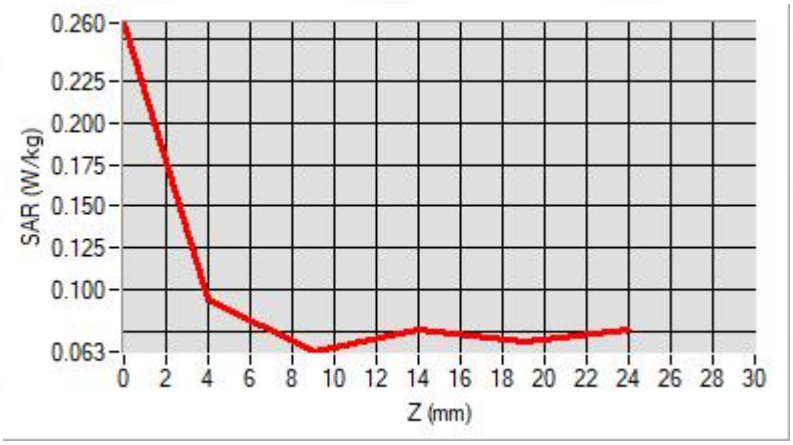
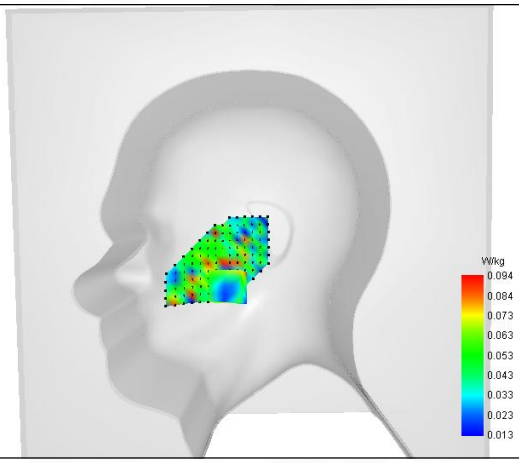
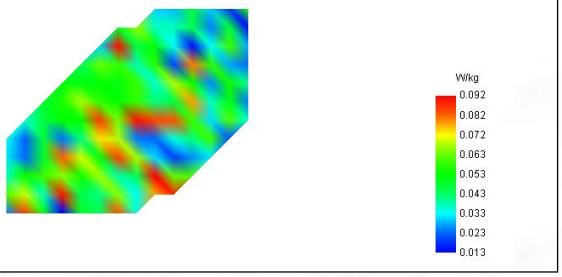


F. 3D Image

3D screen shot	Hot spot position
	

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8-Body with back position in dist. 10mm on Channel 4132 in WCDMA Band 5

SAR Measurement at Band 5 (850) (Body, Validation Plane)

Date of measurement: 5/8/2024

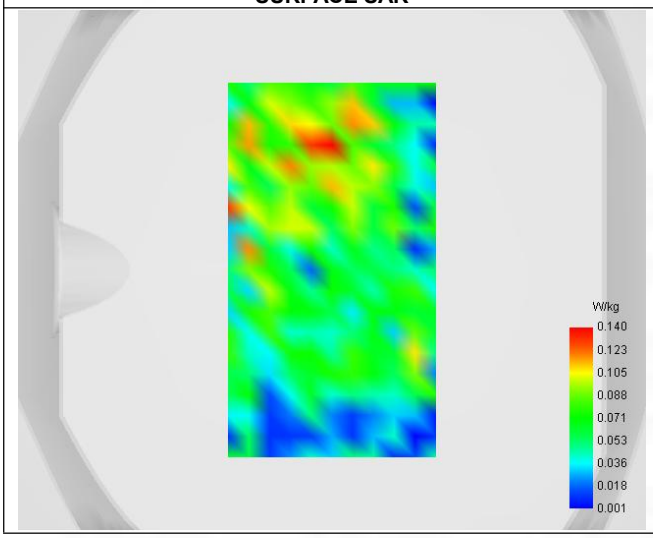
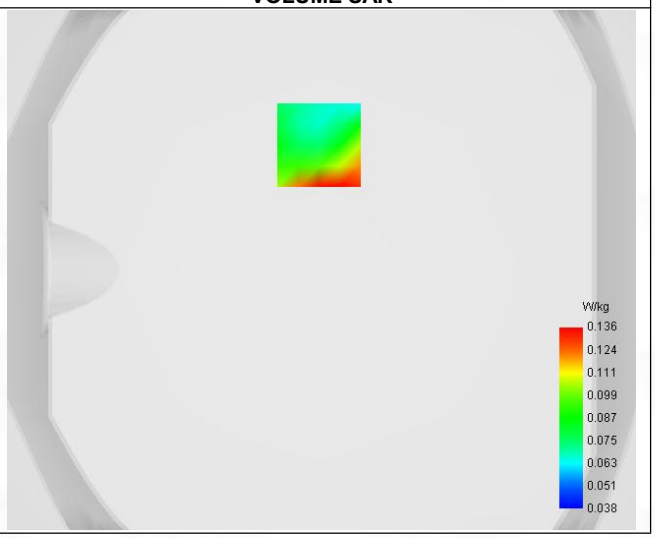
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	Band 5 (850)
Channels	Lower (4132)
Signal	WCDMA
Mode	Release 99
Connection Type	RMC, 12.2 kbps

B. Permitivity

Frequency (MHz)	826.400
Relative permitivity (real part)	41.449
Relative permitivity (imaginary part)	19.689
Conductivity (S/m)	0.869

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-1.00, Y=48.00 ; SAR Peak: 0.21 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.112
SAR 1g (W/Kg)	0.140
Variation (%)	-3.160
Horizontal validation criteria: minimum distance (mm)	9.547
Vertical validation criteria: SAR ratio M2/M1 (%)	46.32%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.466	0.136	0.063	0.081	0.062

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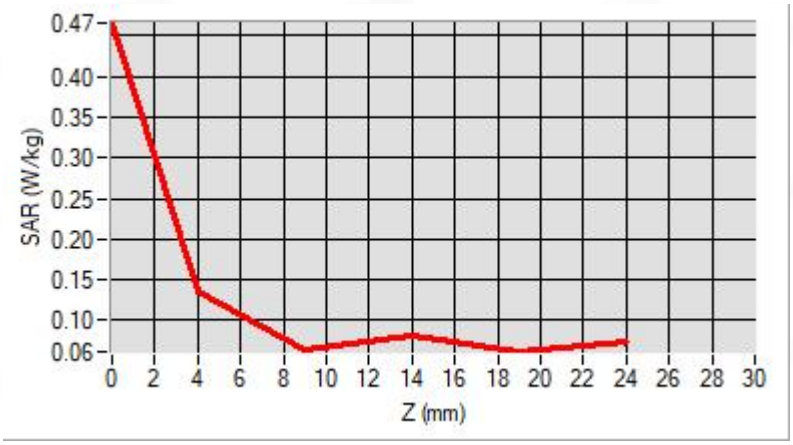
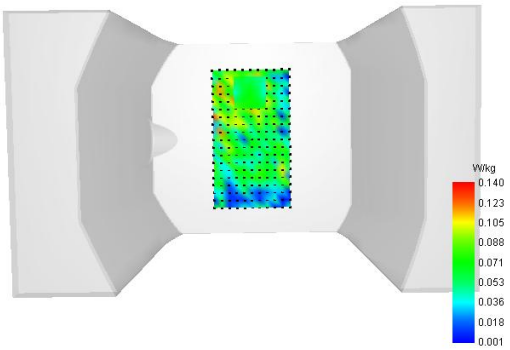
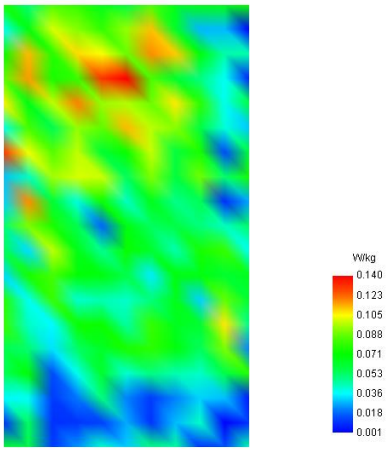


F. 3D Image

3D screen shot	Hot spot position
	

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9-Head with front position in dist. 0mm on Channel 18700 in LTE band 2

SAR Measurement at LTE band 2 (Cheek, Right)

Date of measurement: 6/8/2024

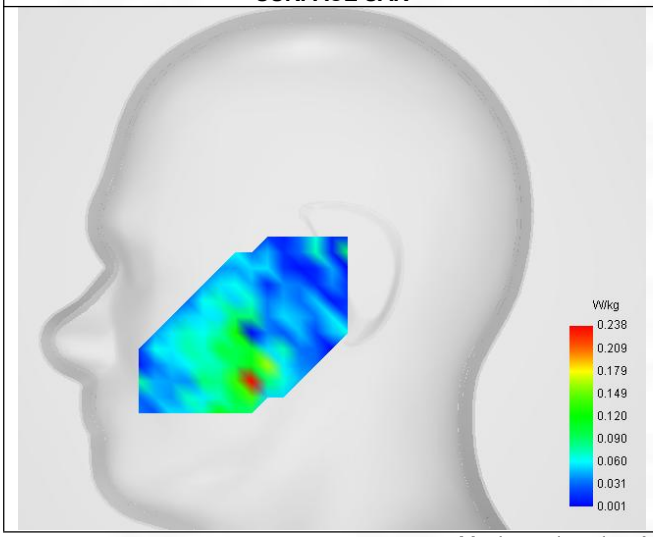
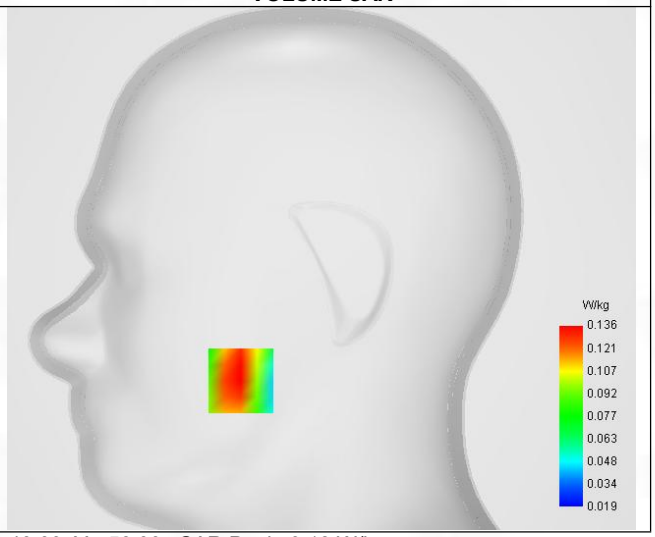
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 2
Channels	Lower (18700)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	1859.910
Relative permitivity (real part)	39.892
Relative permitivity (imaginary part)	13.665
Conductivity (S/m)	1.394

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-40.00, Y=-56.00 ; SAR Peak: 0.18 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.101
SAR 1g (W/Kg)	0.142
Variation (%)	-4.810
Horizontal validation criteria: minimum distance (mm)	9.855
Vertical validation criteria: SAR ratio M2/M1 (%)	73.53%

E. Z Axis Scan

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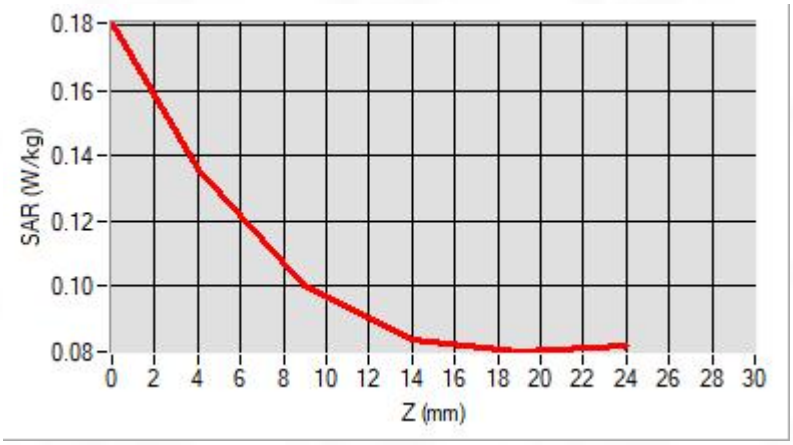
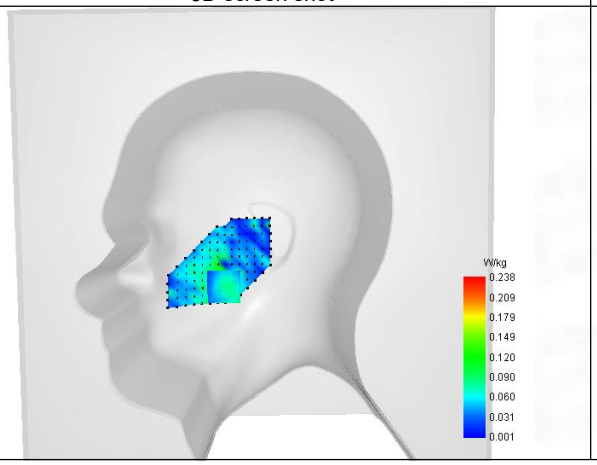
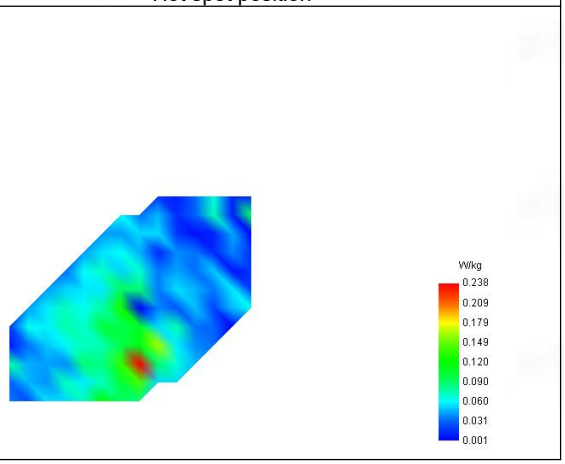
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.181	0.136	0.100	0.084	0.080



F. 3D Image

3D screen shot	Hot spot position
	

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10-Body with back position in dist. 10mm on Channel 18700 in LTE band 2

SAR Measurement at LTE band 2 (Body, Validation Plane)

Date of measurement: 6/8/2024

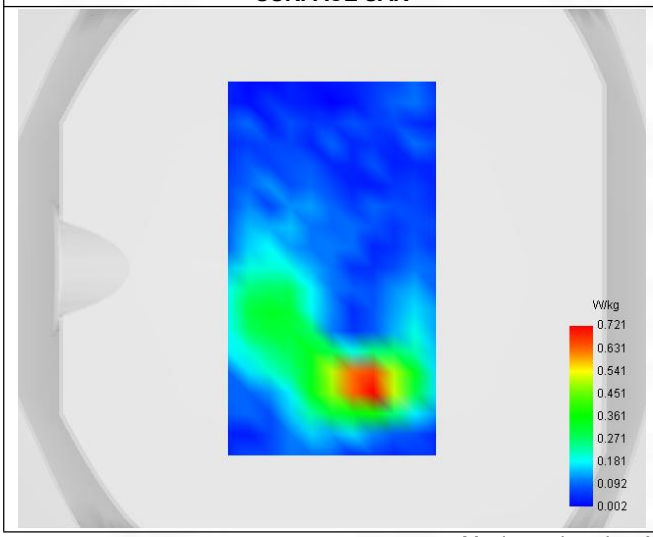
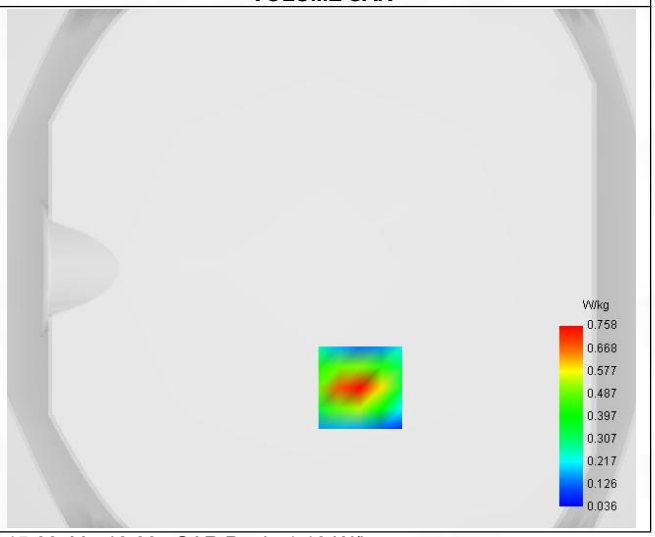
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 2
Channels	Lower (18700)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	1859.910
Relative permitivity (real part)	39.892
Relative permitivity (imaginary part)	13.665
Conductivity (S/m)	1.394

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=15.00, Y=-46.00 ; SAR Peak: 1.10 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.393
SAR 1g (W/Kg)	0.706
Variation (%)	4.260
Horizontal validation criteria: minimum distance (mm)	9.844
Vertical validation criteria: SAR ratio M2/M1 (%)	63.19%

E. Z Axis Scan

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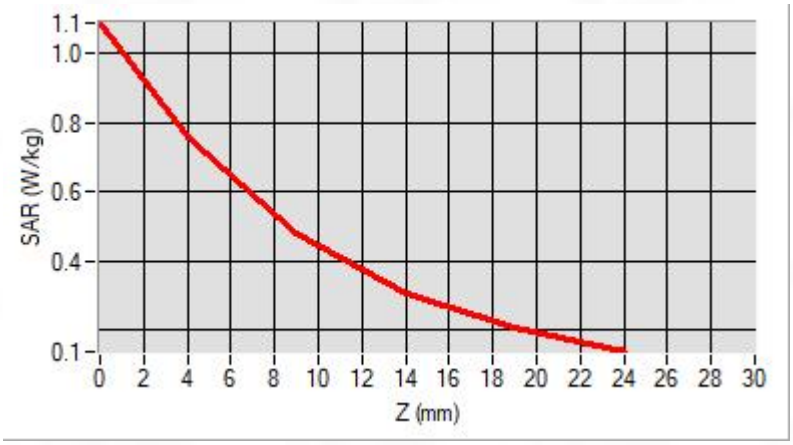
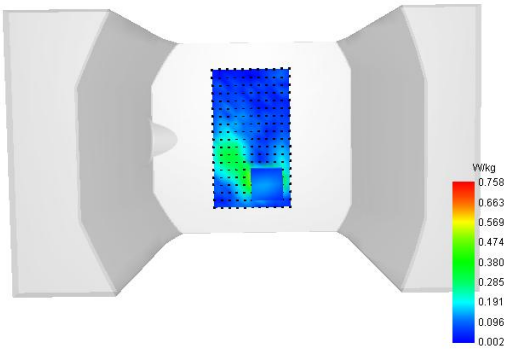
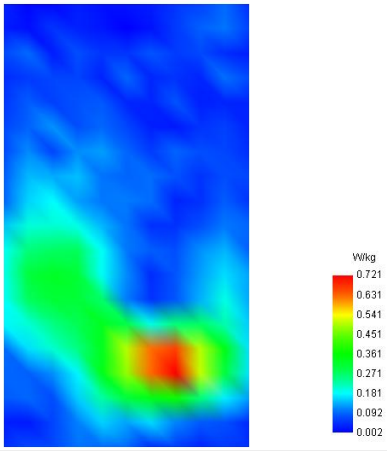
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.089	0.758	0.479	0.308	0.206



F. 3D Image

3D screen shot	Hot spot position
	

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11-Head with front position in dist. 0mm on Channel 20525 in LTE band 5

SAR Measurement at LTE band 5 (Cheek, Right)

Date of measurement: 2/8/2024

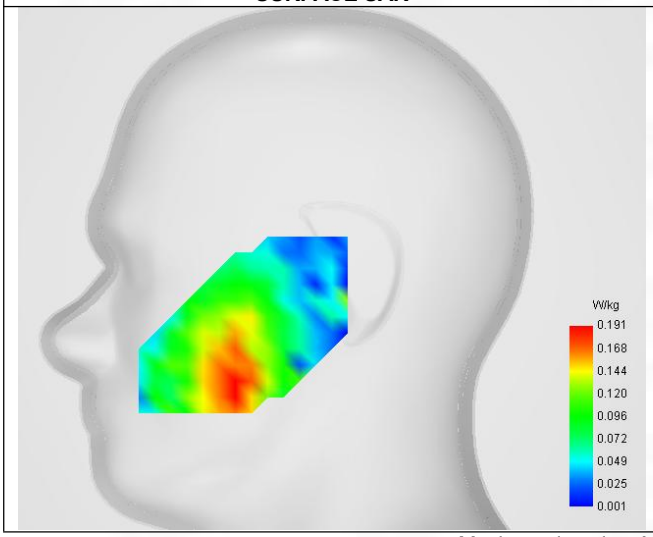
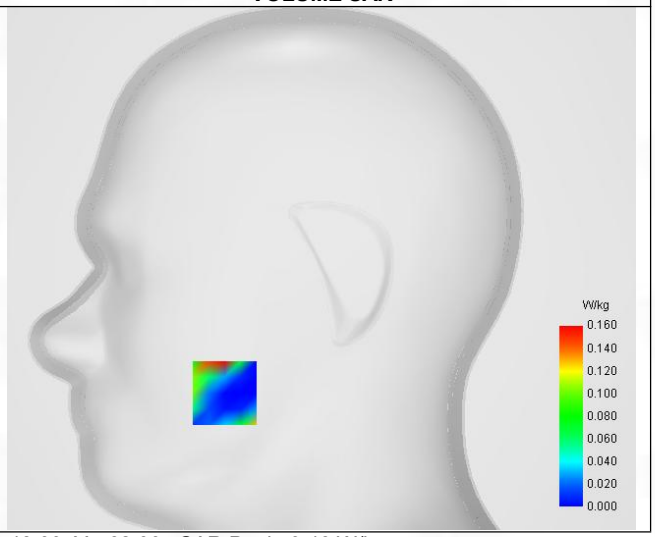
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 5
Channels	Middle (20525)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	24
RB size	1

B. Permitivity

Frequency (MHz)	836.410
Relative permitivity (real part)	41.404
Relative permitivity (imaginary part)	19.457
Conductivity (S/m)	0.870

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-62.00 ; SAR Peak: 0.46 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.045
SAR 1g (W/Kg)	0.139
Variation (%)	-4.540
Horizontal validation criteria: minimum distance (mm)	9.587
Vertical validation criteria: SAR ratio M2/M1 (%)	43.13%

E. Z Axis Scan

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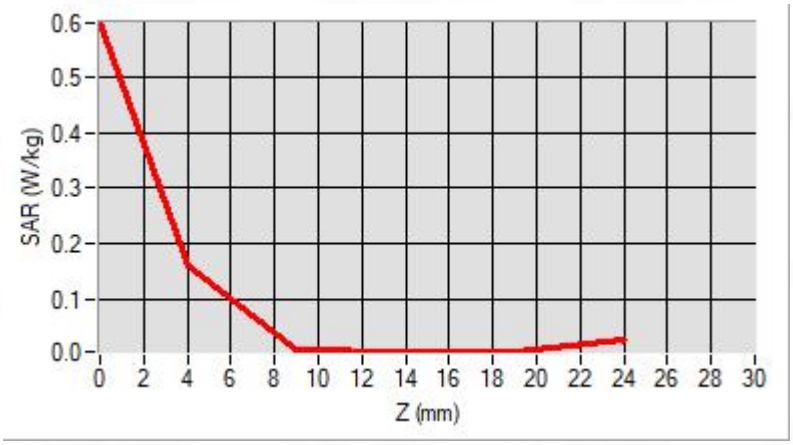
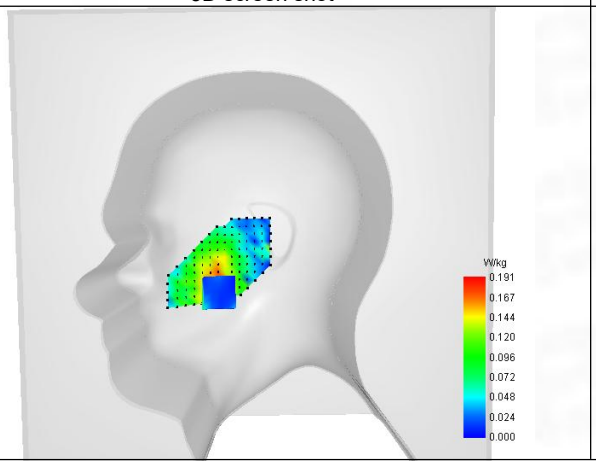
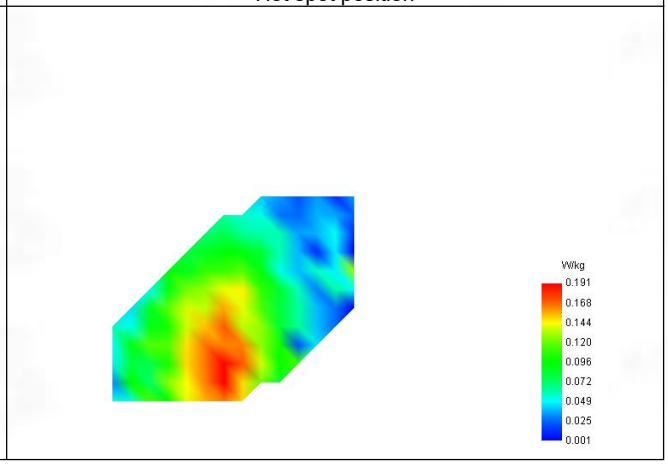
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.598	0.160	0.069	0.037	0.015



F. 3D Image

3D screen shot	Hot spot position
	

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12-Body with back position in dist. 10mm on Channel 20525 in LTE band 5

SAR Measurement at LTE band 5 (Body, Validation Plane)

Date of measurement: 2/8/2024

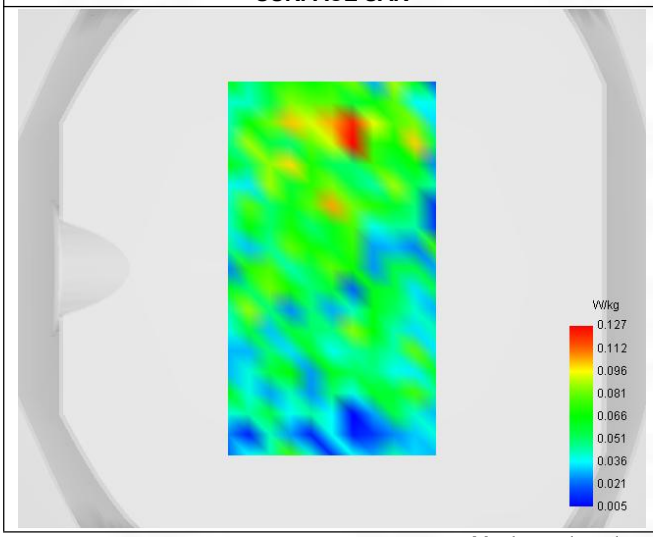
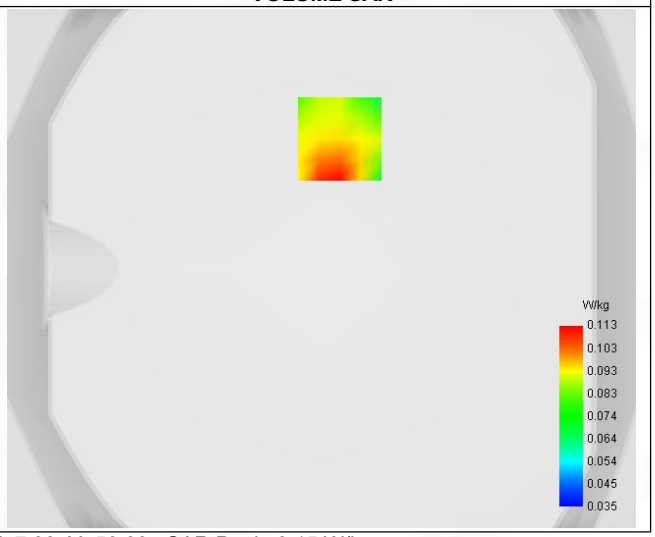
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	1.68
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 5
Channels	Middle (20525)
Signal	LTE FDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	24
RB size	1

B. Permitivity

Frequency (MHz)	836.410
Relative permitivity (real part)	41.408
Relative permitivity (imaginary part)	19.482
Conductivity (S/m)	0.871

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=7.00, Y=50.00 ; SAR Peak: 0.15 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.097
SAR 1g (W/Kg)	0.119
Variation (%)	-2.080
Horizontal validation criteria: minimum distance (mm)	10.745
Vertical validation criteria: SAR ratio M2/M1 (%)	55.75%

E. Z Axis Scan

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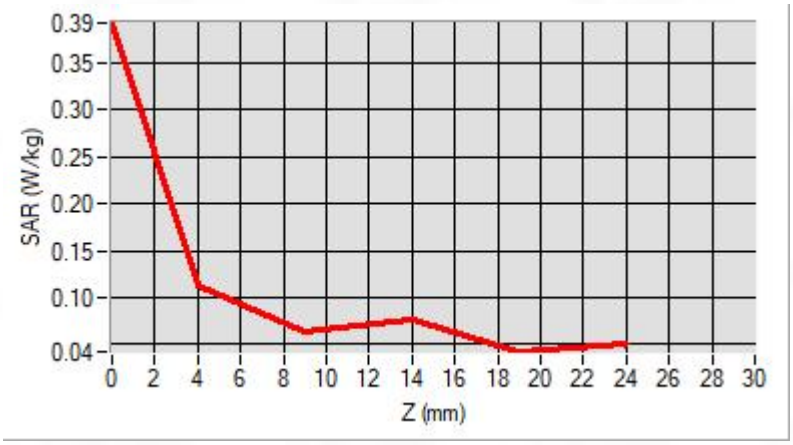
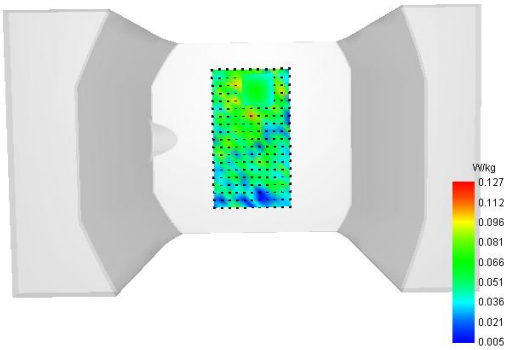
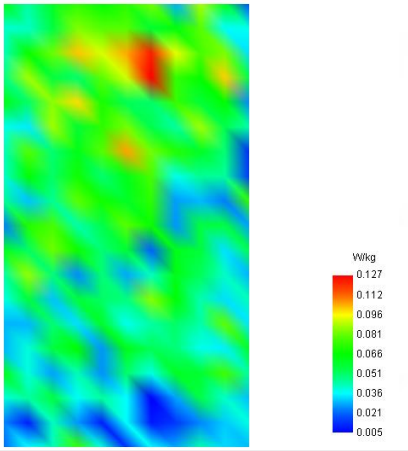
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.392	0.113	0.063	0.075	0.042



F. 3D Image

3D screen shot	Hot spot position
	

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13-Head with front position in dist. 0mm on Channel 20850 in LTE band 7

SAR Measurement at LTE band 7 (Cheek, Right)

Date of measurement: 12/8/2024

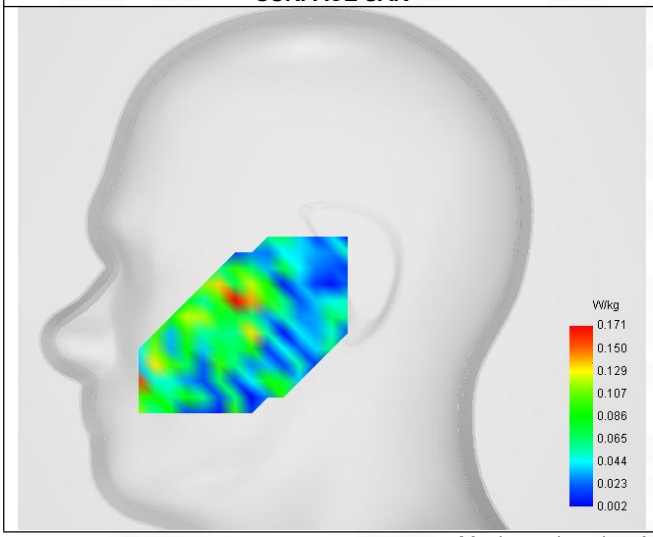
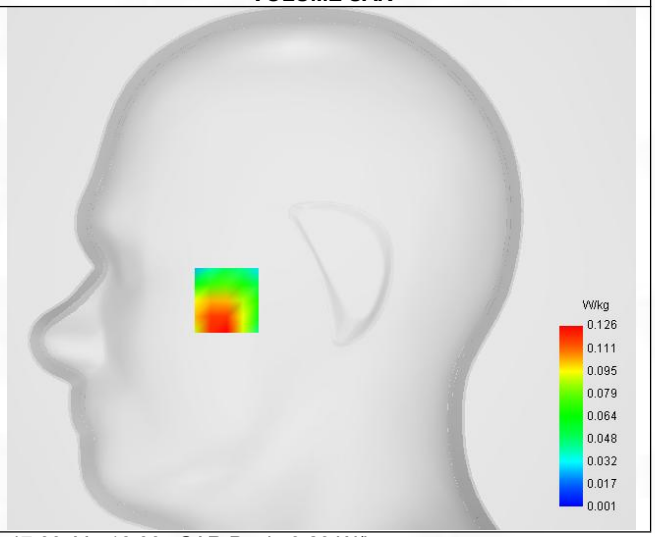
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 7
Channels	Lower (20850)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	2509.910
Relative permitivity (real part)	39.000
Relative permitivity (imaginary part)	13.080
Conductivity (S/m)	1.874

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-47.00, Y=-16.00 ; SAR Peak: 0.23 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.077
SAR 1g (W/Kg)	0.133
Variation (%)	1.530
Horizontal validation criteria: minimum distance (mm)	8.632
Vertical validation criteria: SAR ratio M2/M1 (%)	53.17%

E. Z Axis Scan

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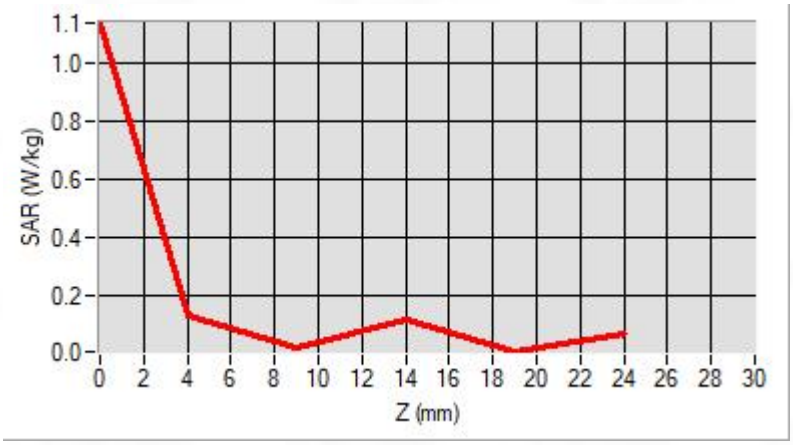
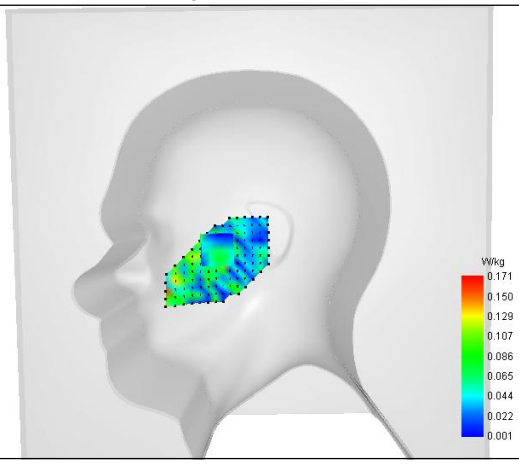
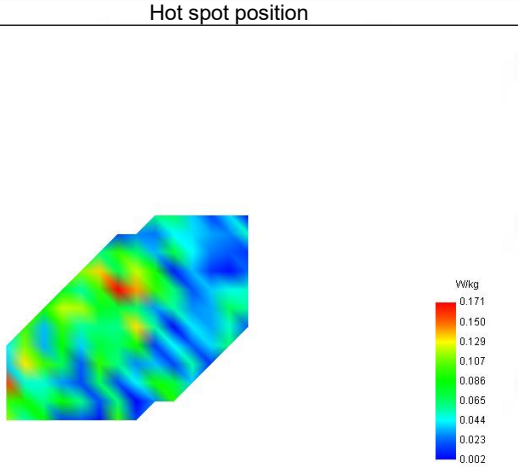
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	1.142	0.126	0.067	0.112	0.002



F. 3D Image

3D screen shot	Hot spot position
	

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14-Body with back position in dist. 10mm on Channel 20850 in LTE band 7

SAR Measurement at LTE band 7 (Body, Validation Plane)

Date of measurement: 12/8/2024

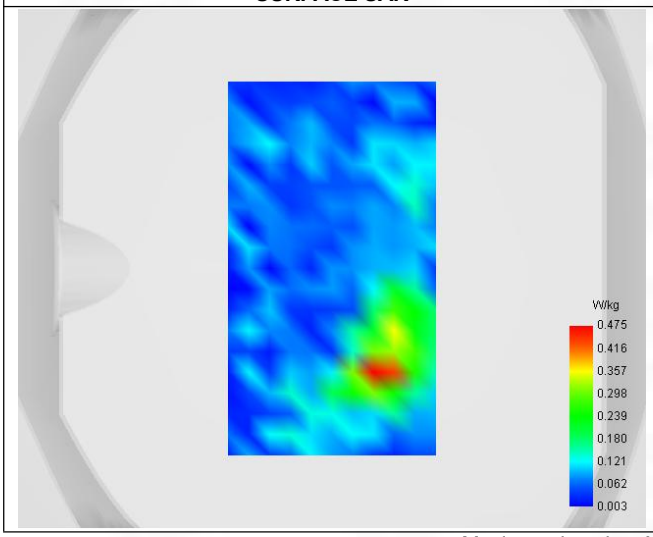
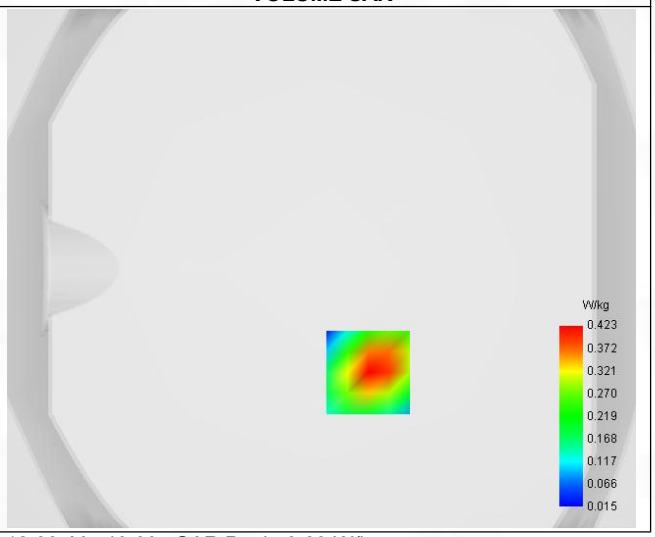
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 7
Channels	Lower (20850)
Signal	LTE FDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1

B. Permitivity

Frequency (MHz)	2509.910
Relative permitivity (real part)	39.000
Relative permitivity (imaginary part)	13.080
Conductivity (S/m)	1.874

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=18.00, Y=-40.00 ; SAR Peak: 0.69 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.231
SAR 1g (W/Kg)	0.418
Variation (%)	0.730
Horizontal validation criteria: minimum distance (mm)	9.874
Vertical validation criteria: SAR ratio M2/M1 (%)	60.05%

E. Z Axis Scan

BTF Testing Lab (Shenzhen) Co., Ltd.
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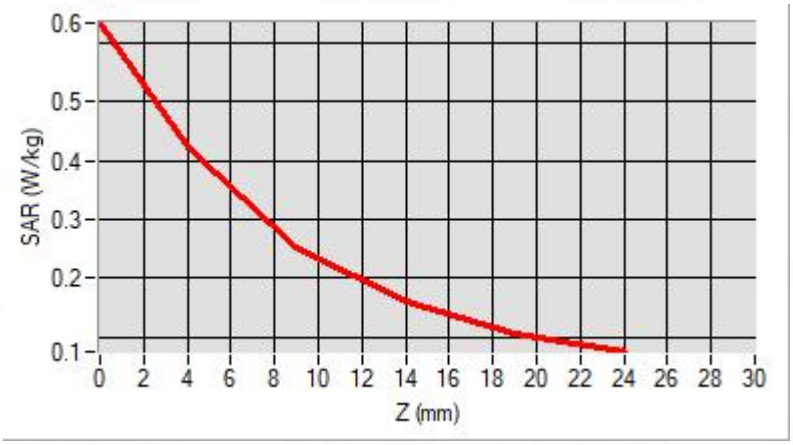
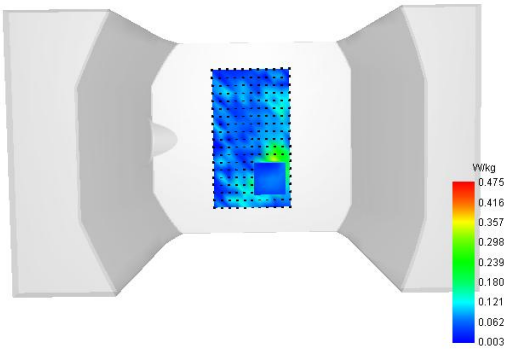
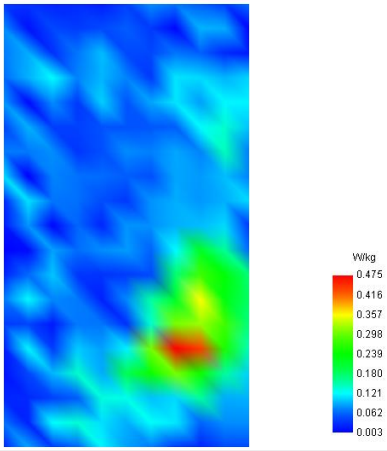
Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.634	0.423	0.254	0.159	0.108



F. 3D Image

3D screen shot	Hot spot position
	

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15-Head with front position in dist. 0mm on Channel 38150 in LTE band 38

SAR Measurement at LTE band 38 (Cheek, Right)

Date of measurement: 12/8/2024

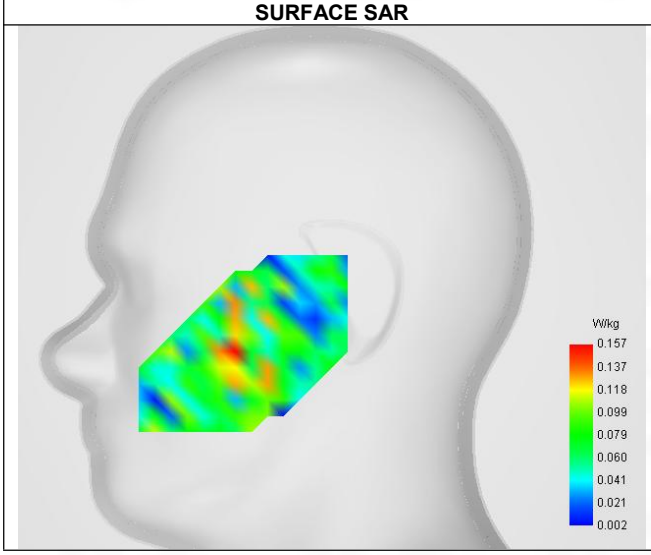
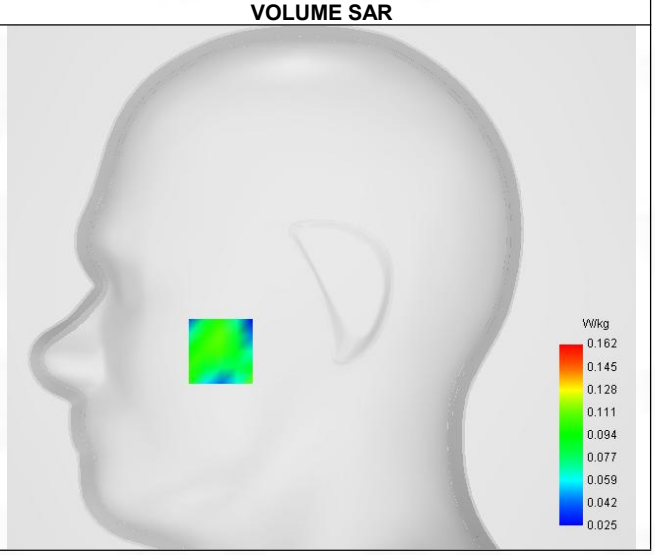
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 38
Channels	Higher (38150)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2609.910
Relative permitivity (real part)	38.869
Relative permitivity (imaginary part)	12.704
Conductivity (S/m)	1.980

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-50.00, Y=-32.00 ; SAR Peak: 0.17 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.084
SAR 1g (W/Kg)	0.112
Variation (%)	0.180
Horizontal validation criteria: minimum distance (mm)	8.635

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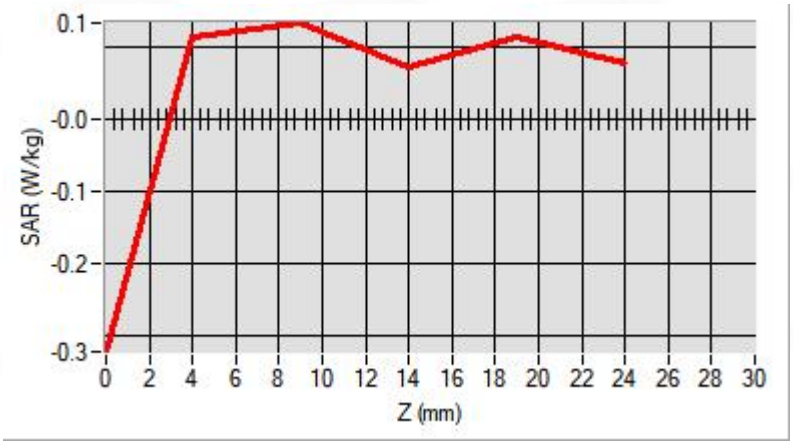
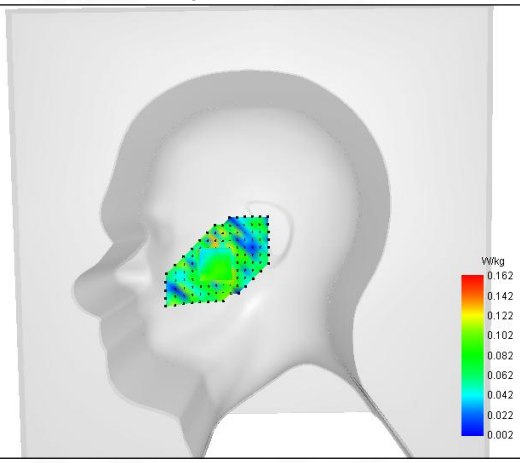
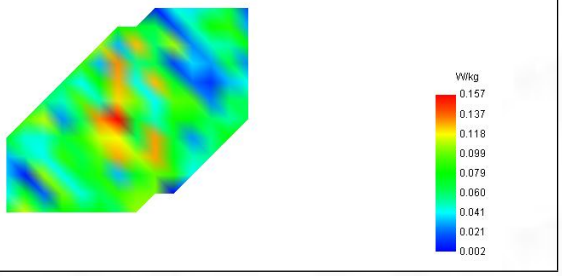
Vertical validation criteria: SAR ratio M2/M1 (%)	69.14%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.321	0.162	0.112	0.071	0.112



F. 3D Image

3D screen shot	Hot spot position
	

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16-Body with back position in dist. 10mm on Channel 38150 in LTE band 38

SAR Measurement at LTE band 38 (Body, Validation Plane)

Date of measurement: 12/8/2024

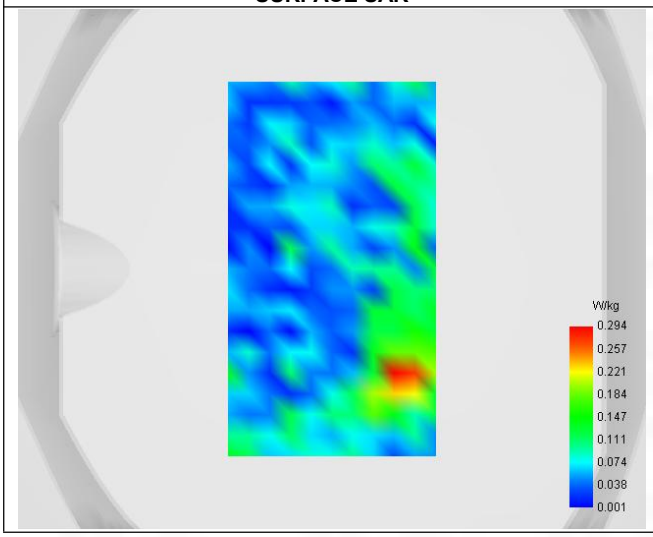
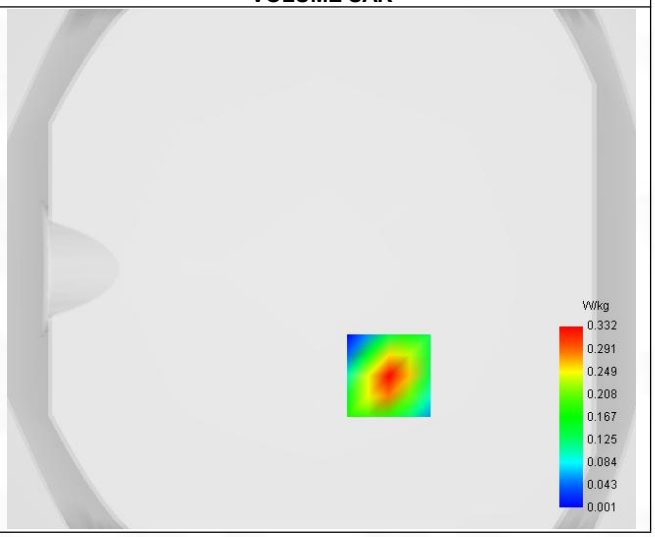
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 38
Channels	Higher (38150)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2609.910
Relative permitivity (real part)	38.869
Relative permitivity (imaginary part)	12.704
Conductivity (S/m)	1.980

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=26.00, Y=-41.00 ; SAR Peak: 0.47 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.182
SAR 1g (W/Kg)	0.310
Variation (%)	3.740
Horizontal validation criteria: minimum distance (mm)	10.322

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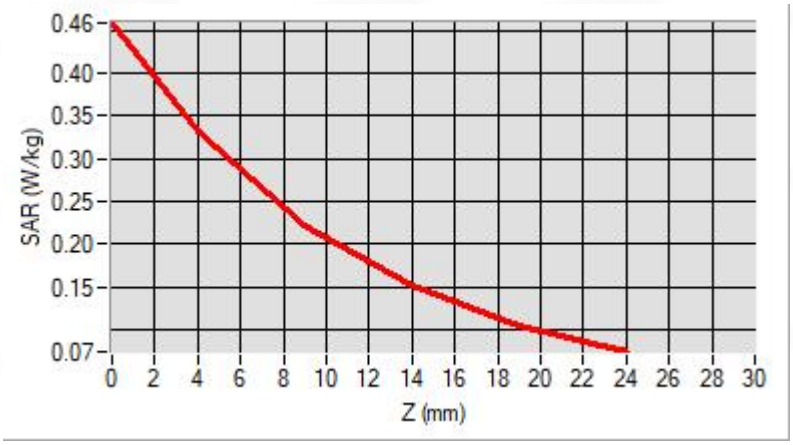
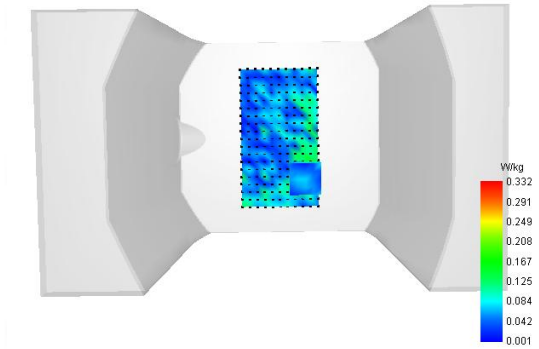
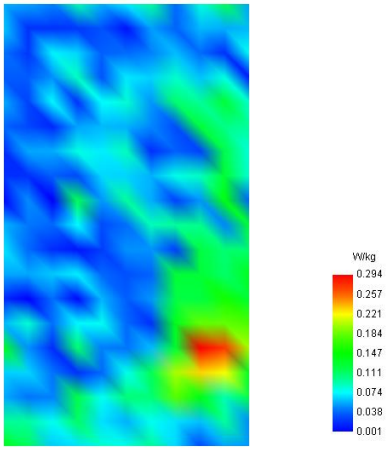
Vertical validation criteria: SAR ratio M2/M1 (%)	66.57%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.459	0.332	0.221	0.150	0.105



F. 3D Image

3D screen shot	Hot spot position
	

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17-Head with front position in dist. 0mm on Channel 38750 in LTE band 40

SAR Measurement at LTE band 40 (Cheek, Right)

Date of measurement: 8/8/2024

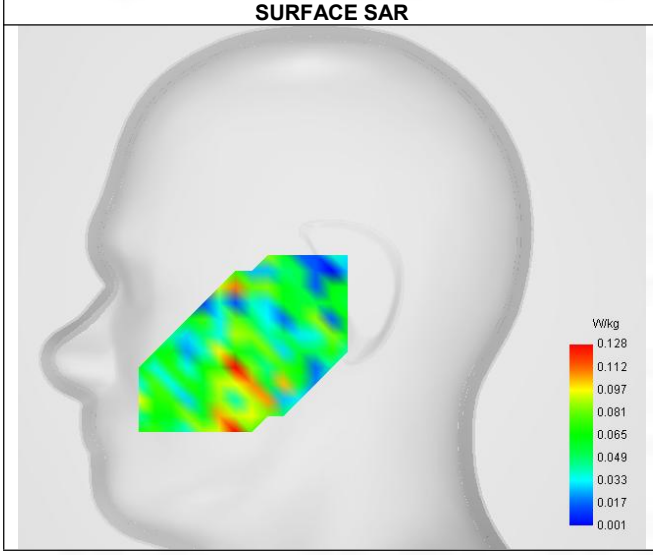
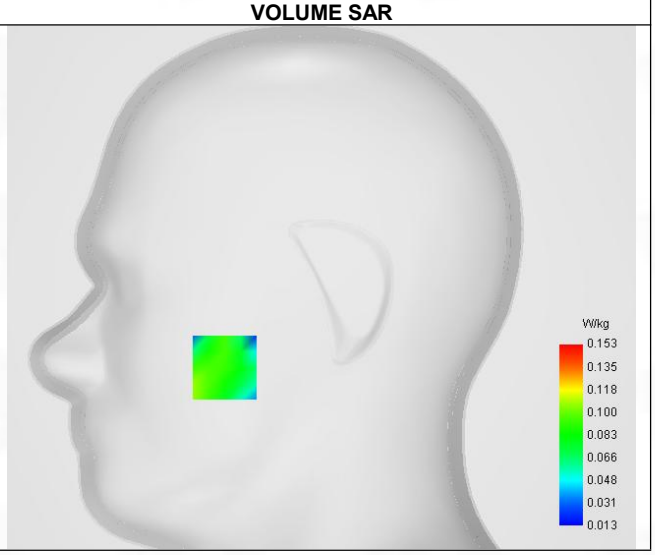
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 40
Channels	Lower (38750)
Signal	LTE TDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	24
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2309.910
Relative permitivity (real part)	39.284
Relative permitivity (imaginary part)	13.350
Conductivity (S/m)	1.708

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-48.00, Y=-40.00 ; SAR Peak: 0.23 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.089
SAR 1g (W/Kg)	0.120
Variation (%)	-4.540
Horizontal validation criteria: minimum distance (mm)	9.788

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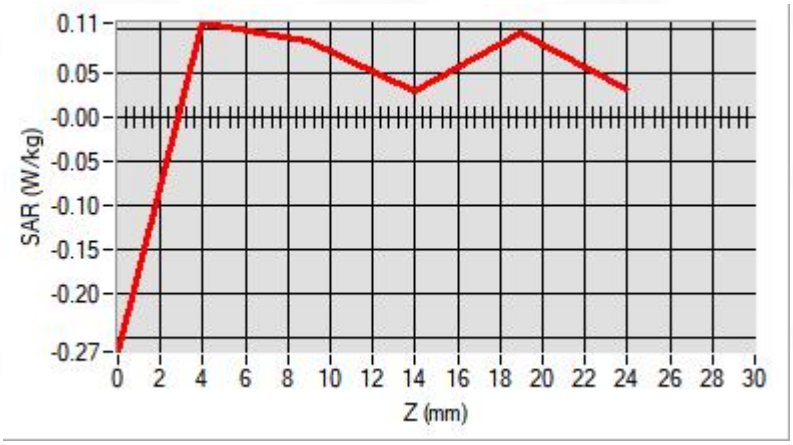
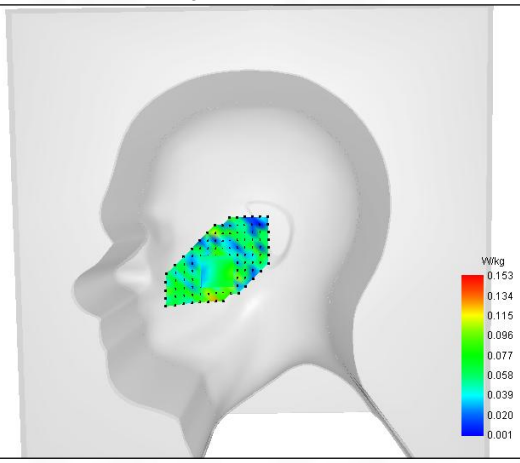
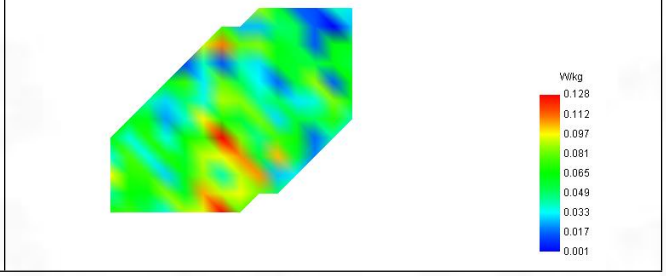
Vertical validation criteria: SAR ratio M2/M1 (%)	70.09%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	-0.267	0.107	0.075	0.029	0.094



F. 3D Image

3D screen shot	Hot spot position
	

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18-Body with back position in dist. 10mm on Channel 38750 in LTE band 40

SAR Measurement at LTE band 40 (Body, Validation Plane)

Date of measurement: 8/8/2024

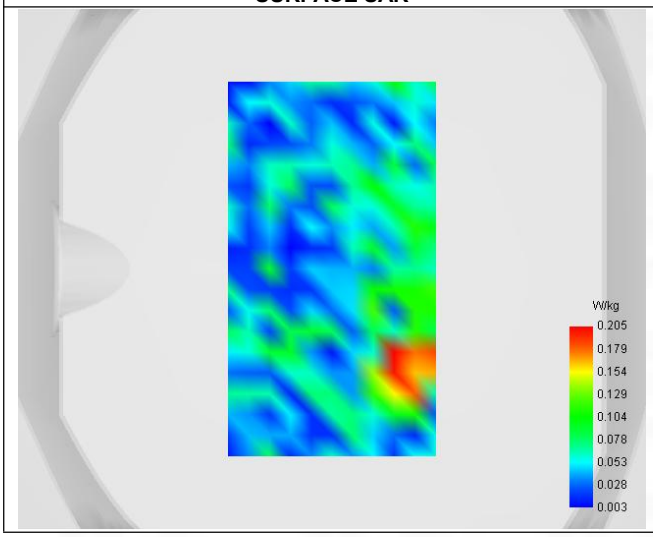
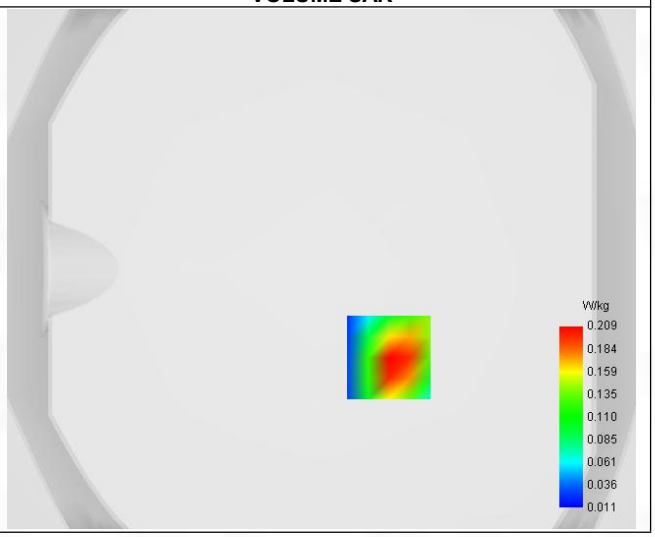
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 40
Channels	Lower (38750)
Signal	LTE TDD
Cell Bandwidth	10 Mhz
Modulation	SC-OFDM - QPSK
RB offset	24
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2309.910
Relative permitivity (real part)	39.284
Relative permitivity (imaginary part)	13.350
Conductivity (S/m)	1.708

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=26.00, Y=-34.00 ; SAR Peak: 0.43 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.114
SAR 1g (W/Kg)	0.220
Variation (%)	-3.100
Horizontal validation criteria: minimum distance (mm)	9.771

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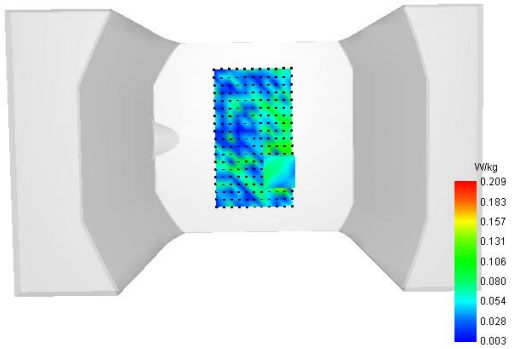
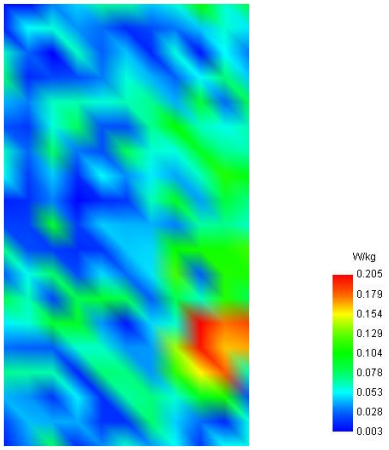
Vertical validation criteria: SAR ratio M2/M1 (%)	45.93%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.387	0.209	0.096	0.057	0.054

F. 3D Image

3D screen shot	Hot spot position
	

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19-Head with front position in dist. 0mm on Channel 40690 in LTE band 41

SAR Measurement at LTE band 41 (Cheek, Right)

Date of measurement: 12/8/2024

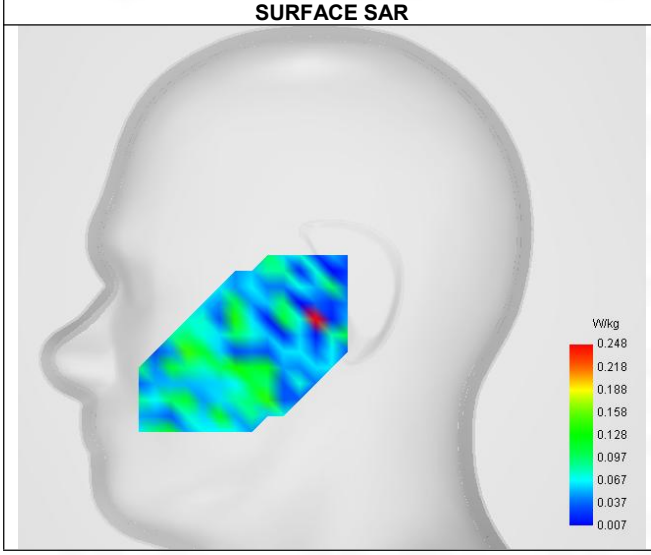
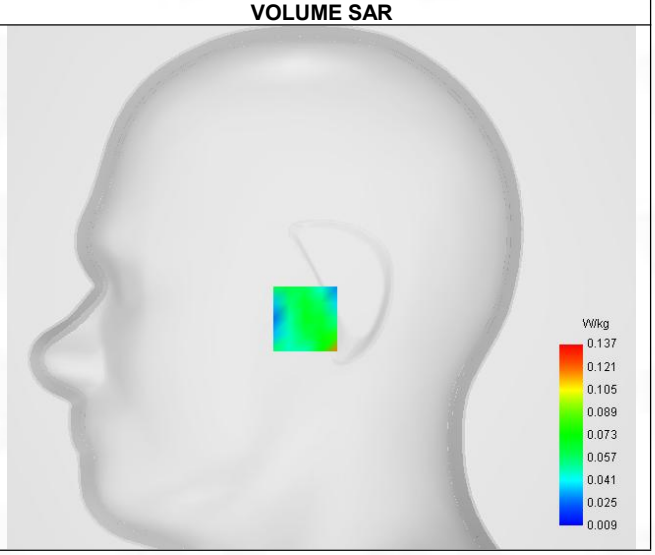
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	LTE band 41
Channels	Middle (40690)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2599.910
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-8.00, Y=-16.00 ; SAR Peak: 0.11 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.073
SAR 1g (W/Kg)	0.087
Variation (%)	-3.640
Horizontal validation criteria: minimum distance (mm)	8.517

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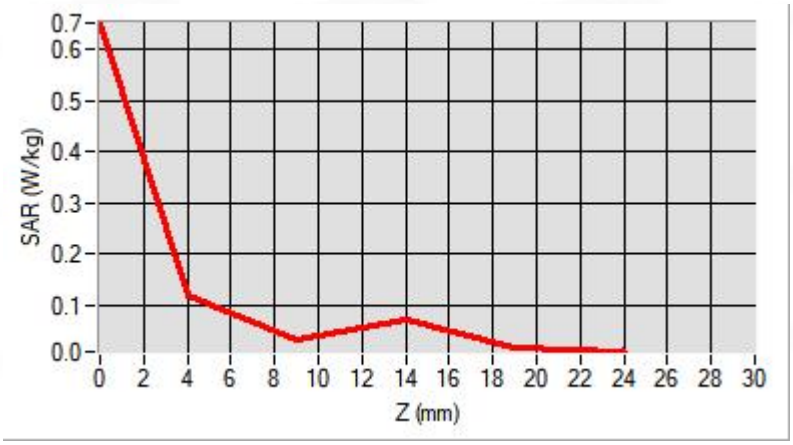
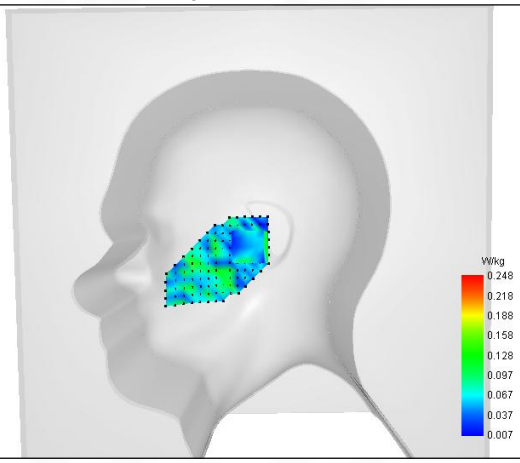
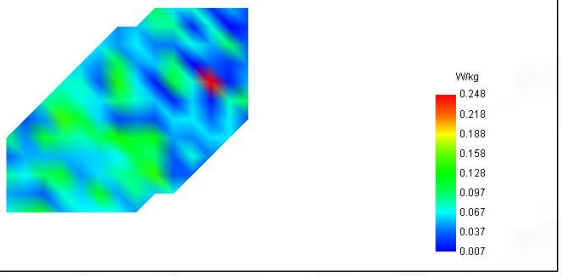
Vertical validation criteria: SAR ratio M2/M1 (%)	54.01%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.652	0.137	0.074	0.054	0.018



F. 3D Image

3D screen shot	Hot spot position
	

20-Body with back position in dist. 10mm on Channel 40690 in LTE band 41

SAR Measurement at LTE band 41 (Body, Validation Plane)

Date of measurement: 12/8/2024

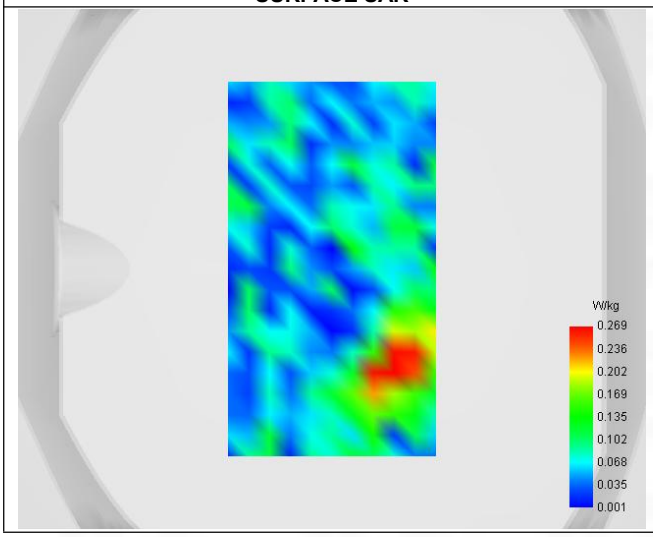
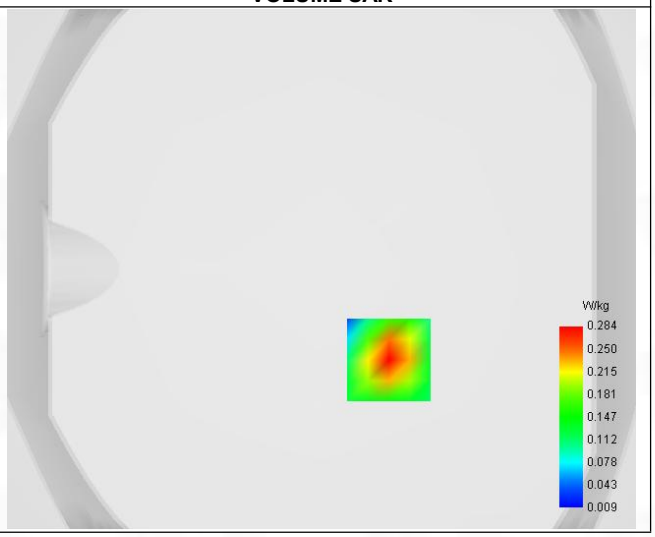
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.40
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	5x5x7,dx=8mm dy=8mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	LTE band 41
Channels	Middle (40690)
Signal	LTE TDD
Cell Bandwidth	20 Mhz
Modulation	SC-OFDM - QPSK
RB offset	49
RB size	1
Subframe configuration	0
Special subframe configuration	0
Cyclic prefix	Normal
Duty Cycle (%)	0.61

B. Permitivity

Frequency (MHz)	2599.910
Relative permitivity (real part)	38.880
Relative permitivity (imaginary part)	12.690
Conductivity (S/m)	1.970

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=26.00, Y=-35.00 ; SAR Peak: 0.38 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.161
SAR 1g (W/Kg)	0.271
Variation (%)	1.060
Horizontal validation criteria: minimum distance (mm)	9.841

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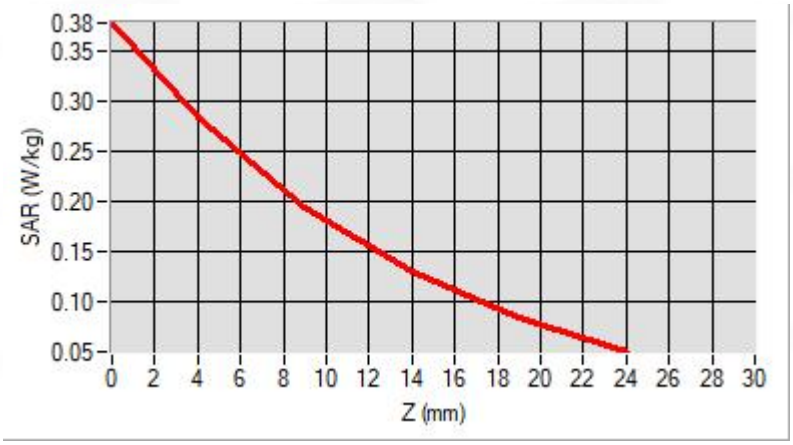
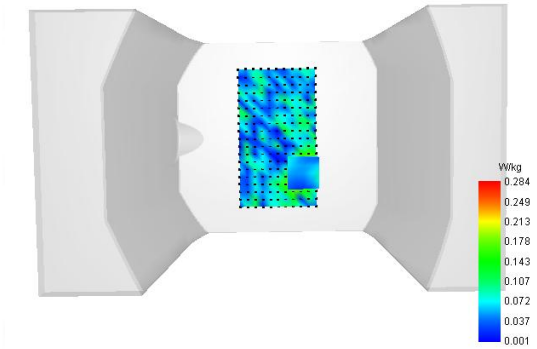
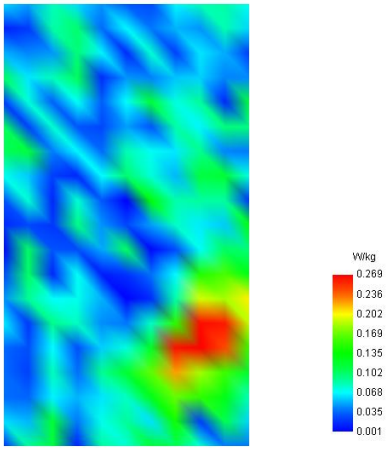
Vertical validation criteria: SAR ratio M2/M1 (%)	68.31%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.379	0.284	0.194	0.130	0.084



F. 3D Image

3D screen shot	Hot spot position
	

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21-Head with front position in dist. 0mm on Channel 1 in IEEE 802.11b ISM

SAR Measurement at IEEE 802.11b ISM (Cheek, Right)

Date of measurement: 9/8/2024

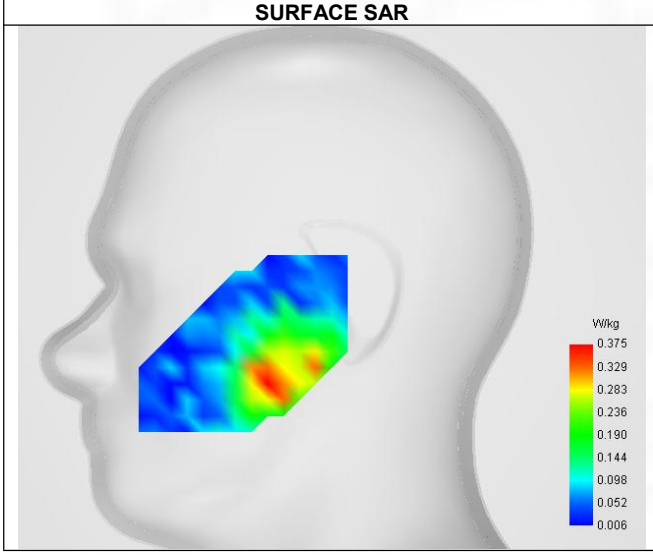
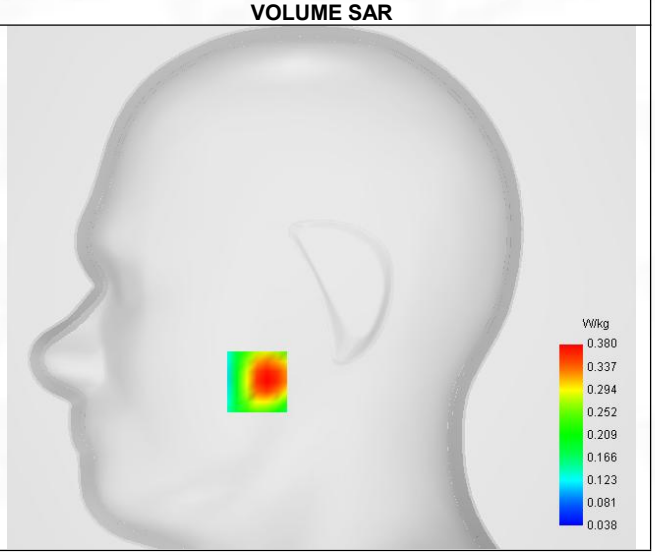
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Right head
Device Position	Cheek
Band	IEEE 802.11b ISM
Channels	Lower (1)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	2412.000
Relative permitivity (real part)	39.135
Relative permitivity (imaginary part)	13.343
Conductivity (S/m)	1.782

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-32.00, Y=-47.00 ; SAR Peak: 0.61 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.222
SAR 1g (W/Kg)	0.378
Variation (%)	-2.510
Horizontal validation criteria: minimum distance (mm)	9.517
Vertical validation criteria: SAR ratio M2/M1 (%)	60.53%

E. Z Axis Scan

Z (mm)	0.00	4.00	8.00	12.00	16.00
SAR (W/Kg)	0.743	0.380	0.230	0.171	0.135

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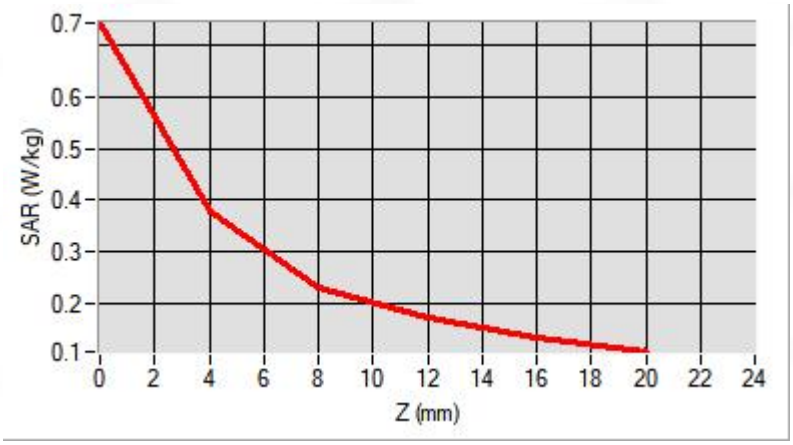
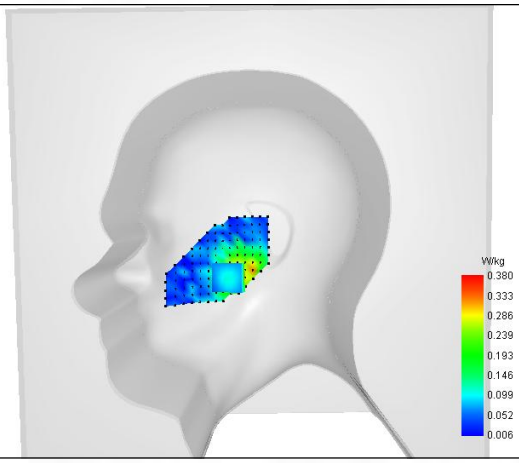
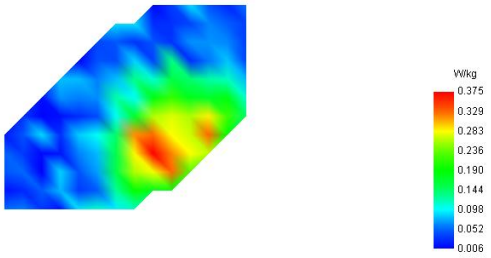


F. 3D Image

3D screen shot	Hot spot position
	

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22-Body with back position in dist. 10mm on Channel 1 in IEEE 802.11b ISM

SAR Measurement at IEEE 802.11b ISM (Body, Validation Plane)

Date of measurement: 9/8/2024

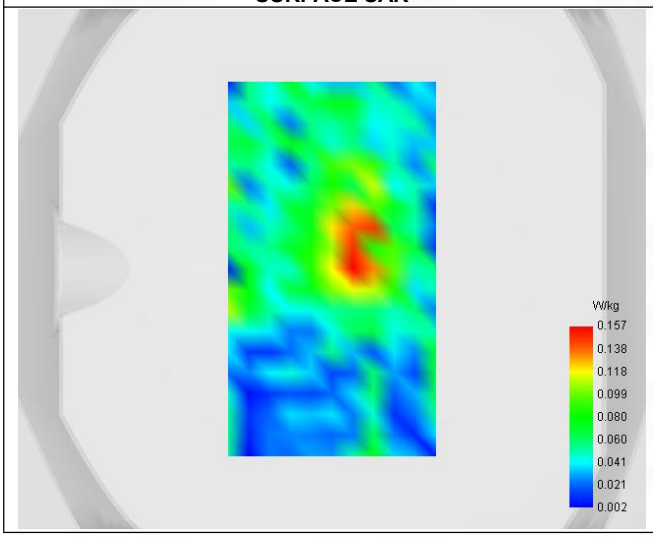
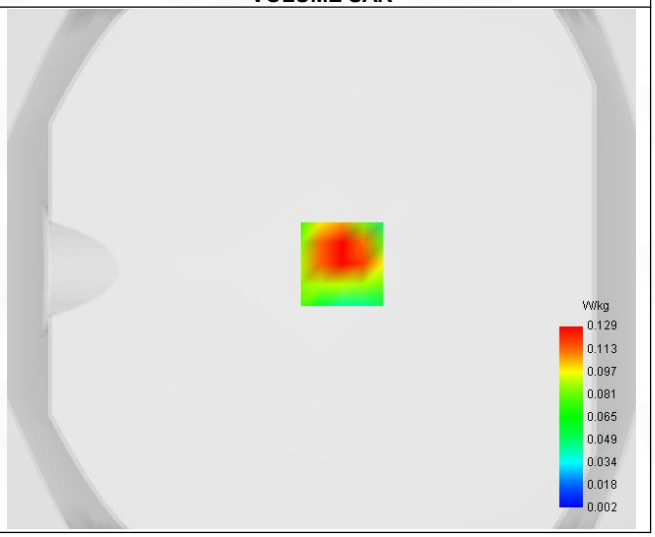
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.36
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x7,dx=5mm dy=5mm dz=5mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11b ISM
Channels	Lower (1)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	2412.000
Relative permitivity (real part)	39.135
Relative permitivity (imaginary part)	13.343
Conductivity (S/m)	1.782

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=8.00, Y=2.00 ; SAR Peak: 0.23 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.087
SAR 1g (W/Kg)	0.136
Variation (%)	-1.600
Horizontal validation criteria: minimum distance (mm)	9.325
Vertical validation criteria: SAR ratio M2/M1 (%)	62.79%

E. Z Axis Scan

Z (mm)	0.00	4.00	9.00	14.00	19.00
SAR (W/Kg)	0.093	0.129	0.081	0.048	0.061

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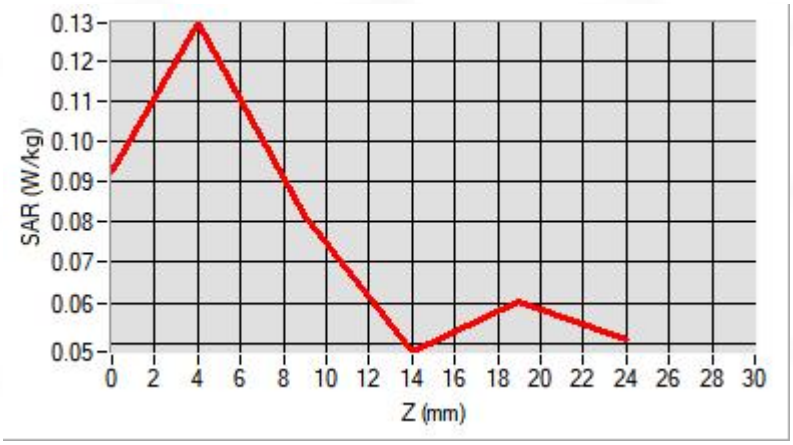
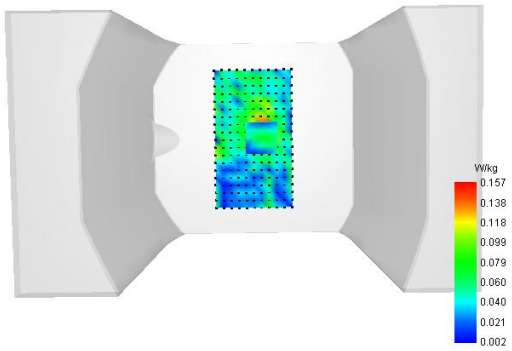
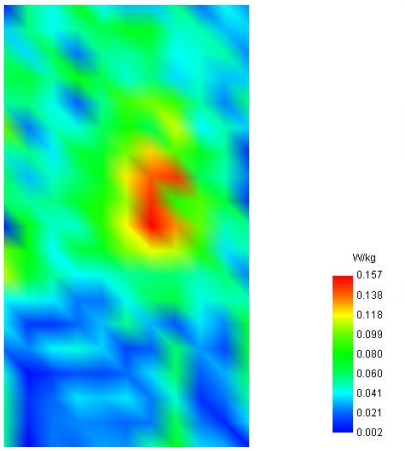


F. 3D Image

3D screen shot	Hot spot position
	

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23-Head with front position in dist. 0mm on Channel 46 in IEEE 802.11n U-NII

SAR Measurement at IEEE 802.11n U-NII (Cheek, Right)

Date of measurement: 13/8/2024

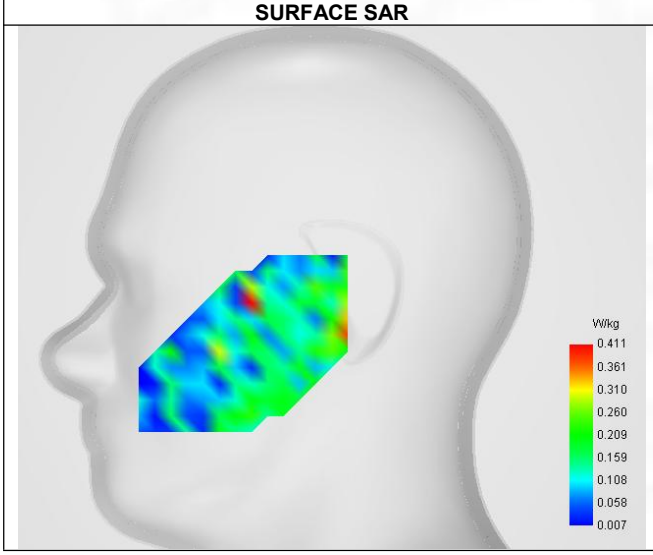
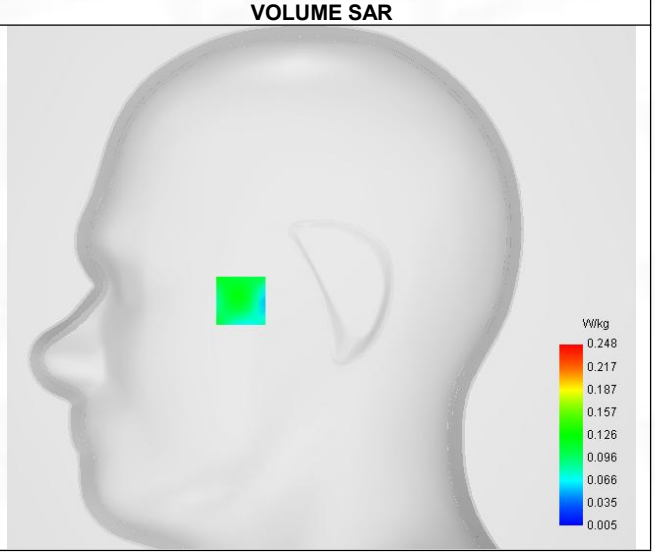
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Right head
Device Position	Cheek
Band	IEEE 802.11n U-NII
Channels	Middle (46)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5230.000
Relative permitivity (real part)	35.850
Relative permitivity (imaginary part)	16.261
Conductivity (S/m)	4.730

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-40.00, Y=-7.00 ; SAR Peak: 0.32 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.106
SAR 1g (W/Kg)	0.236
Variation (%)	-2.140
Horizontal validation criteria: minimum distance (mm)	6.215
Vertical validation criteria: SAR ratio M2/M1 (%)	66.53%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.486	0.248	0.165	0.101	0.188	0.089	0.174	0.082	0.076

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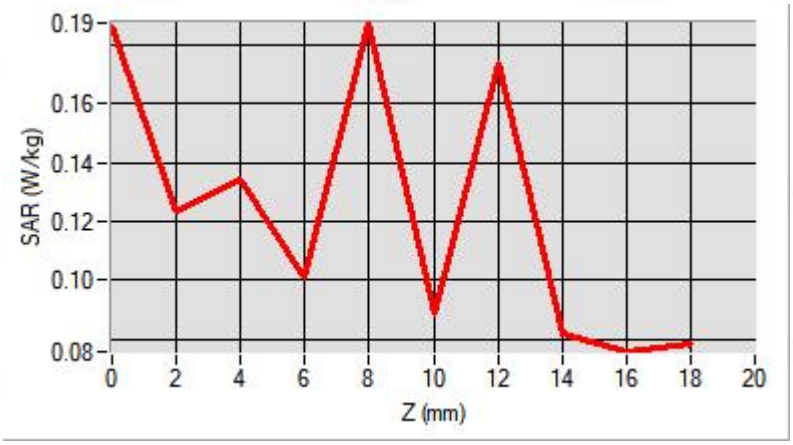
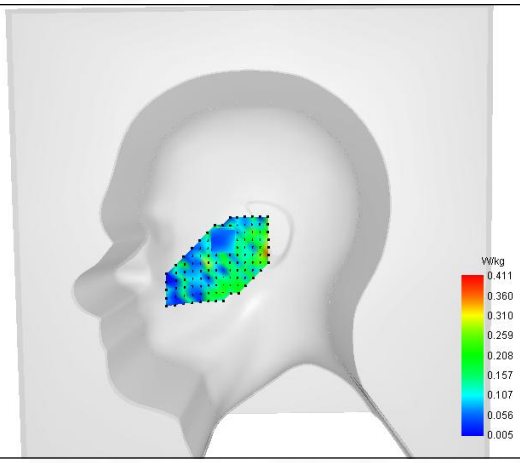
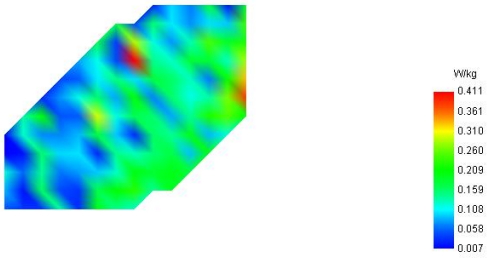


F. 3D Image

3D screen shot	Hot spot position
	

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24-Body with back position in dist. 10mm on Channel 46 in IEEE 802.11n U-NII

SAR Measurement at IEEE 802.11n U-NII (Body, Validation Plane)

Date of measurement: 13/8/2024

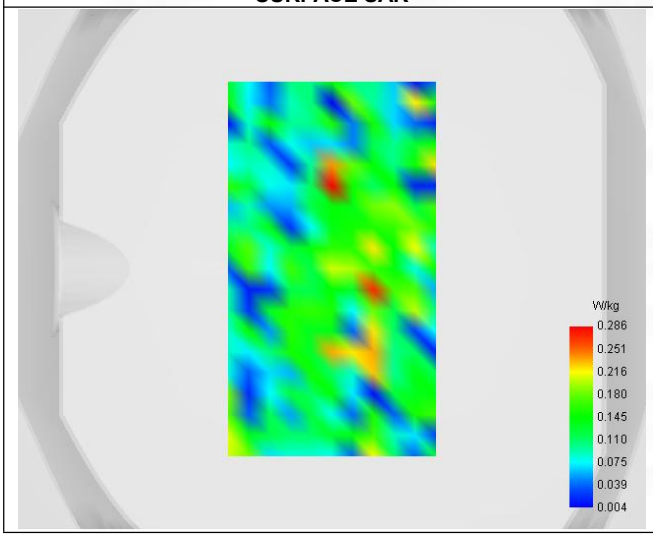
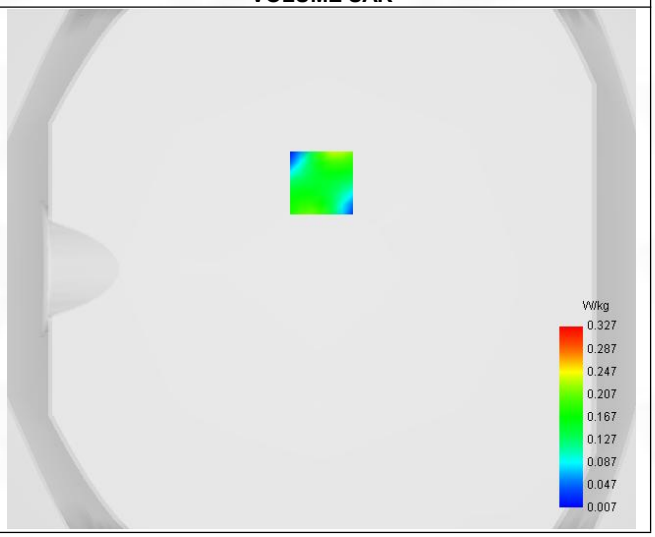
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.24
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11n U-NII
Channels	Middle (46)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5230.000
Relative permitivity (real part)	35.850
Relative permitivity (imaginary part)	16.261
Conductivity (S/m)	4.730

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=0.00, Y=33.00 ; SAR Peak: 0.41 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.078
SAR 1g (W/Kg)	0.144
Variation (%)	-3.110
Horizontal validation criteria: minimum distance (mm)	5.877
Vertical validation criteria: SAR ratio M2/M1 (%)	49.35%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.411	0.231	0.114	0.058	0.030	0.019	0.010	0.018	0.028

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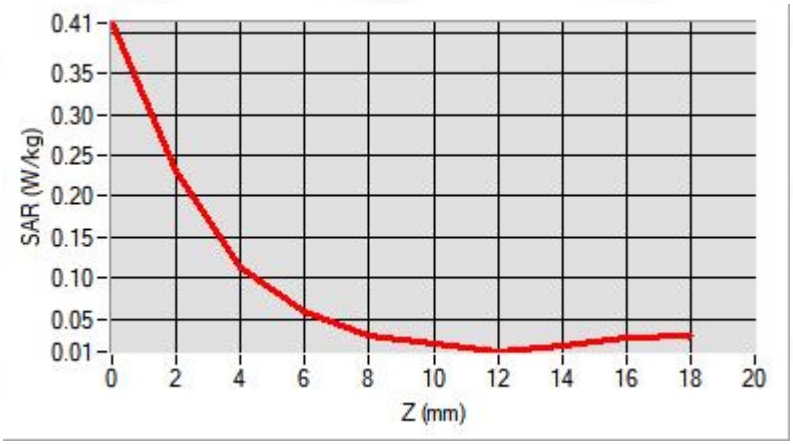
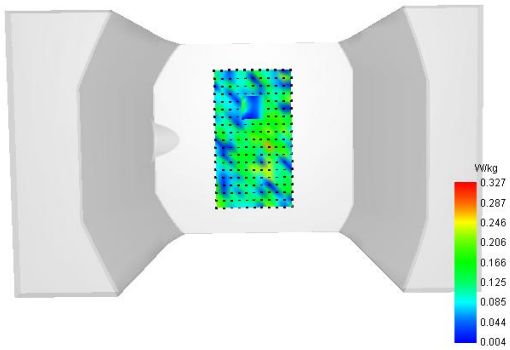
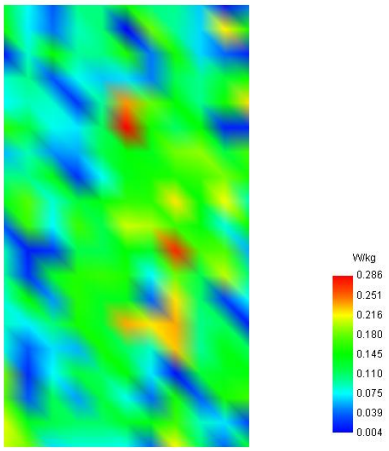


F. 3D Image

3D screen shot	Hot spot position
	

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25-Head with front position in dist. 0mm on Channel 149 in IEEE 802.11ac U-NII

SAR Measurement at IEEE 802.11ac U-NII (Cheek, Right)

Date of measurement: 13/8/2024

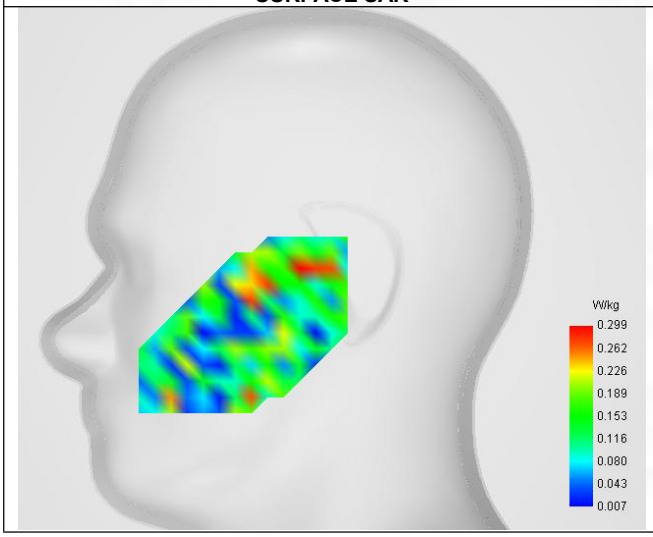
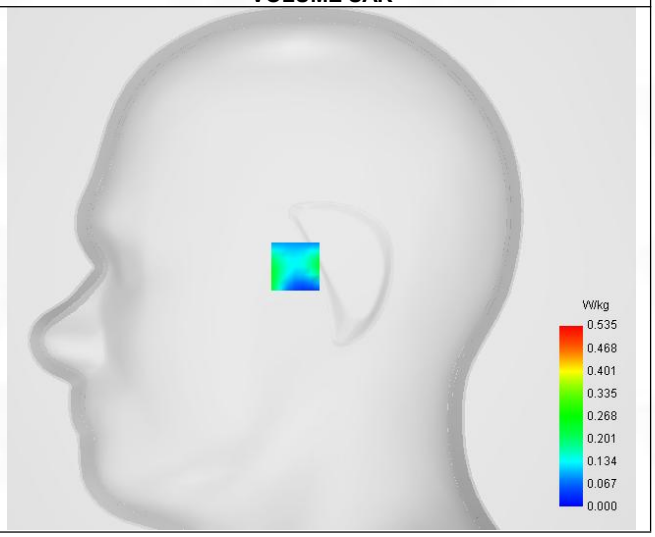
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Right head
Device Position	Cheek
Band	IEEE 802.11ac U-NII
Channels	Lower (149)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5745.000
Relative permitivity (real part)	35.235
Relative permitivity (imaginary part)	16.464
Conductivity (S/m)	5.255

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=-13.00, Y=1.00 ; SAR Peak: 0.95 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.177
SAR 1g (W/Kg)	0.217
Variation (%)	3.850
Horizontal validation criteria: minimum distance (mm)	7.444
Vertical validation criteria: SAR ratio M2/M1 (%)	64.09%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.395	0.259	0.166	0.124	0.105	0.086	0.074	0.094	0.104

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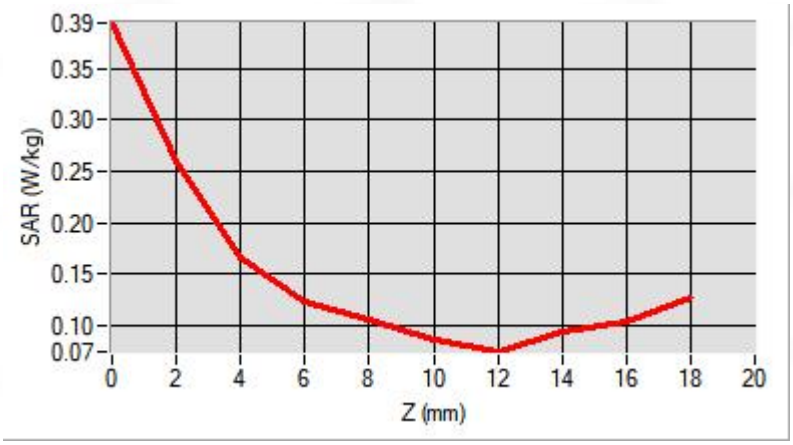
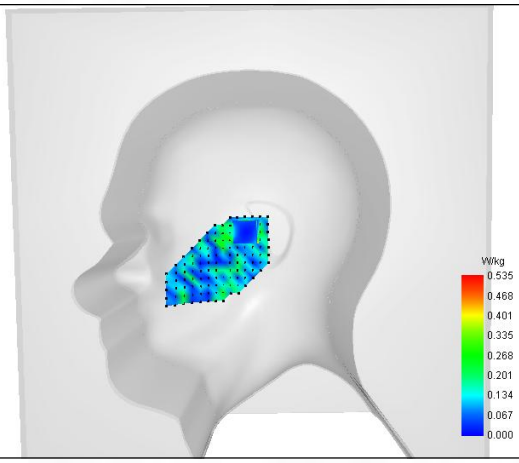
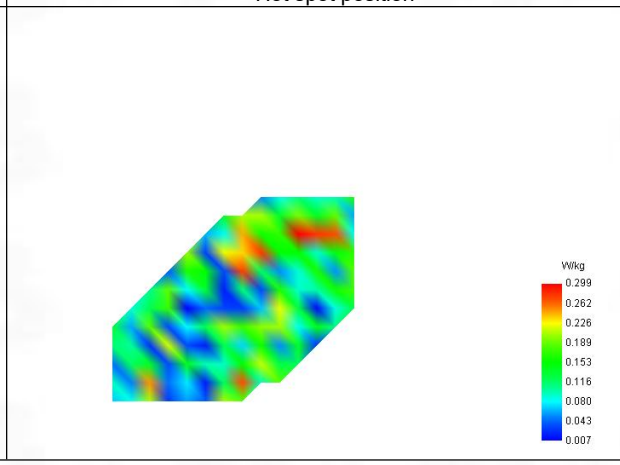


F. 3D Image

3D screen shot	Hot spot position
	

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26-Body with back position in dist. 10mm on Channel 149 in IEEE 802.11ac U-NII

SAR Measurement at IEEE 802.11ac U-NII (Body, Validation Plane)

Date of measurement: 13/8/2024

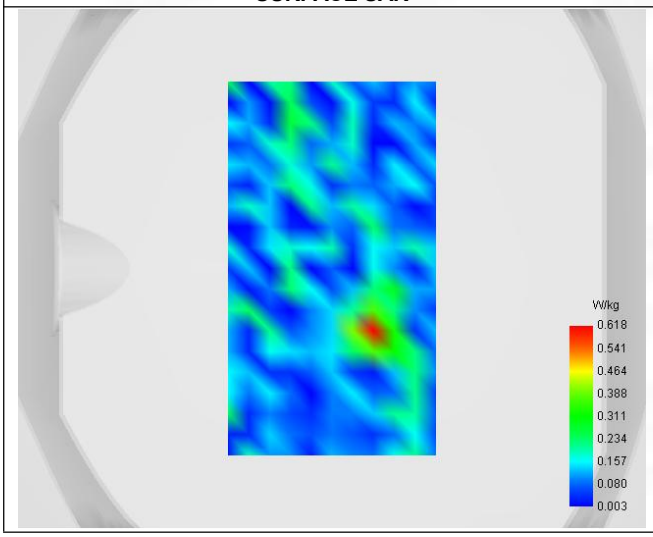
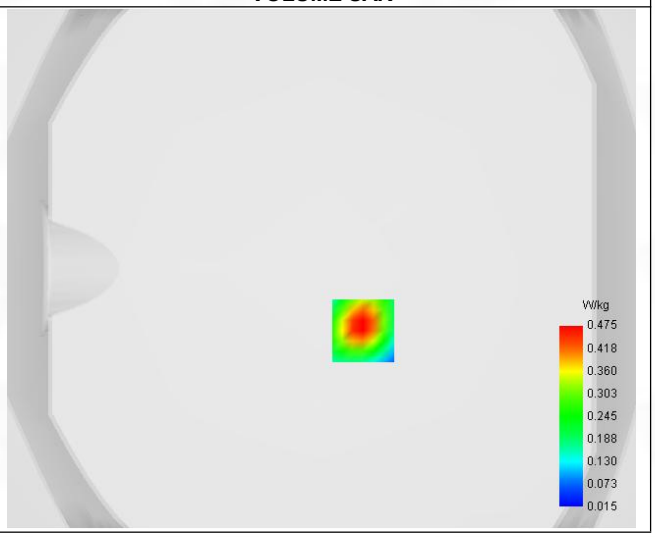
A. Experimental conditions.

Probe	SN 04/22 EPGO365
ConvF	2.04
Area Scan	dx=8mm dy=8mm, Adaptative 1 max
Zoom Scan	7x7x12,dx=4mm dy=4mm dz=2mm,Complete
Phantom	Validation plane
Device Position	Body
Band	IEEE 802.11ac U-NII
Channels	Lower (149)
Signal	IEEE 802.11

B. Permitivity

Frequency (MHz)	5745.000
Relative permitivity (real part)	35.235
Relative permitivity (imaginary part)	16.464
Conductivity (S/m)	5.255

C. SAR Surface and Volume

SURFACE SAR	VOLUME SAR
	

Maximum location: X=16.00, Y=-24.00 ; SAR Peak: 0.86 W/kg

D. SAR 1g & 10g

SAR 10g (W/Kg)	0.166
SAR 1g (W/Kg)	0.304
Variation (%)	1.500
Horizontal validation criteria: minimum distance (mm)	6.522
Vertical validation criteria: SAR ratio M2/M1 (%)	51.16%

E. Z Axis Scan

Z (mm)	0.00	2.00	4.00	6.00	8.00	10.00	12.00	14.00	16.00
SAR (W/Kg)	0.867	0.475	0.243	0.143	0.110	0.071	0.094	0.086	0.115

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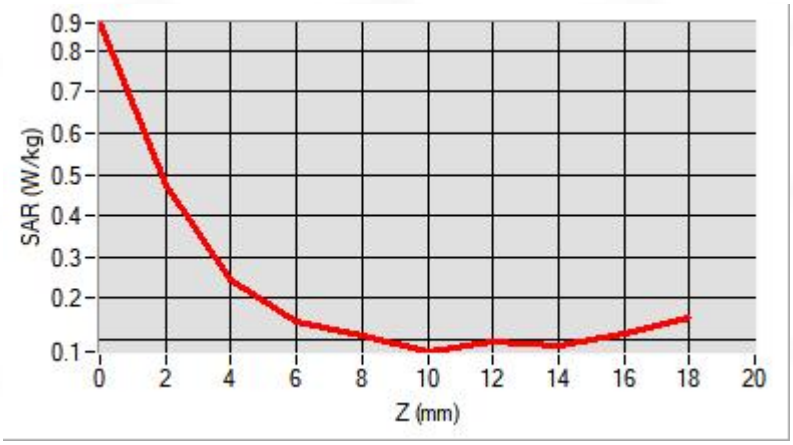
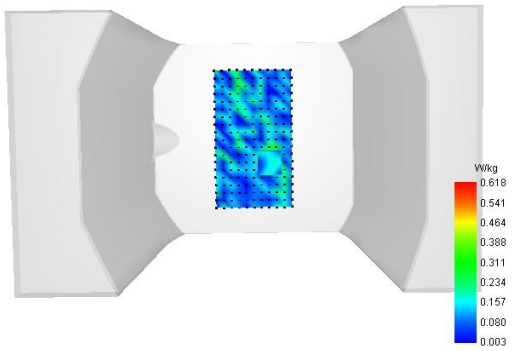
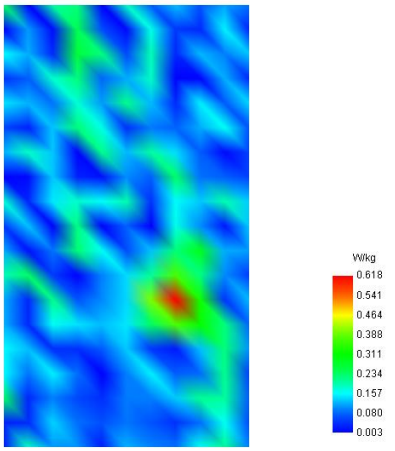


F. 3D Image

3D screen shot	Hot spot position
	

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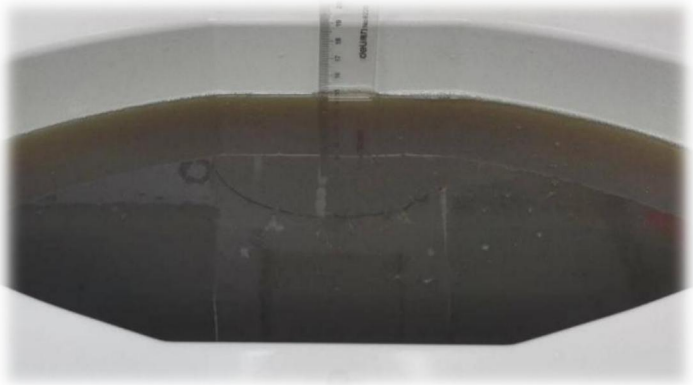
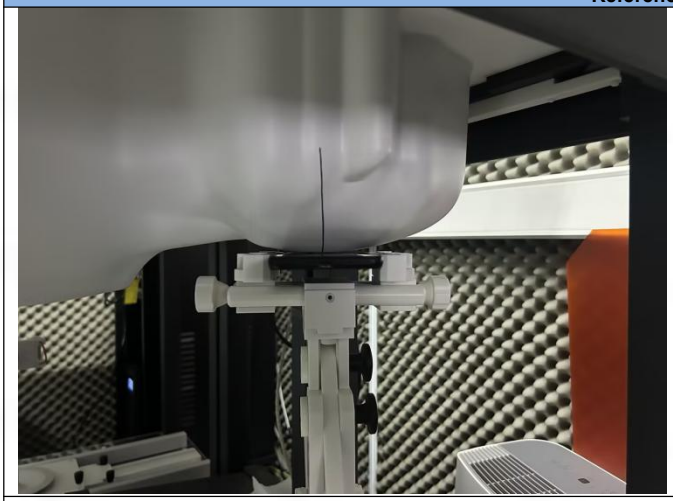
ANNEX E SAR Test Setup Photos

Reference Photo: simulation liquid depth 15cm


Reference Photos	
	
Left Head - Cheek	Left Head - Tilt
	
Right Head - Cheek	Right Head - Tilt

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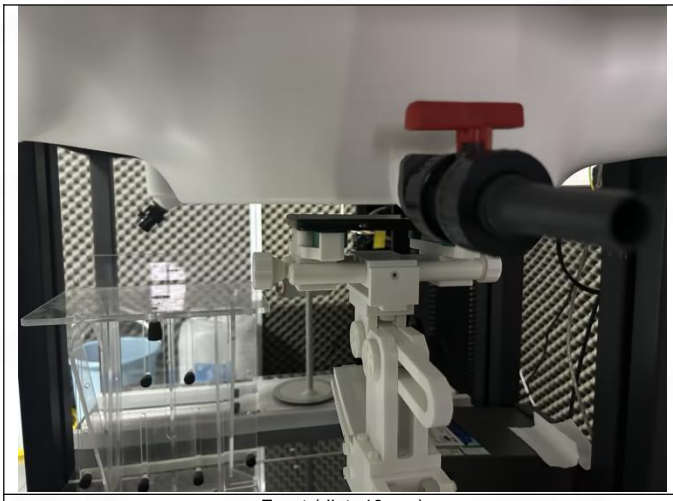
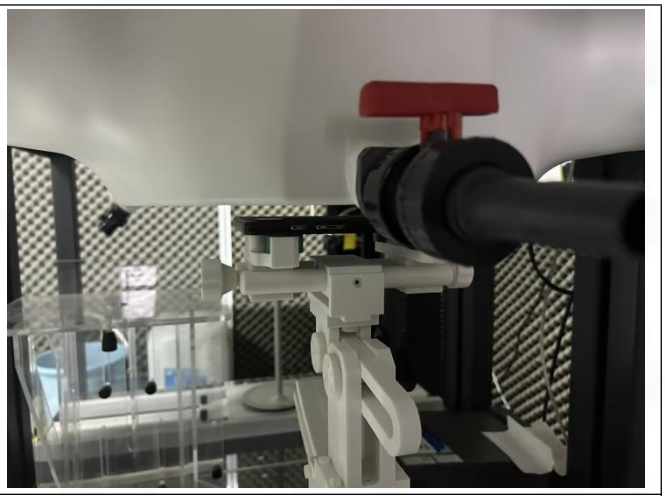


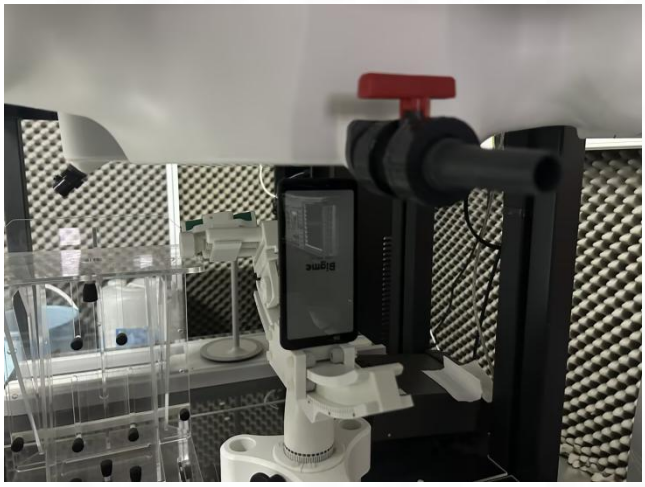
Front (dist. 10mm)



Back (dist. 10mm)

Right (dist. 10mm)

Top (dist. 10mm)



Bottom (dist. 10mm)

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ANNEX F EUT External and Internal Photos

Please refer to RF Report.

ANNEX G Calibration Information

Please refer to the document “Calibration.pdf”.

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